



IS25LP040E

IS25LP020E

IS25LP010E

IS25LP512E

IS25LP025E

IS25WP040E

IS25WP020E

IS25WP010E

IS25WP512E

IS25WP025E

4M/2M/1M/512K/256Kb

**SERIAL FLASH MEMORY WITH 104MHZ MULTI I/O SPI &
QPI INTERFACE**

DATA SHEET

4M/2M/1M/512K/256Kb

SERIAL FLASH MEMORY WITH 104MHZ MULTI I/O SPI & QPI INTERFACE

FEATURES

- **Industry Standard Serial Interface**

- IS25LP040E: 4Mbit/512Kbyte
- IS25WP040E: 4Mbit/512Kbyte
- IS25LP020E: 2Mbit/256Kbyte
- IS25WP020E: 2Mbit/256Kbyte
- IS25LP010E: 1Mbit/128Kbyte
- IS25WP010E: 1Mbit/128Kbyte
- IS25LP512E: 512Kbit/64Kbyte
- IS25WP512E: 512Kbit/64Kbyte
- IS25LP025E: 256Kbit/32Kbyte
- IS25WP025E: 256Kbit/32Kbyte
- 256 bytes per Programmable Page
- Supports standard SPI, Multi-I/O SPI, and QPI
- Supports Serial Flash Discoverable Parameters (SFDP)

- **High Performance Serial Flash (SPI)**

- 50MHz Normal and 104Mhz Fast Read
- 416 MHz equivalent QPI
- Supports SPI Modes 0 and 3
- More than 100,000 Erase/Program Cycles
- More than 20-year Data Retention

- **Flexible & Efficient Memory Architecture**

- Chip Erase with Uniform Sector/Block Erase (4/32/64 Kbyte)
- Program 1 to 256 Bytes per Page
- Program/Erase Suspend & Resume
- Soft RESET & In-Band RESET

- **Efficient Read and Program modes**

- XIP Read Operation; Dual I/O & Quad IO Read with AX mode
- Continuous Read & Wrap Burst Read (8/16/32/64-Byte)
- Program Operation during Erase Suspend Mode

- **Low Power with Wide Temp. Ranges**

- Single Voltage Supply:
 - IS25LP: 2.30V to 3.60V
 - IS25WP: 1.70V to 1.95V
- 6 mA Active Read Current
- 17 μ A Standby Current
- 3 μ A Deep Power Down
- Temp Grades:
 - Extended: -40°C to +105°C
 - Auto Grade (A3): -40°C to +125°C

- **Advanced Security Protection**

- Software and Hardware Write Protection
- Power Supply Lock Protect
- 4x256-Byte Dedicated Security Area with OTP User-lockable Bits
- 128 bit Unique ID for Each Device (Call Factory)

- **Industry Standard Pin-out & Packages⁽¹⁾**

- B = 8-pin SOIC 208mil (Call Factory)
- N = 8-pin SOIC 150mil
- D = 8-pin TSSOP (Call Factory)
- V = 8-pin VVSOP 150mil (Call Factory)
- K = 8-contact WSON 6x5mm (Call Factory)
- Y = 8-contact USON 2x3mm
- KGD (Call Factory)

Note:

1. Call Factory for other package



GENERAL DESCRIPTION

The IS25LP/WP040E/020E/010E/512E/025E and Serial Flash memory offers a versatile storage solution with high flexibility and performance in a simplified pin count package. ISSI's "Industry Standard Serial Interface" Flash is for systems that require limited space, a low pin count, and low power consumption. The device is accessed through a 4-wire SPI Interface consisting of a Serial Data Input (SI), Serial Data Output (SO), Serial Clock (SCK), and Chip Enable (CE#) pins, which can also be configured to serve as multi-I/O (see pin descriptions).

The device supports Dual and Quad I/O as well as standard, Dual Output, and Quad Output SPI. Clock frequencies of up to 104MHz allow for equivalent clock rates of up to 416MHz (104MHz x 4) which equates to 52Mbytes/s of data throughput. These transfer rates can outperform 16-bit Parallel Flash memories allowing for efficient memory access to support XIP (execute in place) operation.

The memory array is organized into programmable pages of 256-bytes. This family supports page program mode where 1 to 256 bytes of data are programmed in a single command. QPI (Quad Peripheral Interface) supports 2-cycle instruction further reducing instruction times. Pages can be erased in groups of 4Kbyte sectors, 32Kbyte blocks, 64Kbyte blocks, and/or the entire chip. The uniform sector and block architecture allows for a high degree of flexibility so that the device can be utilized for a broad variety of applications requiring solid data retention.

GLOSSARY

Standard SPI

In this operation, a 4-wire SPI Interface is utilized, consisting of Serial Data Input (SI), Serial Data Output (SO), Serial Clock (SCK), and Chip Enable (CE#) pins. Instructions are sent via the SI pin to encode instructions, addresses, or input data to the device on the rising edge of SCK. The SO pin is used to read data or to check the status of the device. This device supports SPI bus operation modes (0, 0) and (1, 1).

Multi I/O SPI

Multi-I/O operation utilizes an enhanced SPI protocol to allow the device to function with Dual Output, Dual Input and Output, Quad Output, and Quad Input and Output capability. Executing these instructions through SPI mode will achieve double or quadruple the transfer bandwidth for READ and PROGRAM operations.

QPI

The device supports Quad Peripheral Interface (QPI) operations only when the device is switched from Standard/Dual/Quad SPI mode to QPI mode using the enter QPI (35h) instruction. The typical SPI protocol requires that the byte-long instruction code being shifted into the device only via SI pin in eight serial clocks. The QPI mode utilizes all four I/O pins to input the instruction code thus requiring only two serial clocks. This can significantly reduce the SPI instruction overhead and improve system performance. Only QPI mode or SPI/Dual/Quad mode can be active at any given time. Enter QPI (35h) and Exit QPI (F5h) instructions are used to switch between these two modes, regardless of the non-volatile Quad Enable (QE) bit status in the Status Register. Power Reset or Software Reset will return the device into the standard SPI mode. SI and SO pins become bidirectional I/O0 and I/O1, and WP# and HOLD# pins become I/O2 and I/O3 respectively during QPI mode.



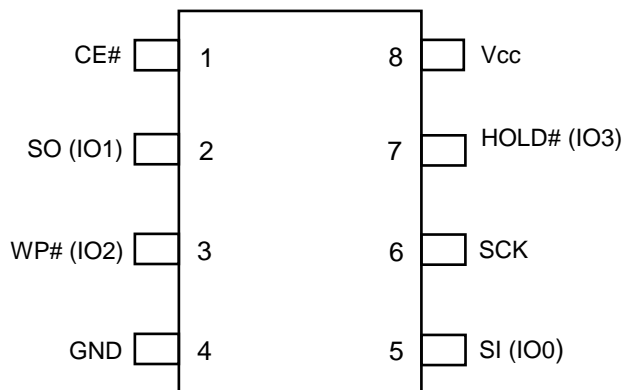
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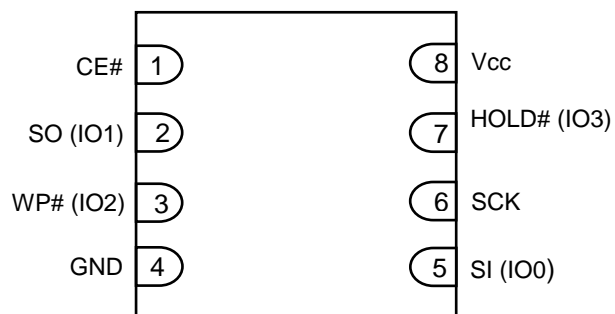


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1. PIN CONFIGURATION



8-pin SOIC 208mil (Package: B)
 8-pin SOIC 150mil (Package: N)
 8-pin TSSOP (Package: D)
 8-pin VVSOP 150mil (Package: V)

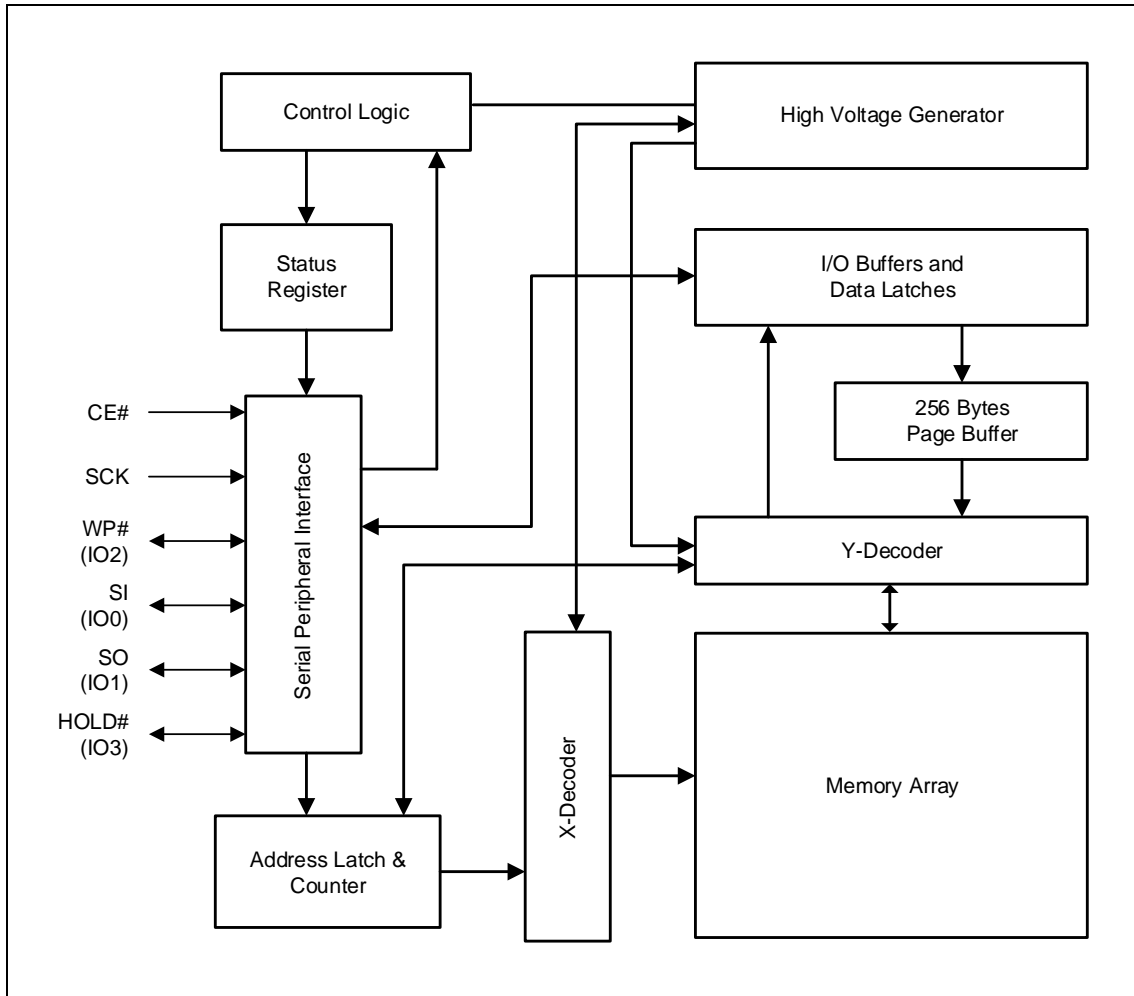


8-pin USON 2x3mm (Package: Y)
 8-pin WSON 6x5mm (Package: K)

2. PIN DESCRIPTIONS

SYMBOL	TYPE	DESCRIPTION
CE#	INPUT	<p>Chip Enable: The Chip Enable (CE#) pin enables and disables the devices operation. When CE# is high the device is deselected and output pins are in a high impedance state. When deselected the devices non-critical internal circuitry power down to allow minimal levels of power consumption while in a standby state.</p> <p>When CE# is pulled low the device will be selected and brought out of standby mode. The device is considered active and instructions can be written to, data read, and written to the device. After power-up, CE# must transition from high to low before a new instruction will be accepted.</p> <p>Keeping CE# in a high state deselects the device and switches it into its low power state. Data will not be accepted when CE# is high.</p>
SI (IO0), SO (IO1)	INPUT/OUTPUT	<p>Serial Data Input, Serial Output, and IOs (SI, SO, IO0, and IO1):</p> <p>This device supports standard SPI, Dual SPI, and Quad SPI operation. Standard SPI instructions use the unidirectional SI (Serial Input) pin to write instructions, addresses, or data to the device on the rising edge of the Serial Clock (SCK). Standard SPI also uses the unidirectional SO (Serial Output) to read data or status from the device on the falling edge of the serial clock (SCK).</p> <p>In Dual and Quad SPI mode, SI and SO become bidirectional IO pins to write instructions, addresses or data to the device on the rising edge of the Serial Clock (SCK) and read data or status from the device on the falling edge of SCK. Quad SPI instructions use the WP# and HOLD# pins as IO2 and IO3 respectively.</p>
WP# (IO2)	INPUT/OUTPUT	<p>Write Protect/Serial Data IO (IO2): The WP# pin protects the Status Register from being written in conjunction with the SRWD bit. When the SRWD is set to "1" and the WP# is pulled low, the Status Register bits (SRWD, QE, BP3, BP2, BP1, BP0) are write-protected and vice-versa for WP# high. When the SRWD is set to "0", the Status Register is not write-protected regardless of WP# state.</p> <p>When the QE bit is set to "1", the WP# pin (Write Protect) function is not available since this pin is used for IO2.</p>
HOLD# (IO3)	INPUT/OUTPUT	<p>Hold/Serial Data IO (IO3): Pauses serial communication by the master device without resetting the serial sequence. When the QE bit of Status Register is set to "1", HOLD# pin is not available since it becomes IO3.</p> <p>The HOLD# pin allows the device to be paused while it is selected. The HOLD# pin is active low. When HOLD# is in a low state, and CE# is low, the SO pin will be at high impedance.</p> <p>Device operation can resume when HOLD# pin is brought to a high state. When the QE bit of Status Register is set for Quad I/O, the HOLD# pin function is not available and becomes IO3 for Multi-I/O SPI mode.</p>
SCK	INPUT	Serial Data Clock: Synchronized Clock for input and output timing operations.
Vcc	POWER	Power: Device Core Power Supply
GND	GROUND	Ground: Connect to ground when referenced to Vcc
NC	Unused	NC: Pins labeled "NC" stand for "No Connect". Not internally connected.

3. BLOCK DIAGRAM



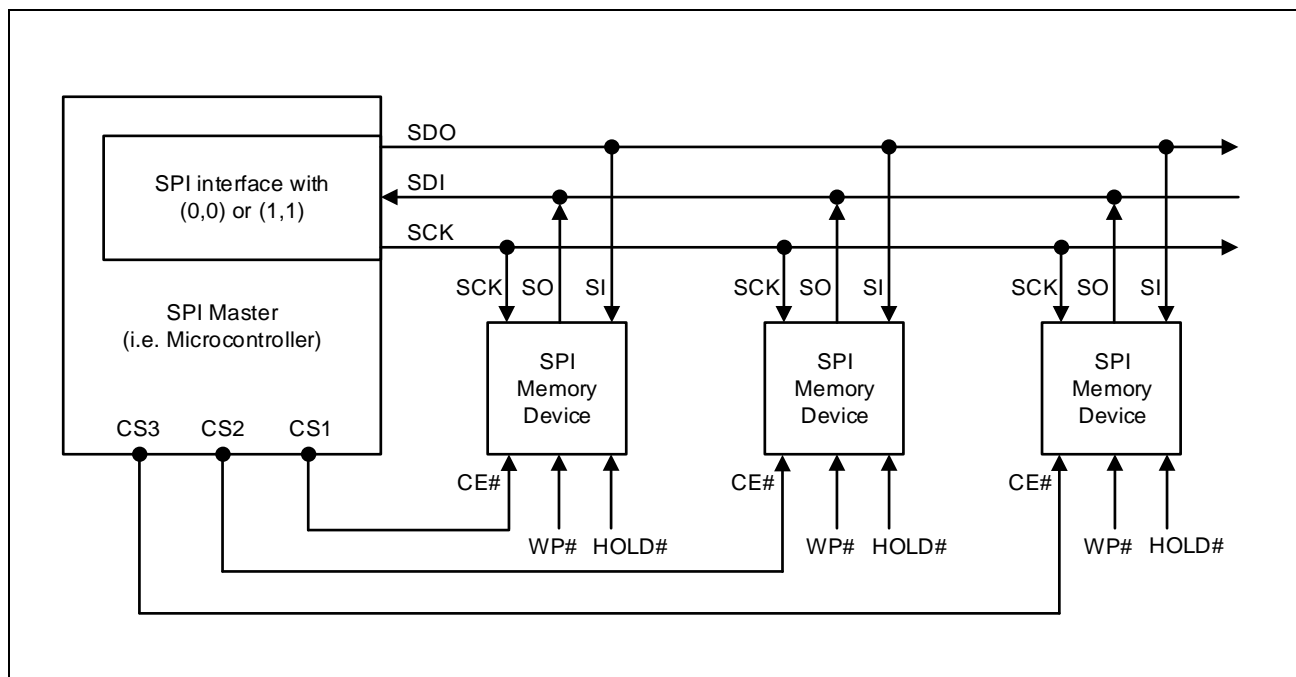
4. SPI MODES DESCRIPTION

Multiple IS25LP/WP040E/020E/010E/512E/025E devices can be connected on the SPI serial bus and controlled by a SPI Master, i.e. microcontroller, as shown in Figure 4.1. The devices support either of two SPI modes:

- Mode 0 (0, 0)
- Mode 3 (1, 1)

The difference between these two modes is the clock polarity. When the SPI master is in stand-by mode, the serial clock remains at “0” (SCK = 0) for Mode 0 and the clock remains at “1” (SCK = 1) for Mode 3. Please refer to Figure 4.2 and Figure 4.3 for SPI and QPI mode. In both modes, the input data is latched on the rising edge of Serial Clock (SCK), and the output data is available from the falling edge of SCK.

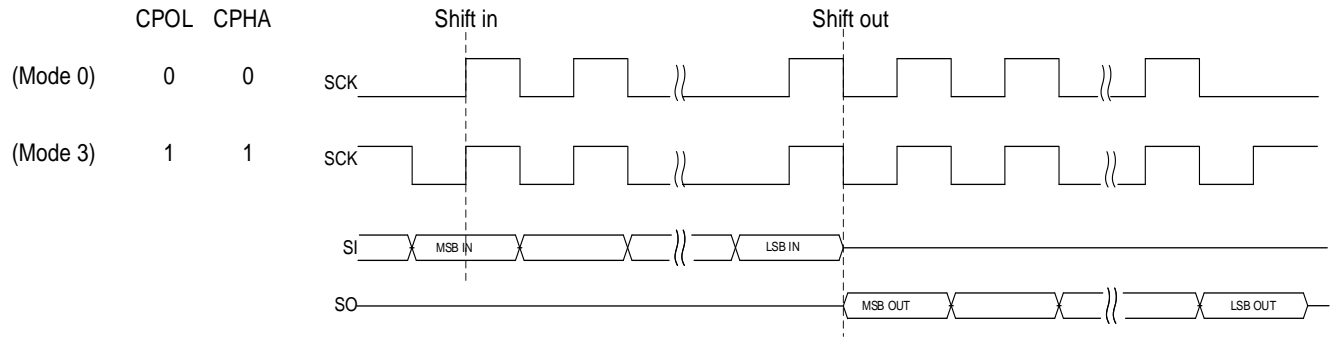
Figure 4.1 Connection Diagram among SPI Master and SPI Slaves (Memory Devices)



Notes:

1. The Write Protect (WP#) and Hold (HOLD#) signals should be driven high or low as necessary.
2. SI and SO pins become bidirectional IO0 and IO1, and WP# and HOLD# pins become IO2 and IO3 respectively during Multi-IO mode.

Figure 4.2 SPI Mode Support





5. SYSTEM CONFIGURATION

The memory array of IS25LP/WP512E/025E is divided into uniform 4Kbyte sectors or uniform 32Kbyte blocks (a block consists of eight adjacent sectors). The memory array of IS25LP/WP040E/020E/010E is divided into uniform 4Kbyte sectors or uniform 32/64Kbyte blocks (a block consists of eight/sixteen adjacent sectors respectively).

Note: Optional 1Mb device (Option C) is also divided into uniform 4Kbyte sectors or uniform 32Kbyte blocks.

Table 5.1 illustrates the memory map of the device. The Status Register controls how the memory is protected.

5.1 BLOCK/SECTOR ADDRESSES

Table 5.1 Block/Sector Addresses of IS25LP/WP0512E/025E

Memory Density	Block No. (32Kbyte)	Sector No.	Sector Size (Kbyte)	Address Range
256Kb	Block 0	Sector 0	4	000000h - 000FFFh
		Sector 1	4	001000h - 001FFFh
		:	:	:
		Sector 7	4	007000h - 007FFFh
	Block 1	Sector 8	4	008000h - 008FFFh
		Sector 9	4	009000h - 009FFFh
		:	:	:
		Sector 15	4	00F000h - 00FFFFh

Table 5.2 Block/Sector Addresses of IS25LP/WP040E/020E/010E

Memory Density		Block No. (64Kbyte)	Block No. (32Kbyte)	Sector No.	Sector Size (Kbyte)	Address Range
1Mb ⁽¹⁾	2Mb	Block 0	Block 0	Sector 0	4	000000h - 000FFFh
			:	:	:	:
			Block 1	Sector 15	4	00F000h - 00FFFFh
			Block 1	Sector 16	4	010000h - 010FFFh
				:	:	:
			Block 3	Sector 31	4	01F000h - 01FFFFh
			Block 2	Sector 32	4	020000h - 020FFFh
				:	:	:
			Block 5	Sector 47	4	02F000h - 02FFFFh
			Block 3	Sector 48	4	030000h - 030FFFh
		:		:	:	
		Block 7	Sector 63	4	03F000h - 03FFFFh	
	4Mb	Block 4	Sector 64	4	040000h - 040FFFh	
				:	:	:
			Block 9	Sector 79	4	04F000h - 04FFFFh
			Block 5	Sector 80	4	050000h - 050FFFh
				:	:	:
			Block 11	Sector 95	4	05F000h - 05FFFFh
			Block 6	Sector 96	4	060000h - 060FFFh
				:	:	:
			Block 13	Sector 111	4	06F000h - 06FFFFh
			Block 7	Sector 112	4	070000h - 070FFFh
		:		:	:	
		Block 15	Sector 127	4	07F000h - 07FFFFh	

Note: Optional 1Mb device (Option C) is divided into uniform 4Kbyte sectors or uniform 32Kbyte blocks like 512Kb. Then both D8h and 52h commands are for 32KB Block Erase operation .

5.2 SERIAL FLASH DISCOVERABLE PARAMETERS

The Serial Flash Discoverable Parameters (SFDP) standard defines the structure of the SFDP database within the memory device. SFDP is the standard of JEDEC JESD216.

The JEDEC-defined header with Parameter ID FF00h and related Basic Parameter Table is mandatory. Additional parameter headers and tables are optional.

Table 5.2 Signature and Parameter Identification Data Values

Description		Address (Byte)	Address (Bit)	Data
SFDP Signature		00h	7:0	53h
		01h	15:8	46h
		02h	23:16	44h
		03h	31:24	50h
SFDP Revision	Minor	04h	7:0	06h
	Major	05h	15:8	01h
Number of Parameter Headers (NPH)		06h	23:16	00h
Unused		07h	31:24	FFh
Parameter ID LSB		08h	7:0	00h
Parameter Minor Revision		09h	15:8	06h
Parameter Major Revision		0Ah	23:16	01h
Parameter Table Length (in DWPRDs)		0Bh	31:24	10h
Basic Flash Parameter Table Pointer (PTP)		0Ch	7:0	30h
		0Dh	15:8	00h
		0Eh	23:16	00h
Parameter ID MSB		0Fh	31:24	FFh



Table 5.3 JEDEC Basic Flash Parameter Table

Description	Address (Byte)	Address (Bit)	Data	
Minimum Sector Erase Sizes	30h	1:0	01b	
Write Granularity		2	1b	
Volatile Status Register Block Protect bits		3	1b	
Write Enable Instruction Select for writing to Volatile Status Register		4	0b	
Unused		7:5	111b	
4KB Erase Instruction	31h	15:8	20h	
Supports (1-1-2) Fast Read	32h	16	1b	
Address Bytes		18:17	00b	
Supports Double Transfer Rate (DTR) Clocking		19	0b	
Supports (1-2-2) Fast Read		20	1b	
Supports (1-4-4) Fast Read		21	1b	
Supports (1-1-4) Fast Read		22	1b	
Unused		23	1b	
Reserved	33h	31:24	FFh	
Flash memory Density (bits)	34h	7:0	FFh	
	35h	15:8	FFh	
Flash memory Density (bits)	4Mb	36h	23:16	3Fh
	2Mb	36h	23:16	1Fh
	1Mb	36h	23:16	0Fh
	512Kb	36h	23:16	07h
	256Kb	36h	23:16	03h
Flash memory Density (bits)	37h	31:24	00h	
1-4-4 Fast Read Wait Cycle Count	38h	4:0	00100b	
1-4-4 Fast Read Mode bit Cycle Count		7:5	010b	
1-4-4 Fast Read Instruction	39h	15:8	EBh	
1-1-4 Fast Read Wait Cycle Count	3Ah	20:16	01000b	
1-1-4 Fast Read Mode bit Cycle Count		23:21	000b	
1-1-4 Fast Read Instruction	3Bh	31:24	6Bh	
1-1-2 Fast Read Wait Cycle Count	3Ch	4:0	01000b	
1-1-2 Fast Read Mode bit Cycle Count		7:5	000b	
1-1-2 Fast Read Instruction	3Dh	15:8	3Bh	
1-2-2 Fast Read Wait Cycle Count	3Eh	20:16	00000b	
1-2-2 Fast Read Mode bit Cycle Count		23:21	100b	
1-2-2 Fast Read Instruction	3Fh	31:24	BBh	



Table 5.3 JEDEC Basic Flash Parameter Table (Continued)

Description	Address (Byte)	Address (Bit)	Data	
Supports (2-2-2) Fast Read	40h	0	0b	
Reserved		3:1	111b	
Supports (4-4-4) Fast Read		4	1b	
Reserved		7:5	111b	
Reserved		43:41h	31:8	FFFFFFh
Reserved	45:44h	15:0	FFFFh	
2-2-2 Fast Read Wait Cycle Count	46h	20:16	00000b	
2-2-2 Fast Read Mode bit Cycle Count		23:21	000b	
2-2-2 Fast Read Instruction	47h	31:24	FFh	
Reserved	49:48h	15:0	FFFFh	
4-4-4 Fast Read Wait Cycle Count	4Ah	20:16	00100b	
4-4-4 Fast Read Mode bit Cycle Count		23:21	010b	
4-4-4 Fast Read Instruction	4Bh	31:24	EBh	
Erase Type 1 Size (4KB)	4Ch	7:0	0Ch	
Erase Type 1 Instruction	4Dh	15:8	20h	
Erase Type 2 Size (32KB)	4Eh	23:16	0Fh	
Erase Type 2 Instruction	4Fh	31:24	52h ⁽¹⁾	
Erase Type 3 Size (64KB)	256Kb/512Kb	50h	7:0	00h
	1Mb/2Mb/4Mb		10h ⁽²⁾	
Erase Type 3 Instruction	256Kb/512Kb	51h	15:8	FFh
	1Mb/2Mb/4Mb		D8h ⁽³⁾	
Erase Type 4 Size (256KB)	52h	23:16	00h	
Erase Type 4 Instruction	53h	31:24	FFh	
Multiplier from typical erase time to maximum erase time	57:54h	3:0	0010b	
Sector Type 1 ERASE time (typ)		8:4	00100b	
		10:9	01b	
Sector Type 2 ERASE time (typ)		15:11	00100b	
		17:16	01b	
Sector Type 3 ERASE time (typ)		256Kb/512Kb	22:18	00000b
		1Mb/2Mb/4Mb	24:23	00b
			22:18	01100b ⁽⁴⁾
			24:23	01b ⁽⁴⁾
Sector Type 4 ERASE time (typ)		29:25	00000b	
	31:30	00b		

Notes:

1. D8h can also be used for 32KB block erase in 256Kb/512Kb and optional 1Mb (Option C) device.
2. 00h in optional 1Mb (Option C) device. 3. FFh in optional 1Mb (Option C) device
4. [22:18] = 00000b and [24:23] = 00b in optional 1Mb (Option C) device



4. Table 5.3 JEDEC Basic Flash Parameter Table (Continued)

Description	Address (Byte)	Address (Bit)	Data	
Multiplier from typical time to maximum time for page or byte PROGRAM	58h	3:0	0001b	
Page size		7:4	1000b	
Page Program Typical time	5Ah:59h	12:8	00111b	
Byte Program Typical time, first byte		13	1b	
Byte Program Typical time, additional byte		17:14	0111b	
		18	0b	
Chip Erase, Typical time		22:19	0000b	
		23	0b	
Units	5Bh	28:24	4Mb	00101b
			2Mb	00010b
			1Mb	00001b
			512Kb	01111b
			256Kb	01000b
Reserved	5Ch	30:29	4Mb/2Mb/1Mb	01b
			512Kb/256Kb	00b
Prohibited Operations During Program Suspend	5Ch	31	1b	
Prohibited Operations During Erase Suspend		3:0	1100b	
Reserved	5Eh:5Dh	7:4	1110b	
Program Resume to Suspend Interval		8	1b	
Suspend in-progress program max latency		12:9	0110b	
		17:13	01100b	
Erase Resume to Suspend Interval		19:18	10b	
		23:20	0110b	
Suspend in-progress erase max latency	5Fh	28:24	01100b	
Suspend /Resume supported		30:29	10b	
Program Resume Instruction		31	0b	
Program Suspend Instruction	60h	7:0	7Ah	
Resume Instruction	61h	15:8	75h	
Suspend Instruction	62h	23:16	7Ah	
Reserved	63h	31:24	75h	
Status Register Polling Device Busy		64h	1:0	11b
		7:2	111101b	

Table 5.3 JEDEC Basic Flash Parameter Table (Continued)

Description	Address (Byte)	Address (Bit)	Data	
Exit Deep Power-down to next operation delay	3V	67h:65h	00010b	
	1.8V		00100b	
Exit Deep Power-down to next operation delay Units			12:8	01b
Exit Deep Power-down Instruction			14:13	ABh
Enter Deep Power-down Instruction			22:15	B9h
Deep Power-down Supported			30:23	0b
4-4-4 mode disable sequences (QPIDI)	69h:68h	31	0b	
4-4-4 mode enable sequences (QPIEN)		3:0	1010b	
0-4-4 Mode Supported		8:4	00100b	
0-4-4 Mode Exit Method		9	1b	
0-4-4 Mode Entry Method:	6Ah	15:10	110000b	
Quad Enable Requirements (QER)		19:16	1100b	
Hold or RESET Disable		22:20	010b	
Reserved	6Bh	23	0b	
Reserved	6Ch	31:24	FFh	
Volatile or Non-Volatile Register and Write Enable (WREN) Instruction for Status Register 1		6:0	1101000b	
Reserved		7	1b	
Soft Reset and Rescue Sequence Support	6Eh:6Dh	13:8	110000b	
Exit 4-Byte Addressing		23:14	110000000 0b	
Enter 4-Byte Addressing	6Fh	31:24	10000000b	

6. REGISTERS

The device has four sets of Registers: Status and Function Register.

6.1 STATUS REGISTER

Status Register Format and Status Register Bit Definitions are described in Table 6.1 & Table 6.2.

Table 6.1 Status Register Format

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	SRWD	QE	BP3	BP2	BP1	BP0	WEL	WIP
Default	0	0	0	0	0	0	0	0

Table 6.2 Status Register Bit Definition

Bit	Name	Definition	Read-Write	Type
Bit 0	WIP	Write In Progress Bit: "0" indicates the device is ready(default) "1" indicates a write cycle is in progress and the device is busy	R	Volatile
Bit 1	WEL	Write Enable Latch: "0" indicates the device is not write enabled (default) "1" indicates the device is write enabled	R/W ¹	Volatile
Bit 2	BP0	Block Protection Bit: "0" indicates the specific blocks are not write-protected (default) "1" indicates the specific blocks are write-protected	R/W	Non-Volatile
Bit 3	BP1			
Bit 4	BP2			
Bit 5	BP3			
Bit 6	QE	Quad Enable bit: "0" indicates the Quad output function disable (default) "1" indicates the Quad output function enable	R/W	Non-Volatile
Bit 7	SRWD	Status Register Write Disable: (See Table 7.1 for details) "0" indicates the Status Register is not write-protected (default) "1" indicates the Status Register is write-protected	R/W	Non-Volatile

Note1: WEL bit can be written by WREN and WRDI commands, but cannot by WRSR command.

The BP0, BP1, BP2, BP3, QE, and SRWD are non-volatile memory cells that can be written by a Write Status Register (WRSR) instruction. The default value of the BP0, BP1, BP2, BP3, QE, and SRWD bits were set to "0" at factory. The Status Register can be read by the Read Status Register (RDSR).

The function of Status Register bits are described as follows:

WIP bit: Write In Progress (WIP) is read-only, and can be used to detect the progress or completion of a Program, Erase, or Write/Set Non-Volatile/OTP Register operation. WIP is set to "1" (busy state) when the device is executing the operation. When an operation has completed, WIP is cleared to "0" (ready state) whether the operation is successful or not and the device is ready for further instructions.

WEL bit: Write Enable Latch (WEL) indicates the status of the internal write enable latch. When WEL is "0", the internal write enable latch is disabled and the write operations described in Table 6.3 are inhibited. When WEL is "1", the Write operations are allowed. WEL bit is set by a Write Enable (WREN) instruction. Each Write Non-Volatile Register, Program and Erase instruction must be preceded by a WREN instruction. The volatile register related commands such as the Set Volatile Read Register and the Set Volatile Extended Read Register don't require to set WEL to "1". WEL can be reset by a Write Disable (WRDI) instruction. It will automatically reset after the completion of any Write operation.

Table 6.3 Instructions requiring WREN instruction ahead

Instructions must be preceded by the WREN instruction		
Name	Hex Code	Operation
PP	02h	Serial Input Page Program
PPQ	32h/38h	Quad Input Page Program
SER	D7h/20h	Sector Erase 4KB
BER32 (32KB)	52h	Block Erase 32KB
BER64 (64KB)	D8h	Block Erase 64KB
BER32 (32KB)	52h/D8h ⁽²⁾	Block Erase 32KB
BER64 (64KB)	NA	Block Erase 64KB
CER	C7h/60h	Chip Erase
WRSR	01h	Write Non-Volatile Status Register Status Register ⁽¹⁾
WRFR	42h	Write Function Register
IRER	64h	Erase Information Row
IRP	62h	Program Information Row

Note:

- Optional 1Mb device (Option C) supports only 32KB Block Erase operation with D8h/ 52h command.

BP3, BP2, BP1, BP0 bits: The Block Protection (BP3, BP2, BP1 and BP0) bits are used to define the portion of the memory area to be protected. Refer to Table 6.4 for the Block Write Protection (BP) bit settings. When a defined combination of BP3, BP2, BP1 and BP0 bits are set, the corresponding memory area is protected. Any program or erase operation to that area will be inhibited.

SRWD bit: The Status Register Write Disable (SRWD) bit operates in conjunction with the Write Protection (WP#) signal to provide a Hardware Protection Mode. When the SRWD is set to “0”, the Status Register is not write-protected. When the SRWD is set to “1” and the WP# is pulled low (V_{IL}), the bits of Status Register (SRWD, QE, BP3, BP2, BP1, BP0) become read-only, and a WRSR instruction will be ignored. If the SRWD is set to “1” and WP# is pulled high (V_{IH}), the Status Register can be changed by a WRSR instruction.

QE bit: The Quad Enable (QE) allows quad operation. When the QE bit is set to “0”, the pin WP# and HOLD# are enabled. When the QE bit is set to “1”, the IO2 and IO3 pins are enabled.

WARNING: The QE bit must be set to 0 if WP# or HOLD# pin is tied directly to the power supply.



Table 6.4 Block (64Kbyte) assignment by Block Write Protect (BP) Bits

Status Register Bits				BP Table, Protected Memory Area			
BP3	BP2	BP1	BP0	4Mb	2Mb	1Mb	512Kb and 256Kb
0	0	0	0	0 (None)	0 (None)	0 (None)	0 (None)
0	0	0	1	1(1 block : 7th)	1(1 block : 3rd)	1(1 block : 1st)	1~15 (All Blocks)
0	0	1	0	2(2 blocks : 6th – 7th)	2(2 blocks : 2nd – 3rd)	2~8 (2 blocks: All Blocks)	
0	0	1	1	3(4 blocks : 4th – 7th)	3(3 blocks : 1st – 3rd)		
0	1	0	0	4(6 blocks : 2nd – 7th)	4~8 (4 blocks: All Blocks)		
0	1	0	1	5(7 blocks : 1st – 7th)			
0	1	1	0	6~8 (8 blocks: All Blocks)			
0	1	1	1				
1	0	0	0	9(1 block : 0th)	9(1 block : 0th)	9(1 block : 0th)	
1	0	0	1				
1	0	1	0	10(2 blocks : 0th – 1st)	10(2 blocks : 0th – 1st)	10~15 (2 blocks : All Blocks)	
1	0	1	1	11(4 blocks : 0th – 3rd)	11(3 blocks : 0th – 2nd)		
1	1	0	0	12(6 blocks : 0th – 5th)	12~15 (4 blocks : All Blocks)		
1	1	0	1	13(7 blocks : 0th– 6th)			
1	1	1	0	14~15 (8 blocks : All Blocks)			
1	1	1	1				

Table 6.5 Optional Block (64Kbyte) assignment by Block Write Protect (BP) Bits ⁽¹⁾

Status Register Bits				Protected Memory Area				
BP3	BP2	BP1	BP0	4Mb	2Mb	1Mb	512Kb and 256Kb	
0	0	0	0	None	None	None	None	
0	0	0	1	1 block : 7	1 block : 3	1 block : 1	All Blocks	
0	0	1	0	2 blocks : 6 - 7	2 blocks : 2 - 3	All Blocks		
0	0	1	1	4 blocks : 4 - 7	3 blocks : 1 - 3	2 blocks : 0 - 1		
0	1	0	0	6 blocks : 2 - 7	All Blocks			
0	1	0	1	7 blocks : 1 - 7				
0	1	1	0	All Blocks				
0	1	1	1					
1	0	0	0					
1	0	0	1	7 blocks 0 - 6	All Blocks			2 blocks : 0 - 1
1	0	1	0					
1	0	1	1	6 blocks 0 - 5	3 blocks : 0 - 2			
1	1	0	0	4 blocks 0 - 3				
1	1	0	1	2 blocks : 0 - 1		2 blocks : 0 - 1		
1	1	1	0	1 block : 0	1 block : 0	1 block : 0		
1	1	1	1	None	None	None		None

Note:

1. Call factory for optional BP Table.

Table 6.6 Optional Block (32Kbyte) assignment by Block Write Protect (BP) Bits for 1Mb Option C

Status Register Bits				BP Table, Protected Memory Area
BP3	BP2	BP1	BP0	1Mb
0	0	0	0	0 (None)
0	0	0	1	1(1 block : 3rd)
0	0	1	0	2(2 blocks : 2nd – 3rd)
0	0	1	1	3~15 (4 blocks: All Blocks)
0	1	0	0	
0	1	0	1	
0	1	1	0	
0	1	1	1	
1	0	0	0	
1	0	0	1	
1	0	1	0	
1	0	1	1	
1	1	0	0	
1	1	0	1	
1	1	1	0	
1	1	1	1	

6.2 FUNCTION REGISTER

Function Register Format and Bit definition are described in Table 6.5 and Table 6.6.

Table 6.7 Function Register Format

	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0
	IRL3	IRL2	IRL1	IRL0	ESUS	PSUS	Reserved	Reserved
Default	0	0	0	0	0	0	0	0

Table 6.8 Function Register Bit Definition

Bit	Name	Definition	Read /Write	Type
Bit 0	Reserved	Reserved	R	Reserved
Bit 1	Reserved	Reserved	R	Reserved
Bit 2	PSUS	Program suspend bit: "0" indicates program is not suspend "1" indicates program is suspend	R	Volatile
Bit 3	ESUS	Erase suspend bit: "0" indicates Erase is not suspend "1" indicates Erase is suspend	R	Volatile
Bit 4	IR Lock 0	Lock the Information Row 0: "0" indicates the Information Row can be programmed "1" indicates the Information Row cannot be programmed	R/W	OTP
Bit 5	IR Lock 1	Lock the Information Row 1: "0" indicates the Information Row can be programmed "1" indicates the Information Row cannot be programmed	R/W	OTP
Bit 6	IR Lock 2	Lock the Information Row 2: "0" indicates the Information Row can be programmed "1" indicates the Information Row cannot be programmed	R/W	OTP
Bit 7	IR Lock 3	Lock the Information Row 3: "0" indicates the Information Row can be programmed "1" indicates the Information Row cannot be programmed	R/W	OTP

Note: Once OTP bits of Function Register are written to "1", it cannot be modified to "0" any more.

PSUS bit: The Program Suspend Status bit indicates when a Program operation has been suspended. The PSUS changes to "1" after a suspend command is issued during the program operation. Once the suspended Program resumes, the PSUS bit is reset to "0".

ESUS bit: The Erase Suspend Status bit indicates when an Erase operation has been suspended. The ESUS bit is "1" after a suspend command is issued during an Erase operation. Once the suspended Erase resumes, the ESUS bit is reset to "0".

IR Lock bit 0 ~ 3: The default is "0" so that the Information Row can be programmed. If the bit set to "1", the Information Row can't be programmed. Once it set to "1", it cannot be changed back to "0" since IR Lock bits are OTP.

7. PROTECTION MODE

The device supports hardware and software write-protection mechanisms.

7.1 HARDWARE WRITE PROTECTION

The Write Protection (WP#) pin provides a hardware write protection method for BP3, BP2, BP1, BP0, SRWD, and QE in the Status Register. Refer to the section 6.1 STATUS REGISTER.

Write inhibit voltage (V_{WI}) is specified in the section 9.8 POWER-UP AND POWER-DOWN. All write sequence will be ignored when V_{CC} drops to V_{WI} .

Table 7.1 Hardware Write Protection on Status Register

SRWD	WP#	Status Register
0	Low	Writable
1	Low	Protected
0	High	Writable
1	High	Writable

Note: Before the execution of any program, erase or write Status Register instruction, the Write Enable Latch (WEL) bit must be enabled by executing a Write Enable (WREN) instruction. If the WEL bit is not enabled, the program, erase or write register instruction will be ignored.

7.2 SOFTWARE WRITE PROTECTION

The device also provides a software write protection feature. The Block Protection (BP3, BP2, BP1, BP0) bits allow part or the whole memory area to be write-protected.

8. DEVICE OPERATION

The device utilizes an 8-bit instruction register. Refer to Table 8.1. Instruction Set for details on instructions and instruction codes. All instructions, addresses, and data are shifted in with the most significant bit (MSB) first on Serial Data Input (SI) or Serial Data IOs (IO0, IO1, IO2, IO3). The input data on SI or IOs is latched on the rising edge of Serial Clock (SCK) after Chip Enable (CE#) is driven low (V_{IL}). Every instruction sequence starts with a one-byte instruction code and is followed by address bytes, data bytes, or both address bytes and data bytes, depending on the type of instruction. CE# must be driven high (V_{IH}) after the last bit of the instruction sequence has been shifted in to end the operation.

Table 8.1 Instruction Set⁽¹⁾

Instruction Name	Operation	Mode	Byte0	Byte1	Byte2	Byte3	Byte4	Byte5	Byte6	Byte7	Byte8
NORD	Normal Read Mode	SPI	03h	A <23:16>	A <15:8>	A <7:0>	Data out				
FRD	Fast Read Mode	SPI	0Bh	A <23:16>	A <15:8>	A <7:0>	Dummy	Data out			
		QPI	0Bh	A <23:16>	A <15:8>	A <7:0>	Dummy	Dummy	Dummy	Data out	
FRDIO	Fast Read Dual I/O	SPI	BBh	A <23:16> Dual	A <15:8> Dual	A <7:0>	Dummy (AXh ⁽²⁾)	Dual Data out			
FRDO	Fast Read Dual Output	SPI	3Bh	A <23:16>	A <15:8>	A <7:0>	Dummy	Dummy	Dual Data out		
FRQO	Fast Read Quad Output	SPI	6Bh	A <23:16>	A <15:8>	A <7:0>	Dummy	Quad Data out			
FRQIO	Fast Read Quad I/O	SPI QPI	EBh	A <23:16> Quad	A <15:8> Quad	A <7:0> Quad	Dummy (AXh ⁽²⁾)	Dummy	Dummy	Quad Data out	
PP	Input Page Program	SPI QPI	02h	A <23:16>	A <15:8>	A <7:0>					PD (256byte)
PPQ	Quad Input Page Program	SPI	32h 38h	A <23:16>	A <15:8>	A <7:0>					Quad PD (256byte)
SER	Sector Erase	SPI	D7h	A <23:16>	A <15:8>	A <7:0>					
		QPI	20h								
		SPI QPI	52h ⁽¹⁾	A <23:16>	A <15:8>	A <7:0>					
BER64 (64KB)	Block Erase 64Kbyte	SPI QPI	D8h ⁽¹⁾	A <23:16>	A <15:8>	A <7:0>					
CER	Chip Erase	SPI QPI	C7h 60h								
WREN	Write Enable	SPI QPI	06h								
WRDI	Write Disable	SPI QPI	04h								
RDSR	Read Status Register	SPI QPI	05h	SR							
WRSR	Write Status Register	SPI QPI	01h	WSR Data							

Note: 1. In 256Kb/512Kb, both 52h and D8h command are for 32KB ERASE only.



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Instruction Name	Operation	Mode	Byte0	Byte1	Byte2	Byte3	Byte4	Byte5	Byte6	Byte7	Byte8
RDFR	Read Function Register	SPI QPI	48h	Data out							
WRFR	Write Function Register	SPI QPI	42h	WFR Data							
QPIEN	Enter QPI mode	SPI	35h								
QPIDI	Exit QPI mode	QPI	F5h								
PERSUS	Suspend during program/erase	SPI QPI	75h B0h								
PERRSM	Resume program/erase	SPI QPI	7Ah 30h								
DP	Deep Power Down	SPI QPI	B9h								
RDPD	Release Power Down	SPI QPI	ABh								
RDID	Read ID	SPI QPI	ABh	Dummy	Dummy	Dummy	ID7-ID0				
RDJDID	Read JEDEC ID Command	SPI	9Fh	MF7-MF0	ID15-ID8	ID7-ID0					
		QPI	AFh	MF7-MF0	ID15-ID8	ID7-ID0					
RDMDID	Read Manufacturer & Device ID	SPI QPI	90h	A <23:16> = 00h	A <15:8> = 00h	00h	MF7-MF0	ID7-ID0			
						01h	ID7-ID0	MF7-MF0			
RDUID	Read Unique ID	SPI	4Bh	A ⁽³⁾ <23:16>	A ⁽³⁾ <15:8>	A ⁽³⁾ <7:0>	Dummy	Data out			
		QPI	4Bh	A ⁽³⁾ <23:16>	A ⁽³⁾ <15:8>	A ⁽³⁾ <7:0>	Dummy	Dummy	Dummy	Data out	
RDSFDP	SFDP Read	SPI	5Ah	A <23:16>	A <15:8>	A <7:0>	Dummy	Data out			
		QPI	5Ah	A <23:16> Quad	A <15:8> Quad	A <7:0> Quad	Dummy	Dummy	Dummy	Dummy	Quad Data out
NOP	No Operation	SPI QPI	00h								
RSTEN	Software Reset Enable	SPI QPI	66h								
RST	Software Reset	SPI QPI	99h								
IRER	Erase Information Row	SPI QPI	64h	A <23:16>	A <15:8>	A <7:0>					
IRP	Program Information Row	SPI QPI	62h	A <23:16>	A <15:8>	A <7:0>	PD (256byte)				
IRRD	Read Information Row	SPI	68h	A <23:16>	A <15:8>	A <7:0>	Dummy	Data out			
		QPI	68h	A <23:16> Quad	A <15:8> Quad	A <7:0> Quad	Dummy	Dummy	Dummy	Quad Data out	
STWBR	Set Wrapped Burst Read	SPI QPI	C0h	STWBR Data							

Notes:

1. The number of dummy cycles for read operation is fixed like below.

Operation	Command	Instruction-Address-Data	Dummy Cycles	Comment
Fast Read (SPI mode)	0Bh	1-1-1	8	RDUID, IRRD instructions have same dummy cycles with Fast Read operation.
Fast Read (QPI mode)	0Bh	4-4-4	6	
Fast Read Dual Output	3Bh	1-1-2	8	
Fast Read Dual IO SPI	BBh	1-2-2	4	
Fast Read Quad Output	6Bh	1-1-4	8	
Fast Read Quad IO (SPI mode)	EBh	1-4-4	6	
Fast Read Quad IO (QPI mode)	EBh	4-4-4	6	

2. AXh has to be counted as a part of dummy cycles. X means "don't care".
3. A<23:9> are "don't care" and A<8:4> are always "0".

8.1 NORMAL READ OPERATION (NORD, 03h)

The NORMAL READ (NORD) instruction is used to read memory contents at a maximum frequency of 50MHz.

The NORD instruction code is transmitted via the SI line, followed by three address bytes (A23 - A0) of the first memory location to be read. A total of 24 address bits are shifted in, but only A_{VMSB} (Valid Most Significant Bit) - A₀ are decoded. The remaining bits (A23 - A_{VMSB+1}) are ignored. The first byte addressed can be at any memory location. Upon completion, any data on the SI will be ignored. Refer to Table 8.2 for the related Address Key.

The first byte data (D7 - D0) is shifted out on the SO line, MSB first. A single byte of data, or up to the whole memory array, can be read out in one NORMAL READ instruction. The address is automatically incremented by one after each byte of data is shifted out. The read operation can be terminated at any time by driving CE# high (VIH) after the data comes out. When the highest address of the device is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read in one continuous READ instruction.

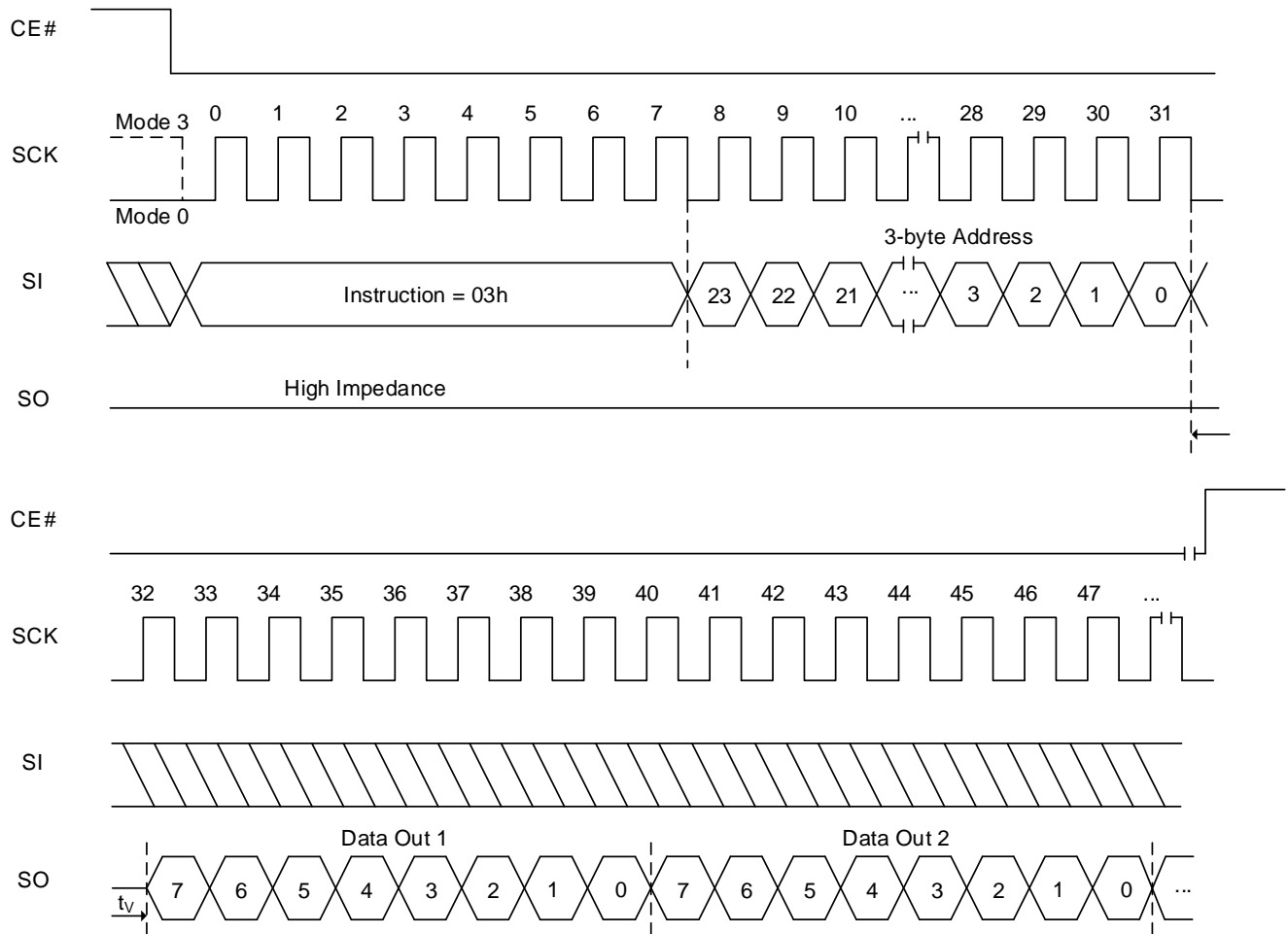
If the NORMAL READ instruction is issued while an Erase, Program or Write operation is in process (WIP=1) the instruction is ignored and will not have any effects on the current operation.

Table 8.2 Address Key

Address	4Mb	2Mb	1Mb	512Kb	256Kb
A _{VMSB} -A ₀	A18-A0 (A23- A19=X)	A17-A0 (A23- A18=X)	A16-A0 (A23- A17=X)	A15-A0 (A23- A16=X)	A14-A0 (A23- A15=X)

Note: X=Don't Care

Figure 8.1 Normal Read Sequence



8.2 FAST READ OPERATION (FRD, 0Bh)

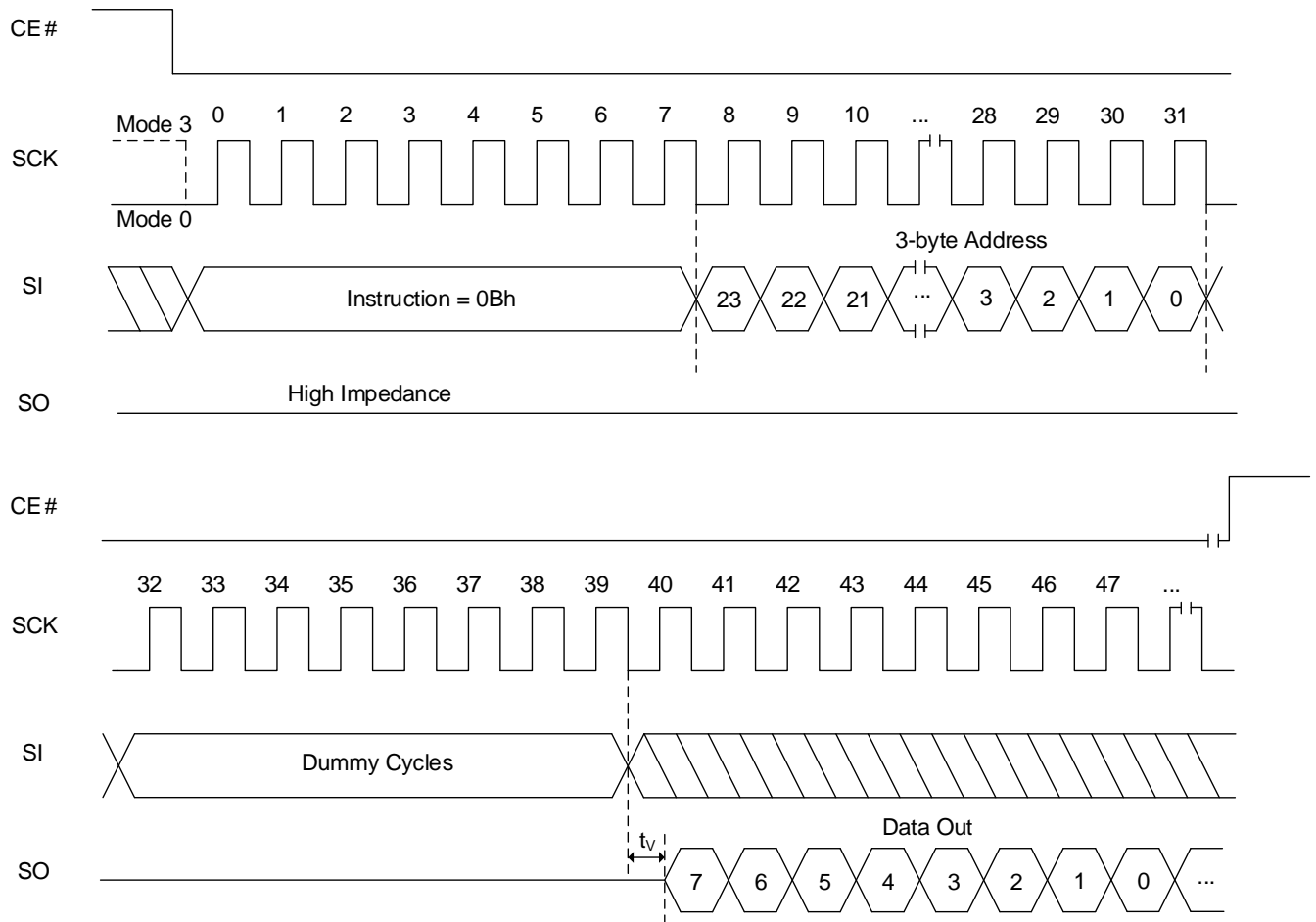
The FAST READ (FRD) instruction is used to read memory data at up to a 104MHz clock.

The FAST READ instruction code is followed by three address bytes (A23 - A0) transmitted via the SI line, with each bit latched-in during the rising edge of SCK. Then the first data byte from the address is shifted out on the SO line after 6 dummy cycles, with each bit shifted out at a maximum frequency f_{CT} , during the falling edge of SCK.

The first byte addressed can be at any memory location. The address is automatically incremented by one after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FAST READ instruction. The FAST READ instruction is terminated by driving CE# high (VIH).

If the FAST READ instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored without affecting the current cycle.

Figure 8.2 Fast Read Sequence



Note: Dummy cycles depends on Read Parameter setting. Detailed information in Table 6.11 Read Dummy Cycles.

FAST READ OPERATION IN QPI MODE (FRD, 0Bh)

The FAST READ (FRD) instruction is used also in QPI mode to read memory data at up to a 104MHz clock.

The FAST READ instruction code (2 clocks) is followed by three address bytes (A23-A0 — 6 clocks), transmitted via the IO3, IO2, IO1 and IO0 lines, with each bit latched-in during the rising edge of SCK. Then the first data byte addressed is shifted out on the IO3, IO2, IO1 and IO0 lines after 6 dummy cycles, with each bit shifted out at a maximum frequency f_{CT} , during the falling edge of SCK.

The first byte addressed can be at any memory location. The address is automatically incremented by one after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FAST READ instruction. The FAST READ instruction in QPI mode is terminated by driving CE# high (VIH).

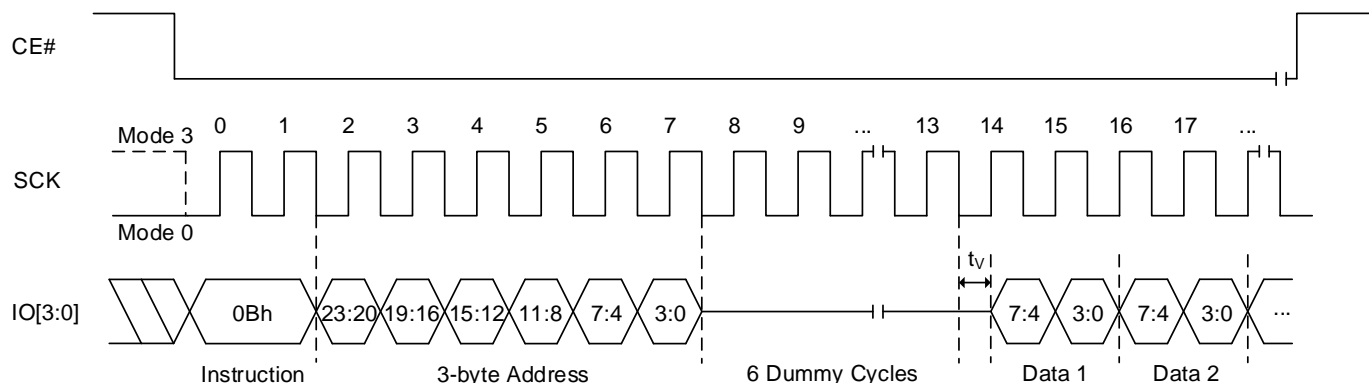
If the FAST READ instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored without affecting the current cycle.

The Fast Read sequence in QPI mode is also applied to the commands in the following table 8.3.

Table 8.3 Address Key

Instruction Name	Operation	Hex Code
FRQIO	Fast Read Quad I/O	EBh
RDUID	Read Unique ID	4Bh
IRRD	Read Information Row	68h

Figure 8.3 Fast Read Sequence In QPI Mode



Note: Number of dummy cycles depends on Read Parameter setting. Detailed information in Table 6.11 Read Dummy Cycles.

8.3 HOLD OPERATION

HOLD# is used in conjunction with CE# to select the device. When the device is selected and a serial sequence is underway, HOLD# can be used to pause the serial communication with the master device without resetting the serial sequence. To pause, HOLD# is brought low while the SCK signal is low. To resume serial communication, HOLD# is brought high while the SCK signal is low (SCK may still toggle during HOLD). Inputs to SI will be ignored while SO is in the high impedance state, during HOLD.

Note: HOLD# is not supported with QE=1.

Timing graph can be referenced in AC Parameters Figure 9.4.

8.4 FAST READ DUAL I/O OPERATION (FRDIO, BBh)

The FRDIO allows the address bits to be input two bits at a time. This may allow for code to be executed directly from the SPI in some applications.

The FRDIO instruction code is followed by three address bytes (A23 – A0) transmitted via the IO1 and IO0 lines, with each pair of bits latched-in during the rising edge of SCK. The address MSB is input on IO1, the next bit on IO0, and this shift pattern continues to alternate between the two lines. Depending on the usage of AX read operation mode, a mode byte may be located after address input.

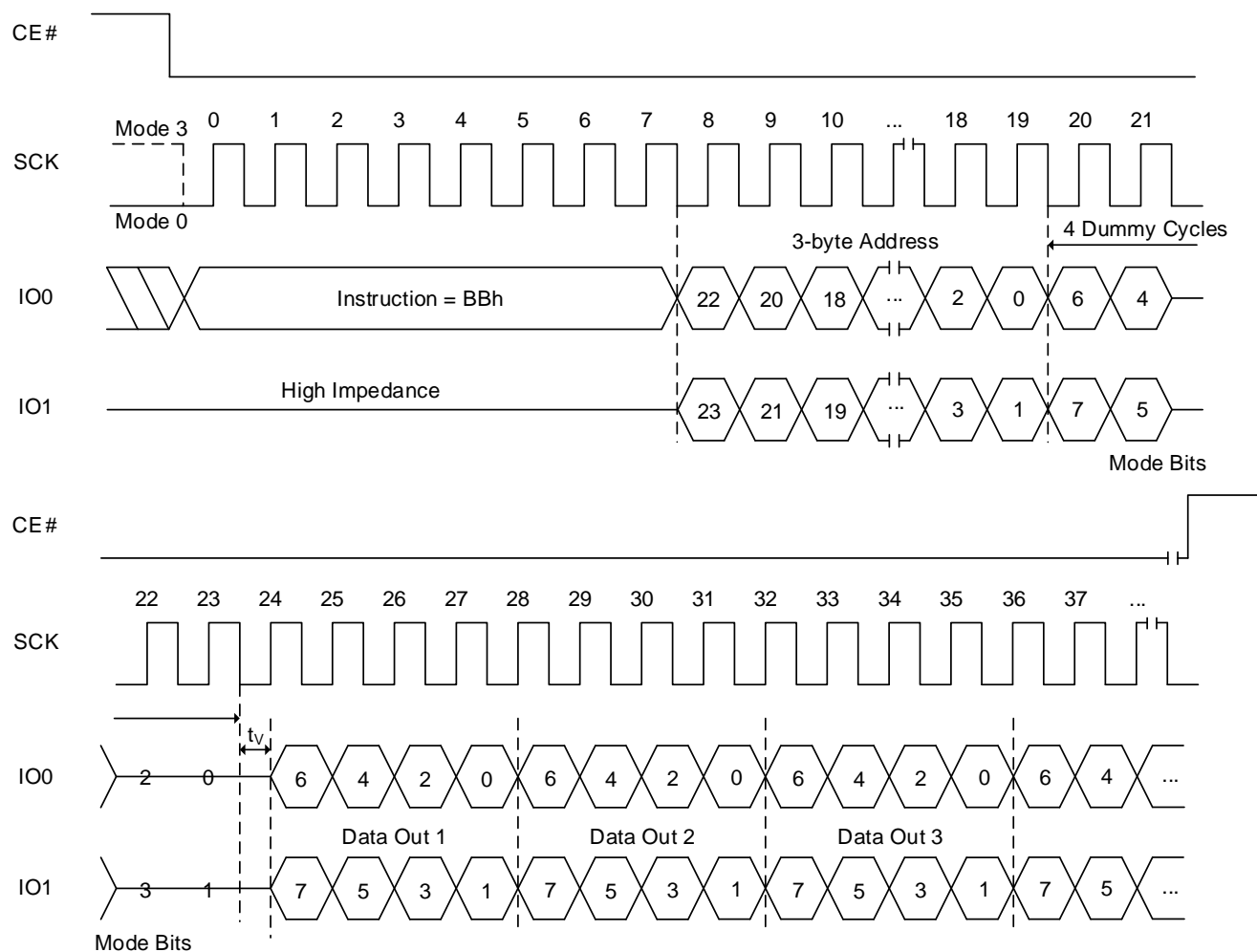
The first data byte addressed is shifted out on the IO1 and IO0 lines after 4 dummy cycles, with each pair of bits shifted out at a maximum frequency f_{CT} , during the falling edge of SCK. The MSB is output on IO1, while simultaneously the second bit is output on IO0. Figure 8.4 illustrates the timing sequence.

The first byte addressed can be at any memory location. The address is automatically incremented by one after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FRDIO instruction. FRDIO instruction is terminated by driving CE# high (V_{IH}).

The device supports the AX read operation by applying mode bits during dummy period. Mode bits consist of 8 bits, such as M7 to M0. Four cycles after address input are reserved for Mode bits in FRDIO execution. M7 to M4 are important for enabling this mode. M3 to M0 become don't care for future use. When M[7:4]=1010(Ah), it enables the AX read operation and subsequent FRDIO execution skips command code. It saves cycles as described in Figure 8.5. When the code is different from AXh (where X is don't care), the device exits the AX read operation. After finishing the read operation, device becomes ready to receive a new command. SPI or QPI mode configuration retains the prior setting. Mode bit must be applied during dummy cycles. The dummy cycles are 4 cycles, data output will start right after mode bit is applied.

If the FRDIO instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored and will not affect the current cycle.

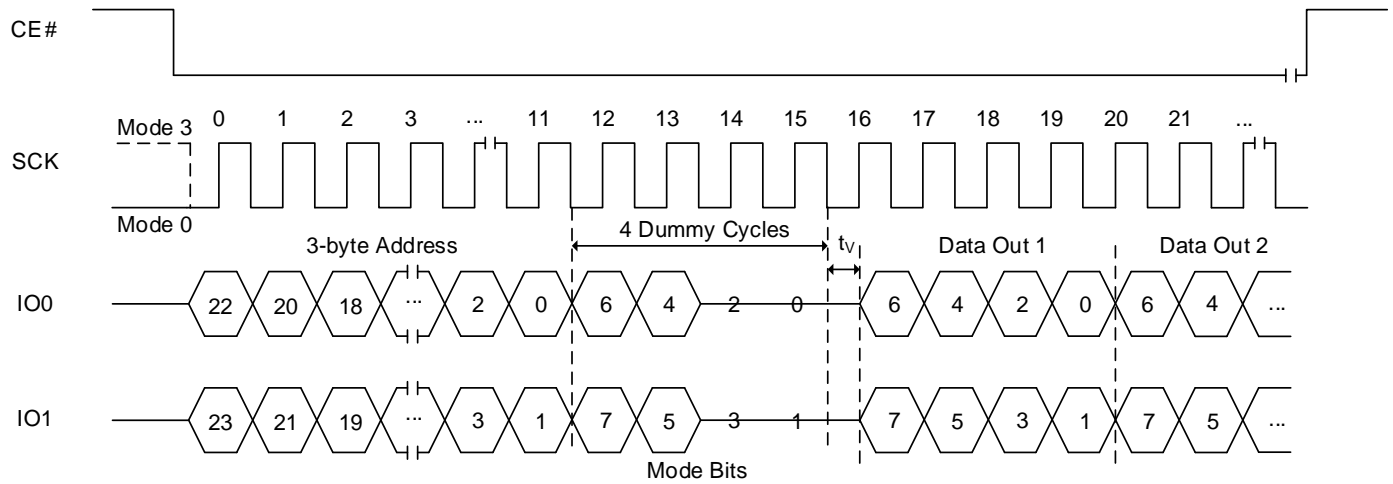
Figure 8.4 Fast Read Dual I/O Sequence (with command decode cycles)



Notes:

1. If the mode bits=AXh (where X is don't care), it can execute the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.
2. Number of dummy cycles depends on clock speed. Detailed information in Table 6.11 Read Dummy Cycles.
3. Sufficient dummy cycles are required to avoid I/O contention. If the number of dummy cycles and AX bit cycles are same, then X should be Hi-Z.

Figure 8.5 Fast Read Dual I/O AX Read Sequence (without command decode cycles)



Notes:

1. If the mode bits=AXh (where X is don't care), it will keep executing the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.

8.5 FAST READ DUAL OUTPUT OPERATION (FRDO, 3Bh)

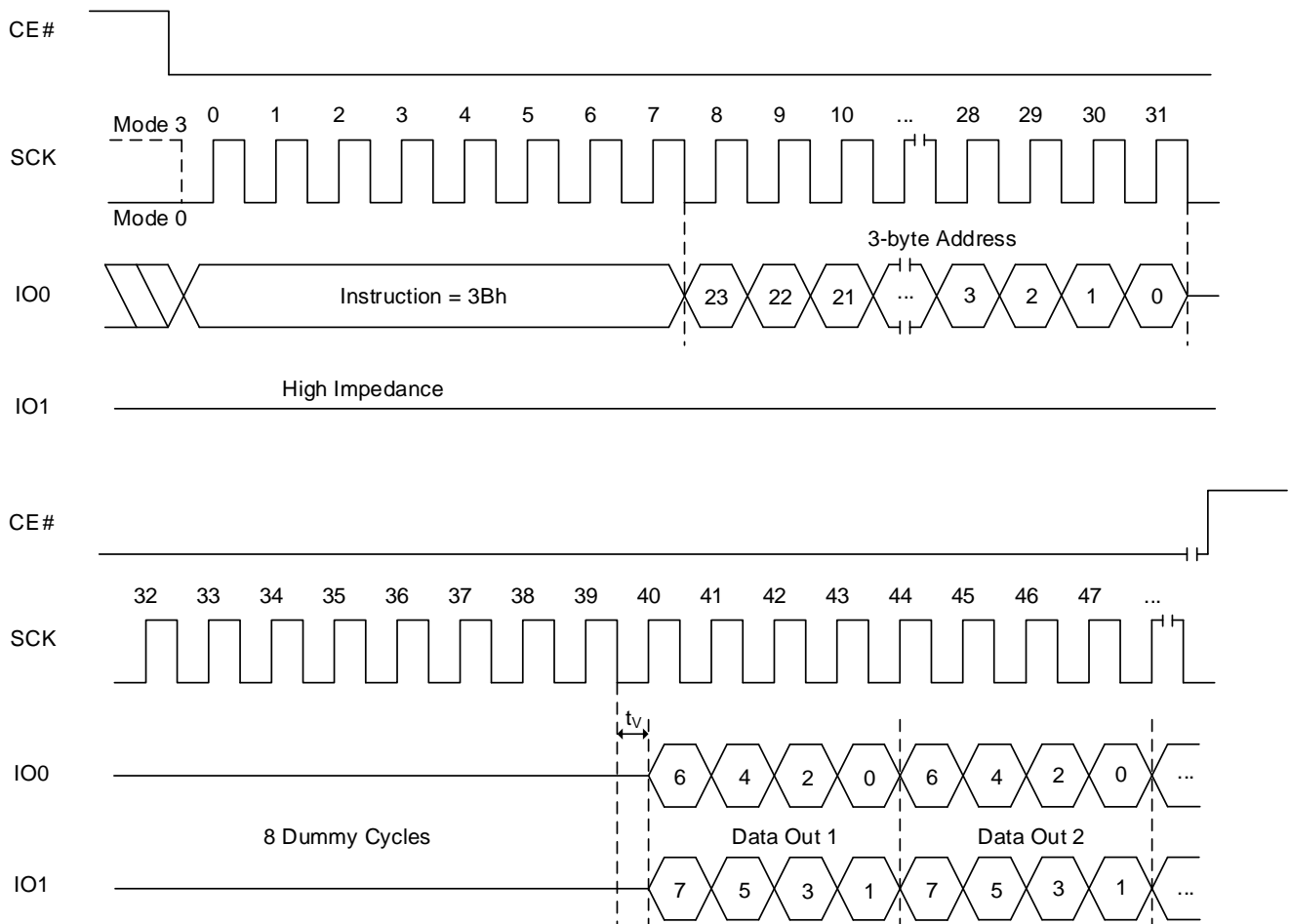
The FRDO instruction is used to read memory data on two output pins each at up to a 104MHz clock.

The FRDO instruction code is followed by three address bytes (A23 – A0) transmitted via the IO0 line, and each bit latched-in during the rising edge of SCK. Then the first data byte addressed is shifted out on the IO1 and IO0 lines after 8 dummy cycles, with each pair of bits shifted out at a maximum frequency f_{CT} , during the falling edge of SCK. The first bit (MSB) is output on IO1. Simultaneously, the second bit is output on IO0.

The first byte addressed can be at any memory location. The address is automatically incremented by one after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FRDO instruction. The FRDO instruction is terminated by driving CE# high (VIH).

If the FRDO instruction is issued while an Erase, Program or Write cycle is in process (BUSY=1) the instruction is ignored and will not have any effects on the current cycle.

Figure 8.6 Fast Read Dual Output Sequence



8.6 FAST READ QUAD OUTPUT OPERATION (FRQO, 6Bh)

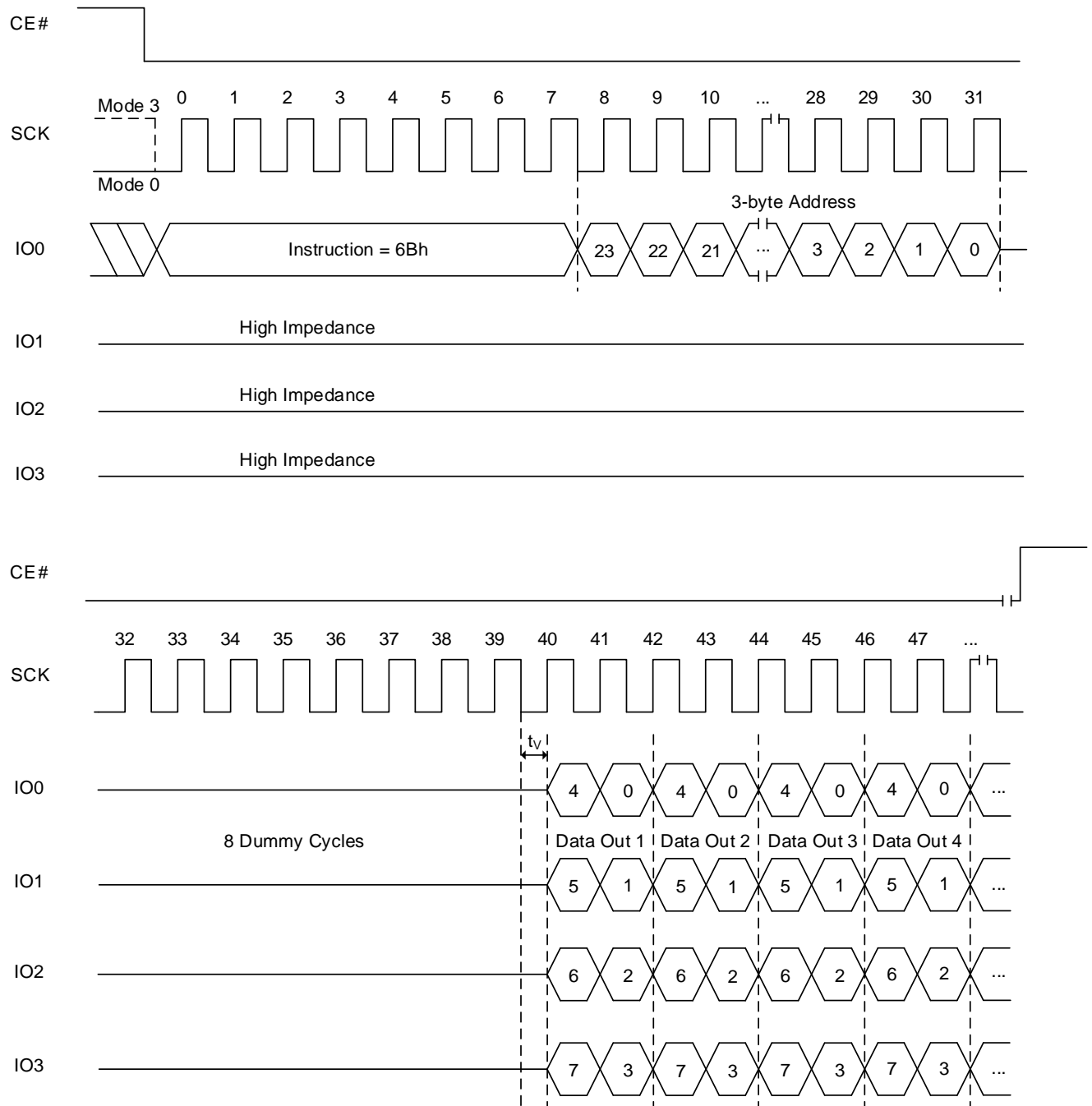
The FRQO instruction is used to read memory data on four output pins each at up to a 104 MHz clock.

The FRQO instruction code is followed by three address bytes (A23 – A0), transmitted via the IO0 line, and each bit latched-in during the rising edge of SCK. Then the first data byte addressed is shifted out on the IO3, IO2, IO1 and IO0 lines after 8 dummy cycles, with each group of four bits shifted out at a maximum frequency f_{CT} , during the falling edge of SCK. The first bit (MSB) is output on IO3, while simultaneously the second bit is output on IO2, the third bit is output on IO1, etc.

The first byte addressed can be at any memory location. The address is automatically incremented after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FRQO instruction. FRQO instruction is terminated by driving CE# high (VIH).

If a FRQO instruction is issued while an Erase, Program or Write cycle is in process (BUSY=1) the instruction is ignored and will not have any effects on the current cycle.

Figure 8.7 Fast Read Quad Output Sequence



8.7 FAST READ QUAD I/O OPERATION (FRQIO, EBh)

The FRQIO instruction allows the address bits to be input four bits at a time. This may allow for code to be executed directly from the SPI in some applications.

The FRQIO instruction code is followed by three address bytes (A23 – A0), transmitted via the IO3, IO2, IO1 and IO0 lines, and each group of four bits latched-in during the rising edge of SCK. The address of MSB inputs on IO3, the next bit on IO2, the next bit on IO1, the next bit on IO0, and continue to shift in alternating on the four. Depending on the usage of AX read operation mode, a mode byte may be located after address input.

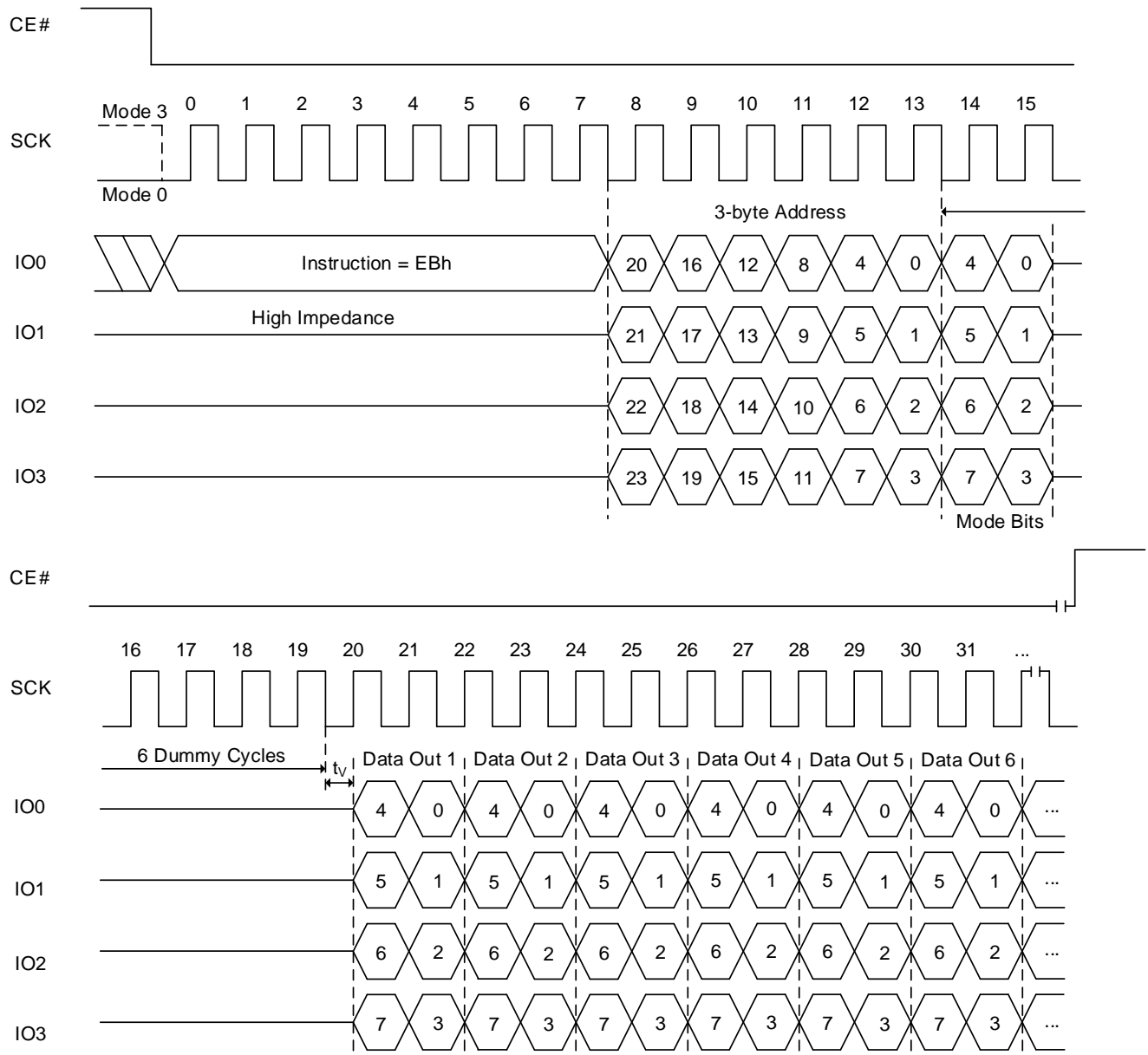
The first data byte addressed is shifted out on the IO3, IO2, IO1 and IO0 lines after 6 dummy cycles, with each group of four bits shifted out at a maximum frequency f_{CT} , during the falling edge of SCK. The first bit (MSB) is output on IO3, while simultaneously the second bit is output on IO2, the third bit is output on IO1, etc. Figure 8.8 illustrates the timing sequence.

The first byte addressed can be at any memory location. The address is automatically incremented after each byte of data is shifted out. When the highest address is reached, the address counter will roll over to the 000000h address, allowing the entire memory to be read with a single FRQIO instruction. FRQIO instruction is terminated by driving CE# high (V_{IH}).

The device supports the AX read operation by applying mode bits during dummy period. Mode bits consist of 8 bits, such as M7 to M0. Two cycles after address input are reserved for Mode bits in FRQIO execution. M7 to M4 are important for enabling this mode. M3 to M0 become don't care for future use. When M[7:4]=1010(Ah), it enables the AX read operation and subsequent FRQIO execution skips command code. It saves cycles as described in Figure 8.9. When the code is different from AXh (where X is don't care), the device exits the AX read operation. After finishing the read operation, device becomes ready to receive a new command. SPI or QPI mode configuration retains the prior setting.

If the FRQIO instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored and will not have any effects on the current cycle.

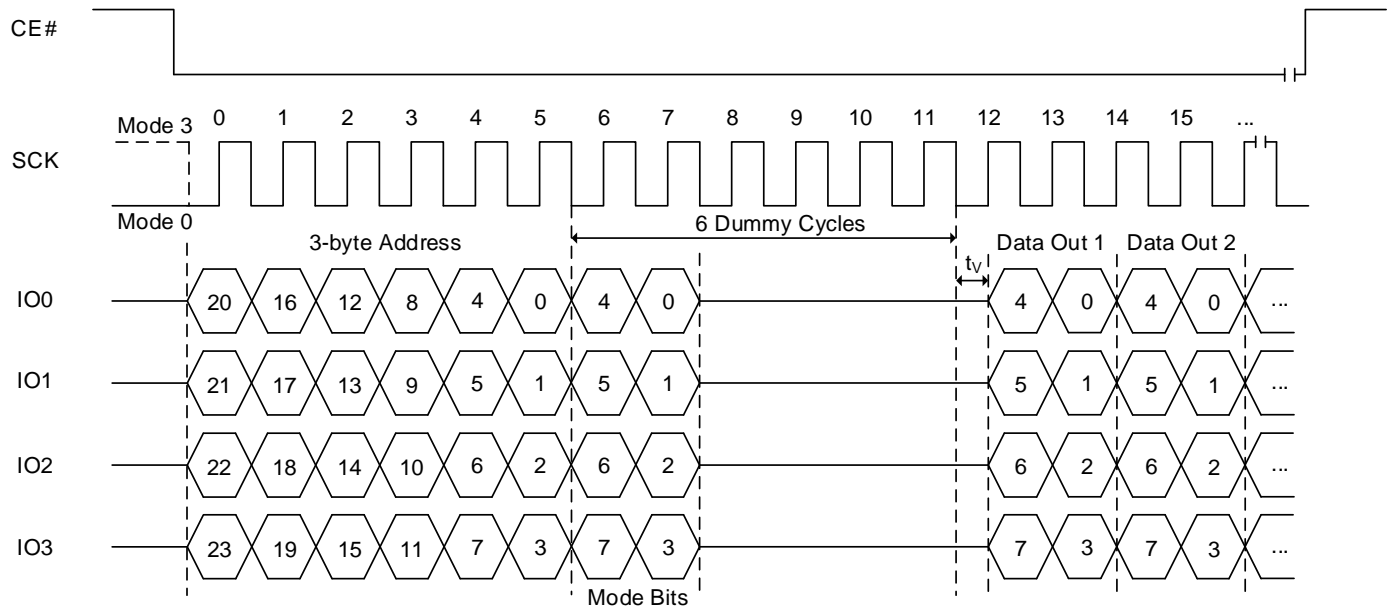
Figure 8.8 Fast Read Quad I/O Sequence (with command decode cycles)



Note:

1. If the mode bits=AXh (where X is don't care), it can execute the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.

Figure 8.9 Fast Read Quad I/O AX Read Sequence (without command decode cycles)



Note:

1. If the mode bits=AXh (where X is don't care), it will keep executing the AX read mode (without command). When the mode bits are different from AXh, the device exits the AX read operation.

FAST READ QUAD I/O OPERATION IN QPI MODE (FRQIO, EBh)

The FRQIO instruction is also used in QPI mode to read memory data at up to a 104MHz clock.

The FRQIO instruction in QPI mode utilizes all four IO lines to input the instruction code so that only two clocks are required, while the FRQIO instruction in SPI mode requires that the byte-long instruction code is shifted into the device only via IO0 line in eight clocks. As a result, 6 command cycles will be reduced by the FRQIO instruction in QPI mode.

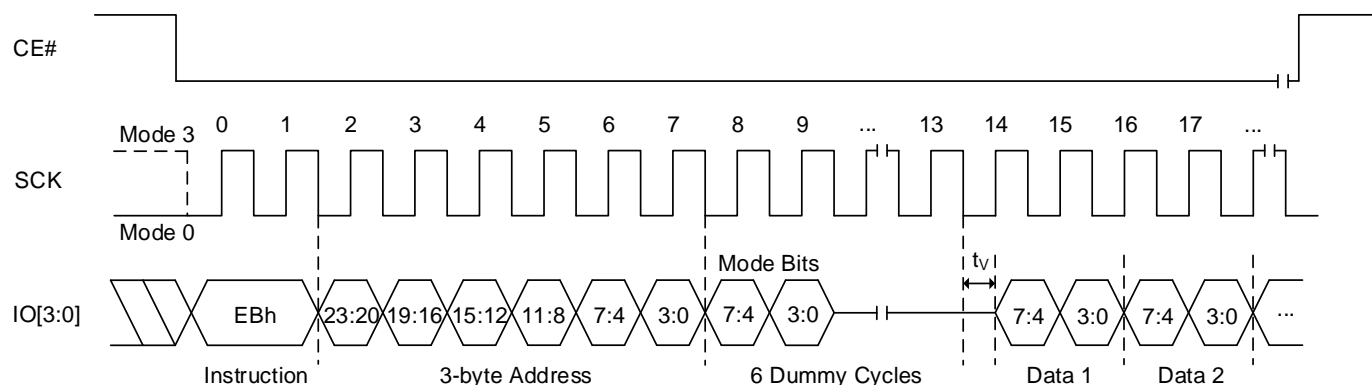
The first data byte addressed is shifted out on the IO3, IO2, IO1 and IO0 lines after 6 dummy cycles, with each group of four bits shifted out at a maximum frequency f_{CT} , during the falling edge of SCK.

The device supports the AX read operation by applying mode bits during dummy period. Mode bits consist of 8 bits, such as M7 to M0. Two cycles after address input are reserved for Mode bits in FRQIO execution. M7 to M4 are important for enabling this mode. M3 to M0 become don't care for future use. When M[7:4]=1010(Ah), it enables the AX read operation and subsequent FRQIO execution skips command code. When the code is different from AXh (where X is don't care), the device exits the AX read operation.

After finishing the read operation, device becomes ready to receive a new command. SPI or QPI mode configuration retains the prior setting.

If the FRQIO instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored and will not have any effects on the current cycle.

Figure 8.10 Fast Read Quad I/O Sequence in QPI Mode



8.8 PAGE PROGRAM OPERATION (PP, 02h)

The Page Program (PP) instruction allows up to 256 bytes data to be programmed into memory in a single operation. The destination of the memory to be programmed must be outside the protected memory area set by the Block Protection (BP3, BP2, BP1, BP0) bits. A PP instruction which attempts to program into a page that is write-protected will be ignored. Before the execution of PP instruction, the Write Enable Latch (WEL) must be enabled through a Write Enable (WREN) instruction.

The PP instruction code, three address bytes and program data (1 to 256 bytes) are input via the SI line. Program operation will start immediately after the CE# is brought high, otherwise the PP instruction will not be executed. The internal control logic automatically handles the programming voltages and timing. The progress or completion of the program operation can be determined by reading the WIP bit in Status Register via a RDSR instruction. If the WIP bit is "1", the program operation is still in progress. If WIP bit is "0", the program operation has completed.

If more than 256 bytes data are sent to a device, the address counter rolls over within the same page, the previously latched data are discarded, and the last 256 bytes are kept to be programmed into the page. The starting byte can be anywhere within the page. When the end of the page is reached, the address will wrap around to the beginning of the same page. If the data to be programmed are less than a full page, the data of all other bytes on the same page will remain unchanged.

Note: A program operation can alter "1"s into "0"s. The same byte location or page may be programmed more than once, to incrementally change "1"s to "0"s. An erase operation is required to change "0"s to "1"s.

Figure 8.11 Page Program Sequence in SPI Mode

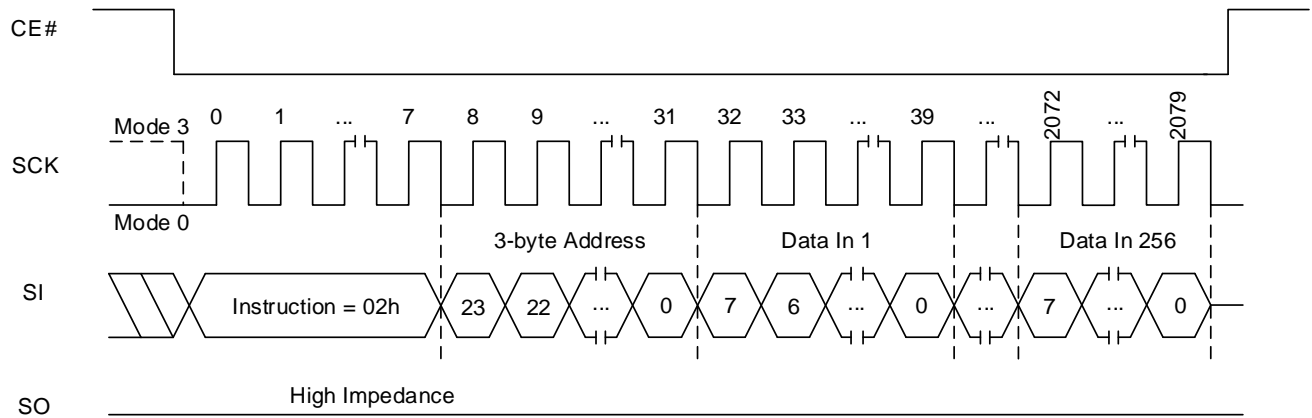
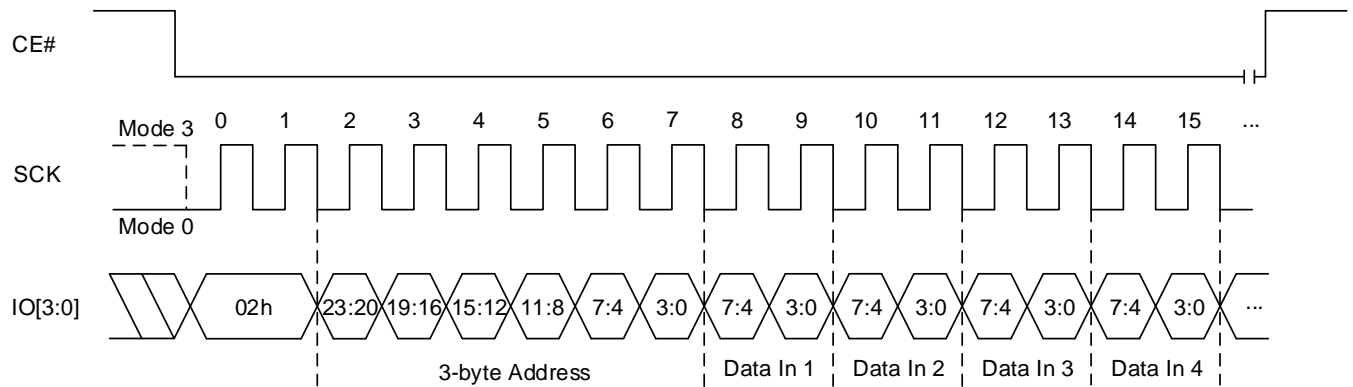


Figure 8.12 Page Program Sequence in QPI Mode



8.9 QUAD INPUT PAGE PROGRAM OPERATION (PPQ, 32h/38h)

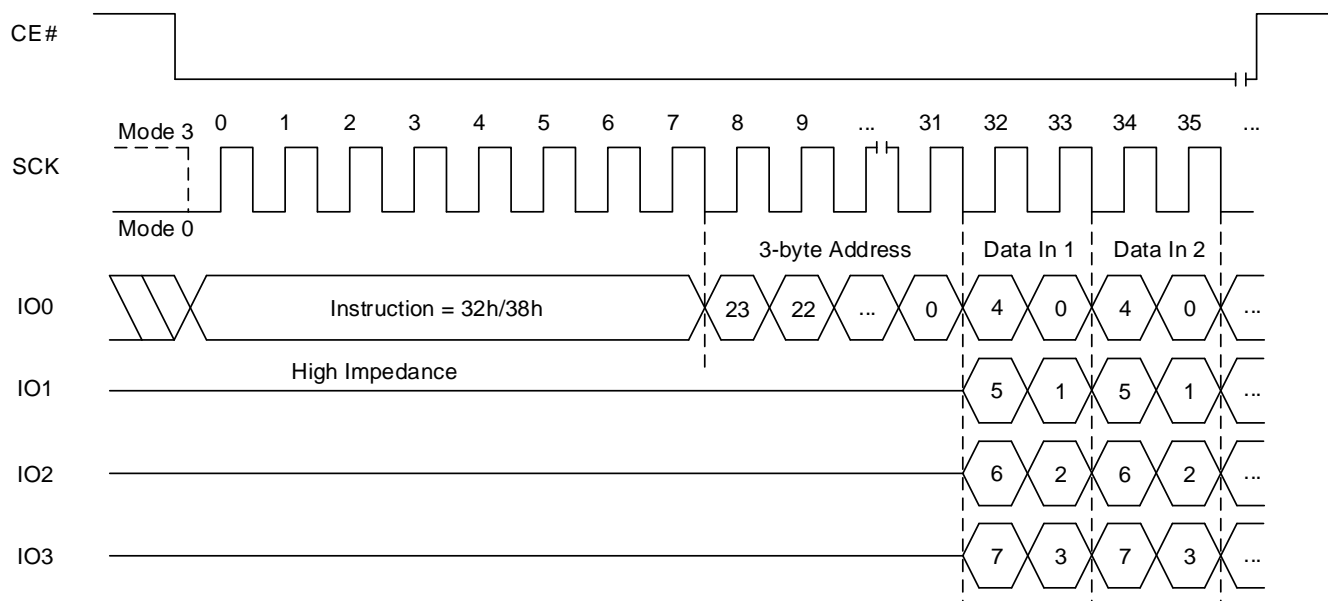
The Quad Input Page Program instruction allows up to 256 bytes data to be programmed into memory in a single operation with four pins (IO0, IO1, IO2 and IO3). The destination of the memory to be programmed must be outside the protected memory area set by the Block Protection (BP3, BP2, BP1, BP0) bits. A Quad Input Page Program instruction which attempts to program into a page that is write-protected will be ignored. Before the execution of Quad Input Page Program instruction, the QE bit in the Status Register must be set to “1” and the Write Enable Latch (WEL) must be enabled through a Write Enable (WREN) instruction.

The Quad Input Page Program instruction code, three address bytes and program data (1 to 256 bytes) are input via the four pins (IO0, IO1, IO2 and IO3). Program operation will start immediately after the CE# is brought high, otherwise the Quad Input Page Program instruction will not be executed. The internal control logic automatically handles the programming voltages and timing. The progress or completion of the program operation can be determined by reading the WIP bit in Status Register via a RDSR instruction. If the WIP bit is “1”, the program operation is still in progress. If WIP bit is “0”, the program operation has completed.

If more than 256 bytes data are sent to a device, the address counter rolls over within the same page, the previously latched data are discarded, and the last 256 bytes data are kept to be programmed into the page. The starting byte can be anywhere within the page. When the end of the page is reached, the address will wrap around to the beginning of the same page. If the data to be programmed are less than a full page, the data of all other bytes on the same page will remain unchanged.

Note: A program operation can alter “1”s into “0”s. The same byte location or page may be programmed more than once, to incrementally change “1”s to “0”s. An erase operation is required to change “0”s to “1”s.

Figure 8.13 Quad Input Page Program Sequence





8.10 ERASE OPERATION

The Erase command sets all bits in the addressed sector or block to “1”s.

The memory array of the 512Kb/256Kb (IS25LP/WP512E/025E) is organized into uniform 4Kbyte sectors or 32Kbyte uniform blocks (a block consists of eight adjacent sectors).

The memory array of the 4Mb/2Mb/1Mb (IS25LP/WP040E/020E/010E) is organized into uniform 4Kbyte sectors or 32/64Kbyte uniform blocks (a block consists of eight/sixteen adjacent sectors respectively).

In order to erase the device, there are three erase instructions available: Sector Erase (SER), Block Erase (BER) and Chip Erase (CER). A sector erase operation allows any individual sector to be erased without affecting the data in other sectors. A block erase operation erases any individual block. A chip erase operation erases the whole memory array of a device. A sector erase, block erase or chip erase operation can be executed prior to any programming operation.

8.11 SECTOR ERASE OPERATION (SER, D7h/20h)

A Sector Erase (SER) instruction erases a 4 Kbyte sector before the execution of a SER instruction, the Write Enable Latch (WEL) must be set via a Write Enable (WREN) instruction. The WEL bit is automatically reset after the completion of Sector Erase operation.

A SER instruction is entered, after CE# is pulled low to select the device and stays low during the entire instruction sequence. The SER instruction code, and three address bytes are input via SI. Erase operation will start immediately after CE# is pulled high. The internal control logic automatically handles the erase voltage and timing.

The progress or completion of the erase operation can be determined by reading the WIP bit in the Status Register using a RDSR instruction.

If the WIP bit is "1", the erase operation is still in progress. If the WIP bit is "0", the erase operation has been completed.

Figure 8.14 Sector Erase Sequence In SPI Mode

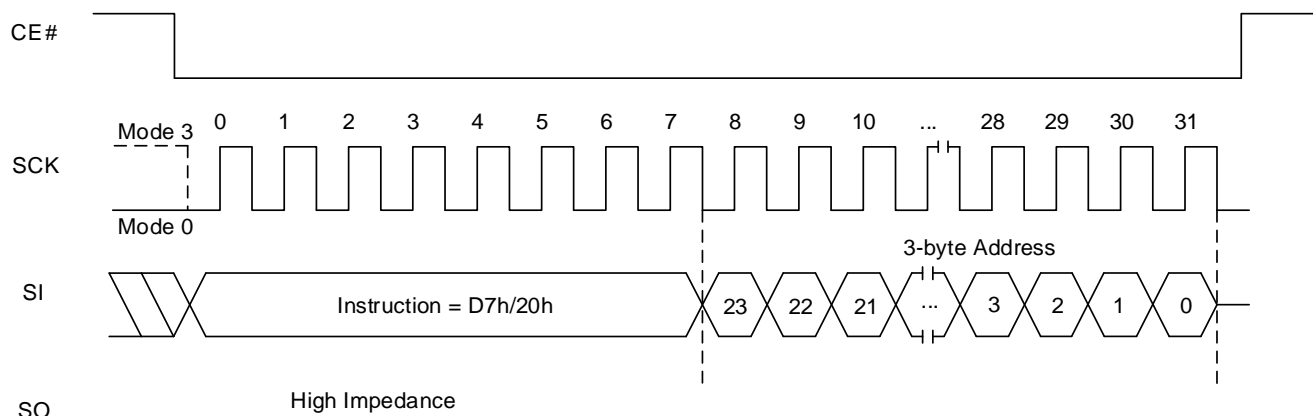
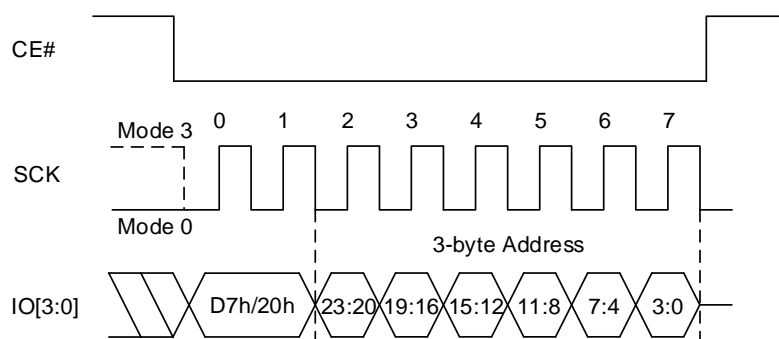


Figure 8.15 Sector Erase Sequence In QPI Mode



8.12 BLOCK ERASE OPERATION (BER32K:52h or 52h/D8h, BER64K:D8h)

A Block Erase (BER) instruction erases a 32/64Kbyte block. Before the execution of a BER instruction, the Write Enable Latch (WEL) must be set via a Write Enable (WREN) instruction. The WEL is reset automatically after the completion of a block erase operation.

In 256Kb/512Kb (IS25LP/WP512E/025E), there is a 32KB block only, both 52h and D8h are for BER32K command. But in 4Mb/2Mb/1Mb (IS25LP/WP040E/020E/010E), there are 32KB block and 64KB block, so 52h is for BER32K command, and D8h is for BER64K command.

The BER instruction code and three address bytes are input via SI. Erase operation will start immediately after the CE# is pulled high, otherwise the BER instruction will not be executed. The internal control logic automatically handles the erase voltage and timing.

Figure 8.16 Block Erase (64KB) Sequence In SPI Mode

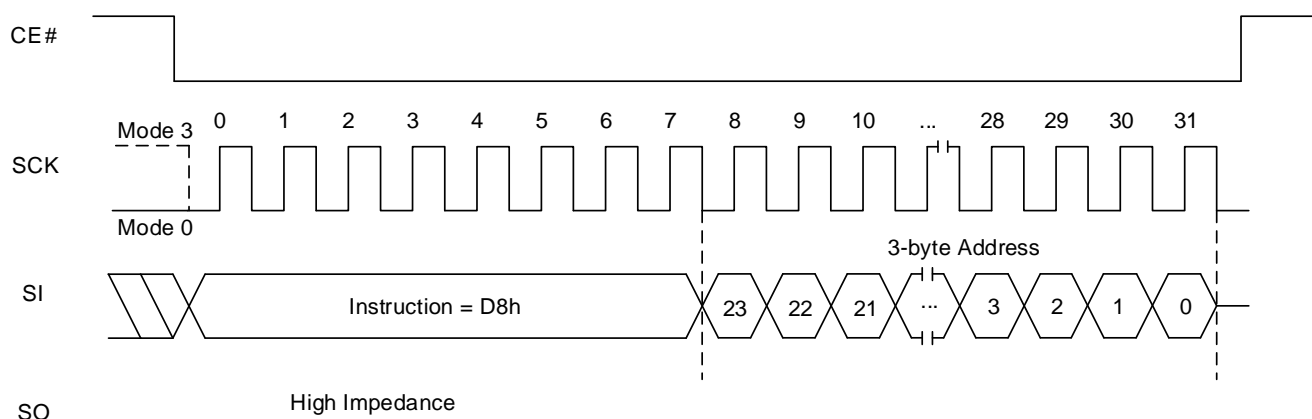


Figure 8.17 Block Erase (64KB) Sequence In QPI Mode

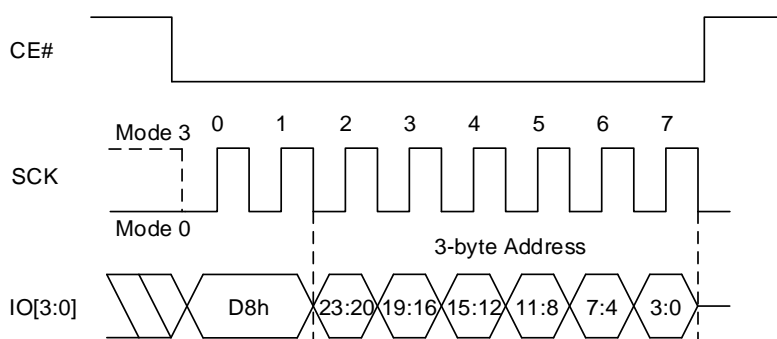


Figure 8.18 Block Erase (32KB) Sequence In SPI Mode

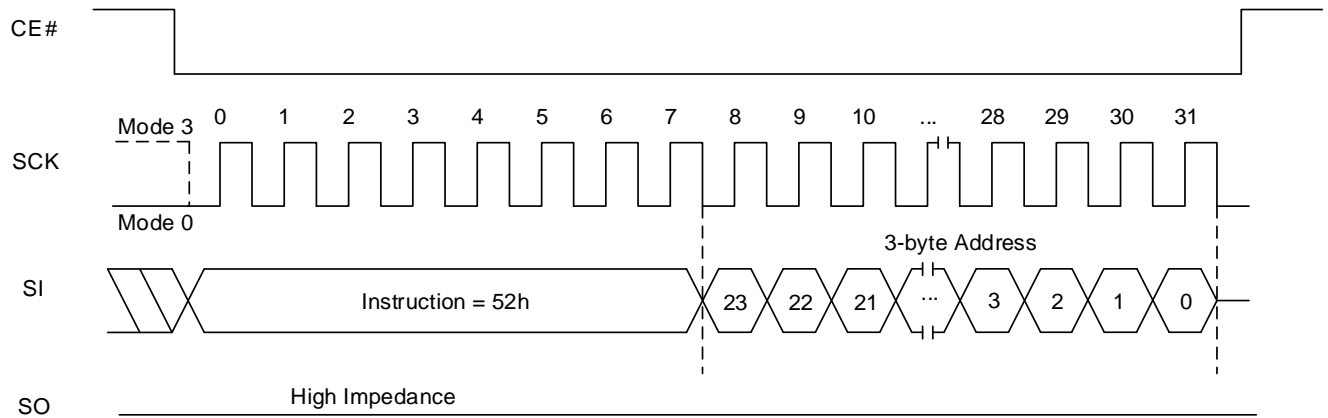
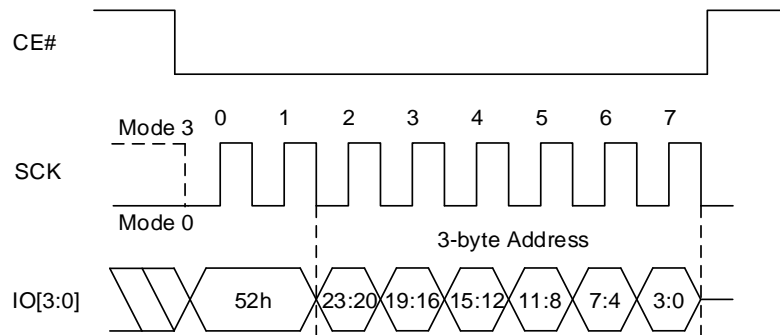


Figure 8.19 Block Erase (32KB) Sequence In QPI Mode



8.13 CHIP ERASE OPERATION (CER, C7h/60h)

A Chip Erase (CER) instruction erases the entire memory array. Before the execution of CER instruction, the Write Enable Latch (WEL) must be set via a Write Enable (WREN) instruction. The WEL is automatically reset after completion of a chip erase operation.

The CER instruction code is input via the SI. Erase operation will start immediately after CE# is pulled high, otherwise the CER instruction will not be executed. The internal control logic automatically handles the erase voltage and timing.

Figure 8.20 Chip Erase Sequence In SPI Mode

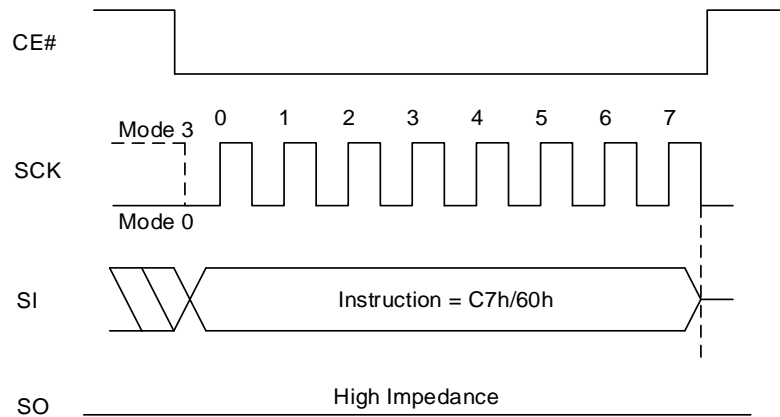
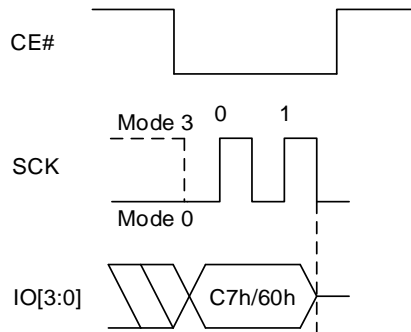


Figure 8.21 Chip Erase Sequence In QPI Mode



8.14 WRITE ENABLE OPERATION (WREN, 06h)

The Write Enable (WREN) instruction is used to set the Write Enable Latch (WEL) bit. The WEL bit is reset to the write-protected state after power-up. The WEL bit must be write enabled before any write operation, including Sector Erase, Block Erase, Chip Erase, Page Program, Program Information Row, Write Non-Volatile Status Register, and Write Function Register operations except for Write Volatile Status Register.

The WEL bit will be reset to the write-protected state automatically upon completion of a write operation. The WREN instruction is required before any above operation is executed.

Figure 8.22 Write Enable Sequence In SPI Mode

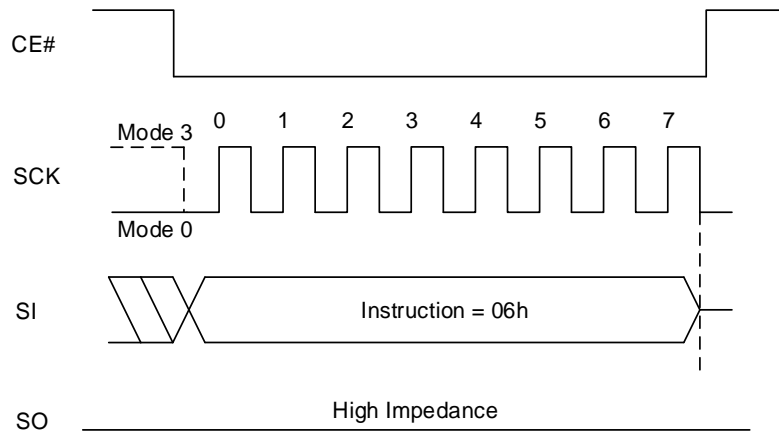
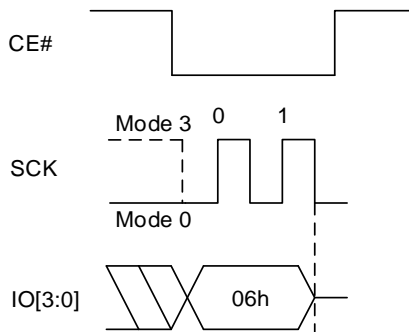


Figure 8.23 Write Enable Sequence In QPI Mode



8.15 WRITE DISABLE OPERATION (WRDI, 04h)

The Write Disable (WRDI) instruction resets the WEL bit and disables all write instructions. The WRDI instruction is not required after the execution of a write instruction, since the WEL bit is automatically reset.

Figure 8.24 Write Disable Sequence In SPI Mode

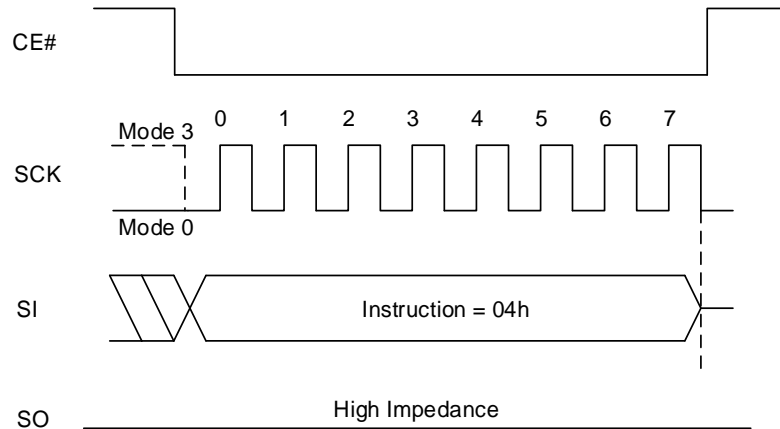
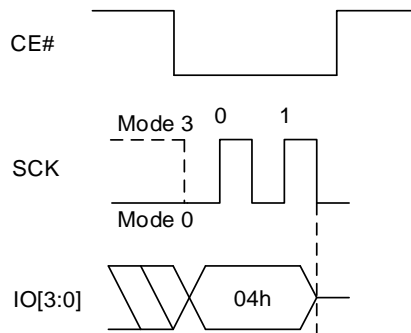


Figure 8.25 Write Disable Sequence In QPI Mode



8.16 READ STATUS REGISTER OPERATION (RDSR, 05h)

The Read Status Register (RDSR) instruction provides access to the Status Register. During the execution of a program, erase or write Status Register operation, RDSR instruction can be used to check the progress or completion of an operation by reading the WIP bit of Status Register.

Figure 8.26 Read Status Register Sequence In SPI Mode

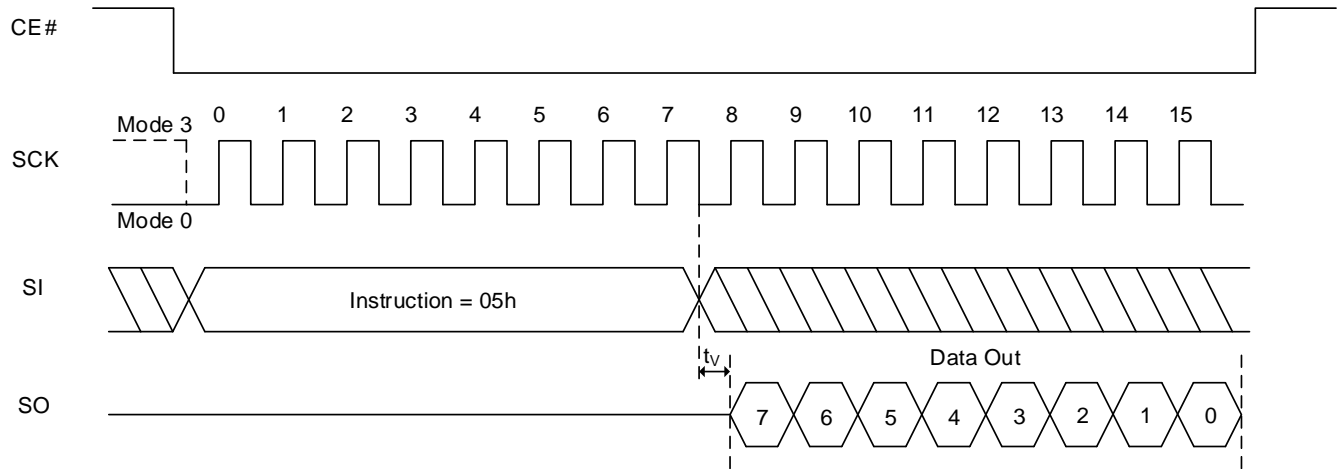
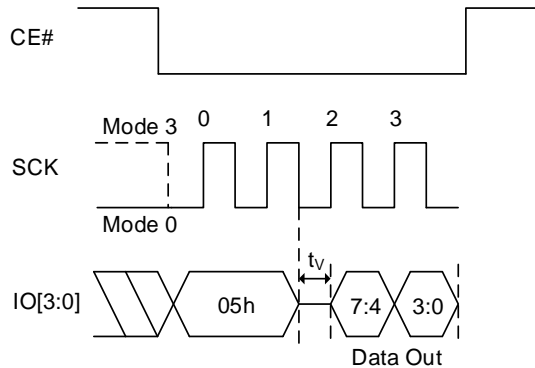


Figure 8.27 Read Status Register Sequence In QPI Mode



8.17 WRITE STATUS REGISTER OPERATION (WRSR, 01h)

The Write Status Register (WRSR) instruction allows the user to enable or disable the block protection and Status Register write protection features by writing “0”s or “1”s into the volatile/non-volatile BP3, BP2, BP1, BP0, and SRWD bits. Also WRSR instruction allows the user to disable or enable quad operation by writing “0” or “1” into the volatile/non-volatile QE bit.

To write Status Register bits, a standard Write Enable (06h) instruction must previously have been executed for the device to accept Write Status Register (01h) instruction (Status Register bit WEL must equal 1).

Figure 8.28 Write Status Register Sequence In SPI Mode

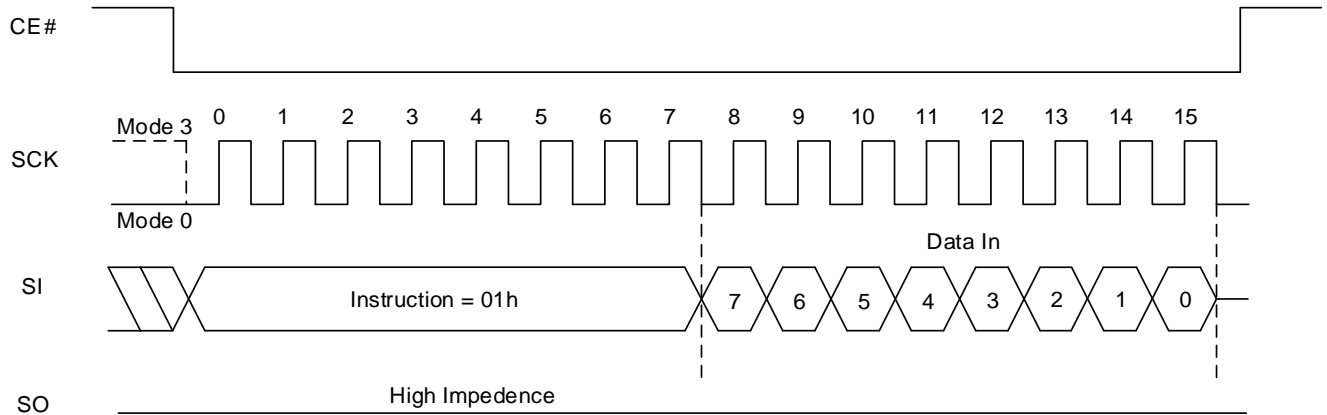
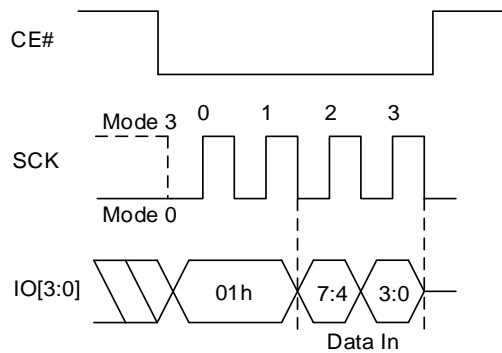


Figure 8.29 Write Status Register Sequence In QPI Mode



8.18 READ FUNCTION REGISTER OPERATION (RDFR, 48h)

The Read Function Register (RDFR) instruction provides access to the Function Register.

Figure 8.30 Read Function Register Sequence In SPI Mode

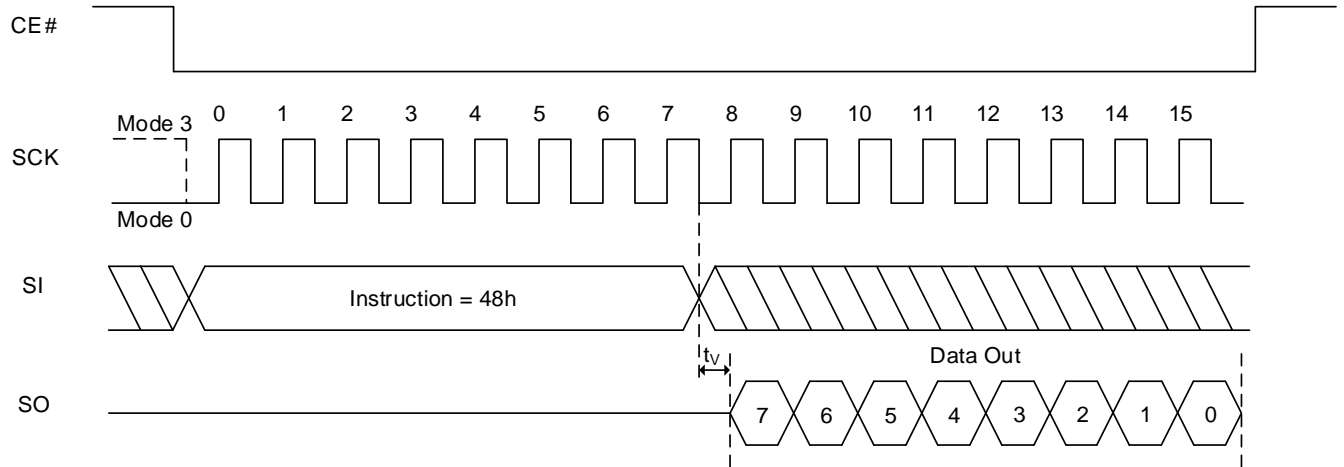
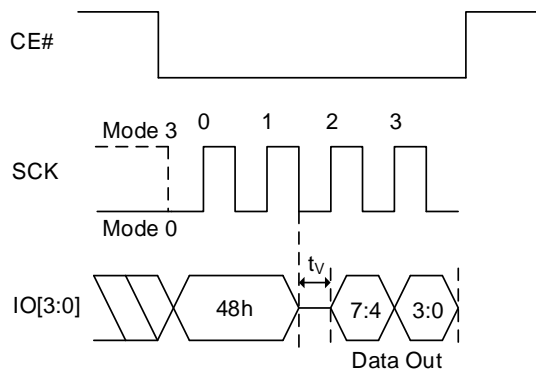


Figure 8.31 Read Function Register Sequence In QPI Mode



8.19 WRITE FUNCTION REGISTER OPERATION (WRFR, 42h)

Information Row Lock bits (IRL3~IRL0) can be set to “1” individually by WRFR instruction in order to lock Information Row. Since IRL bits are OTP, once it is set to “1”, it cannot set back to “0” again.

Before the execution of a WRFR instruction, the Write Enable Latch (WEL) must be set via a Write Enable (WREN) instruction. The WEL is reset automatically after the completion of a write function register operation.

Figure 8.32 Write Function Register Sequence In SPI Mode

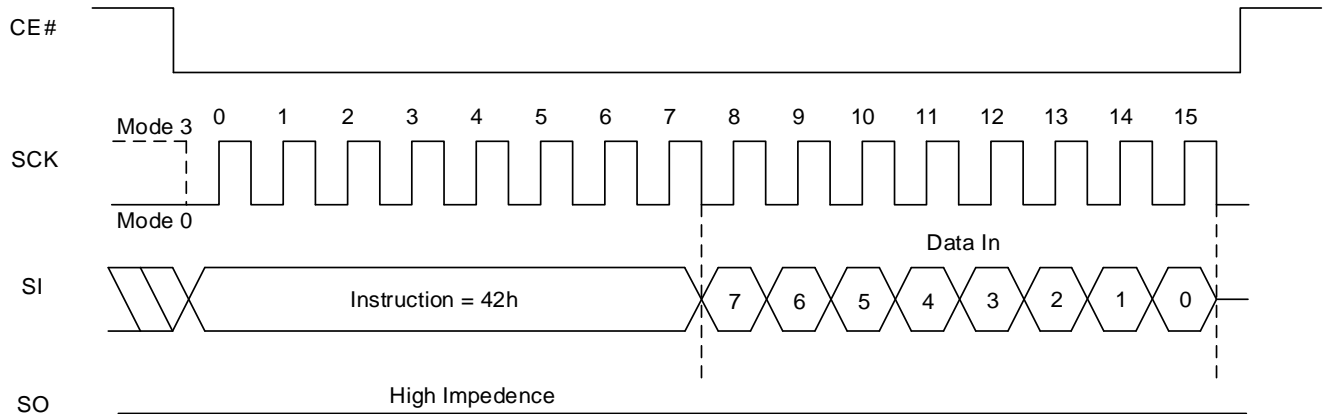
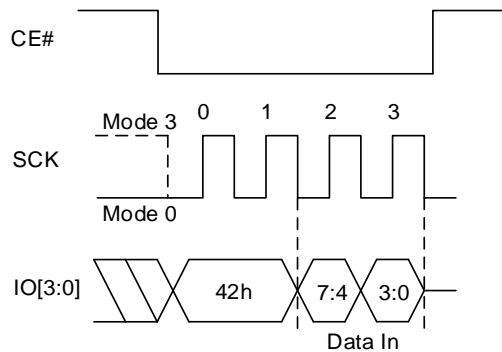


Figure 8.33 Write Function Register QPI Sequence In QPI Mode



8.20 ENTER QUAD PERIPHERAL INTERFACE (QPI) MODE OPERATION (QPIEN, 35h; QPIDI, F5h)

The Enter Quad Peripheral Interface (QPIEN) instruction, 35h, enables the Flash device for QPI bus operation. Upon completion of the instruction, all instructions thereafter will be 4-bit multiplexed input/output until a power cycle or an Exit Quad Peripheral Interface instruction is sent to device.

The Exit Quad Peripheral Interface (QPIDI) instruction, F5h, resets the device to 1-bit SPI protocol operation. To execute an Exit Quad Peripheral Interface operation, the host drives CE# low, sends the QPIDI instruction, then drives CE# high. The device just accepts QPI (2 clocks) command cycles.

Figure 8.34 Enter Quad Peripheral Interface (QPI) Mode Sequence

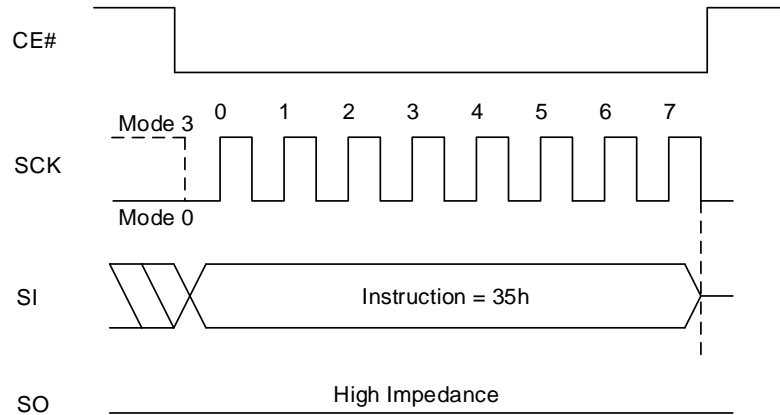
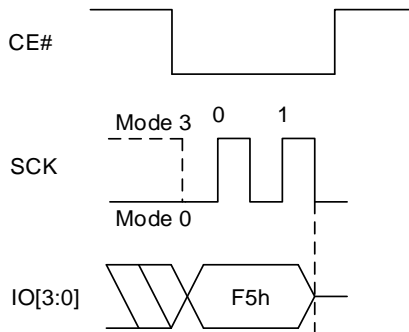


Figure 8.35 Exit Quad Peripheral Interface (QPI) Mode Sequence



8.21 PROGRAM/ERASE SUSPEND & RESUME

The device allows the interruption of Sector Erase, Block Erase, or Page Program operations to conduct other operations. 75h/B0h command for suspend and 7Ah/30h for resume will be used. (SPI/QPI all acceptable) Function Register bit2 (PSUS) and bit3 (ESUS) are used to check whether or not the device is in suspend mode.

Suspend to read ready timing (t_{SUS}): 100 μ s (TYP)

Resume to another suspend timing (t_{RS}): 80 μ s (TYP)

SUSPEND DURING SECTOR-ERASE OR BLOCK-ERASE (PERSUS 75h/B0h)

The Suspend command allows the interruption of Sector Erase and Block Erase operations. But Suspend command will be ignored during Chip Erase operation. After the Suspend command, other commands include array read operation can be accepted.

But Write Status Register command (01h) and Erase instructions are not allowed during Erase Suspend. Also, array read for being erased sector/block is not allowed.

To execute Erase Suspend operation, the host drives CE# low, sends the Suspend command cycle (75h/B0h), then drives CE# high. The Function Register indicates that the Erase has been suspended by setting the ESUS bit from "0" to "1", but the device will not accept another command until it is ready. To determine when the device will accept a new command, poll the WIP bit or wait the specified time t_{SUS} . When ESUS bit is set to "1", the Write Enable Latch (WEL) bit clears to "0".

SUSPEND DURING PAGE PROGRAMMING (PERSUS 75h/B0h)

The Suspend command also allows the interruption of all array Program operations. After the Suspend command, other commands include array read operation can be accepted can be accepted.

But Write Status Register instruction (01h) and Program instructions are not allowed during Program Suspend. Also, array read for being programmed page is not allowed.

To execute the Program Suspend operation, the host drives CE# low, sends the Suspend command cycle (75h/B0h), then drives CE# high. The Function Register indicates that the programming has been suspended by setting the PSUS bit from "0" to "1", but the device will not accept another command until it is ready. To determine when the device will accept a new command, poll the WIP bit or wait the specified time t_{SUS} . When PSUS bit is set to "1", the Write Enable Latch (WEL) bit clears to "0".

PROGRAM/ERASE RESUME (PERRSM 7Ah/30h)

The Program/Erase Resume restarts the Program or Erase command that was suspended, and clears the suspend status bit in the Function Register (ESUS or PSUS bits) to "0". To execute the Program/Erase Resume operation, the host drives CE# low, sends the Program/Erase Resume command cycle (7Ah/30h), then drives CE# high. A cycle is two nibbles long, most significant nibble first. To issue another Erase Suspend operation after Erase Resume operation, Erase Resume to another Erase Suspend delay (t_{RS}) is required, but it could require longer Erase time to complete Erase operation.

To determine if the internal, self-timed Write operation completed, poll the WIP bit.

Table 8.4 Instructions accepted during Suspend

Operation Suspended	Instruction Allowed		
	Name	Hex Code	Operation
Program or Erase	NORD	03h	Read Data Bytes from Memory at Normal Read Mode
Program or Erase	FRD	0Bh	Read Data Bytes from Memory at Fast Read Mode
Program or Erase	FRDIO	BBh	Fast Read Dual I/O
Program or Erase	FRDO	3Bh	Fast Read Dual Output
Program or Erase	FRQIO	EBh	Fast Read Quad I/O
Program or Erase	FRQO	6Bh	Fast Read Quad Output
Program or Erase	WREN	06h	Write Enable
Program or Erase	WRDI	04h	Write Disable
Program or Erase	WRSR	01h	Write Volatile Status Register
Erase	PP ⁽¹⁾	02h	Serial Input Page Program
Erase	PPQ ⁽¹⁾	32h/38h	Quad Input Page Program
Program or Erase	RDSR	05h	Read Status Register
Program or Erase	RDFR	48h	Read Function Register
Program or Erase	PERRSM	7Ah/30h	Program/Erase Resume
Erase	PERRSM	75h/B0h	Program/Erase Suspend (to suspend program operation in another block during Erase suspend)
Program or Erase	RDID	ABh	Read Manufacturer and Product ID
Program or Erase	RDJDID	9Fh	Read JEDEC ID
Program or Erase	RDJDIDQ	AFh	Read JEDEC ID in QPI mode
Program or Erase	RDMDID	90h	Read Manufacturer and Device ID
Program or Erase	RDUID	4Bh	Read Unique ID Number
Program or Erase	RDSFDP	5Ah	SFDP Read
Program or Erase	NOP	00h	No Operation
Program or Erase	RSTEN	66h	Software reset enable
Program or Erase	RST	99h	Reset (Only along with 66h)
Program or Erase	IRRD	68h	Read Information Row
Erase	SECUNLOCK	26h	Sector Unlock
Erase	SECLOCK	24h	Sector Lock
Program or Erase	QPIEN	35h	Enter QPI mode
Program or Erase	QPIDI	F5h	Exit QPI mode
Program or Erase	STWBR	C0h	Set Wrapped Burst Read

8.22 ENTER DEEP POWER DOWN (DP, B9h)

The Deep Power-down (DP) instruction is for setting the device on the minimizing the power consumption (enter into Power-down mode). During this mode, standby current is reduced from I_{sb1} to I_{sb2} . While in the Power-down mode, the device is not active and all Write/Program/Erase instructions are ignored. The instruction is initiated by driving the CE# pin low and shifting the instruction code into the device. The CE# pin must be driven high after the instruction has been latched, or Power-down mode will not engage. Once CE# pin driven high, the Power-down mode will be entered within the time duration of t_{DP} . While in the Power-down mode only the Release from Power-down/RDID instruction, which restores the device to normal operation, will be recognized. All other instructions are ignored, including the Read Status Register instruction which is always available during normal operation. Ignoring all but one instruction makes the Power Down state a useful condition for securing maximum write protection. It is available in both SPI and QPI mode.

Figure 8.36 Enter Deep Power Down Mode Sequence In SPI Mode

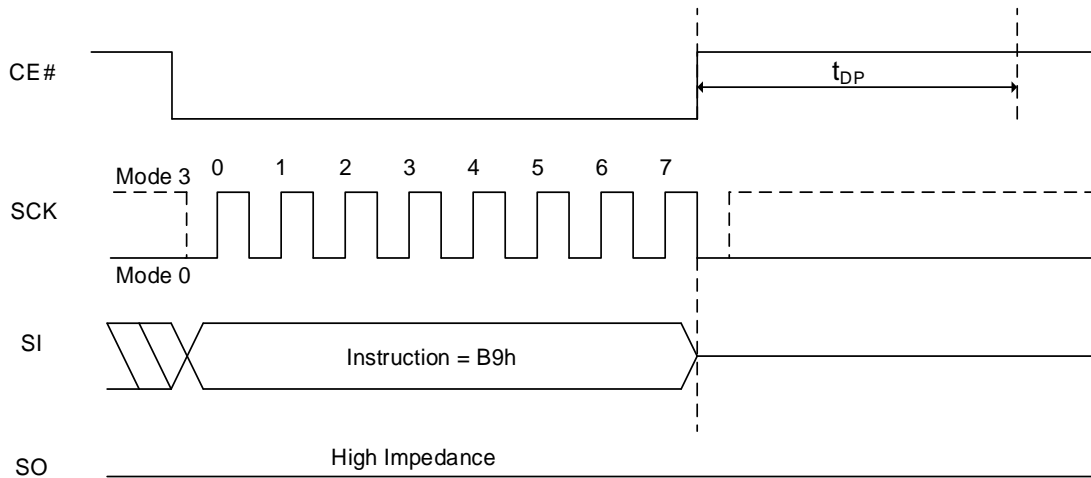
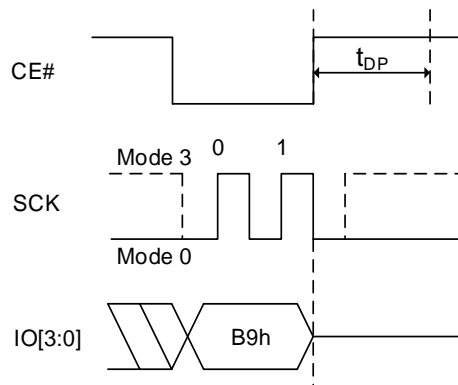


Figure 8.37 Enter Deep Power Down Mode Sequence In QPI Mode



8.23 RELEASE DEEP POWER DOWN (RDPD, ABh)

The Release Deep Power-down/Read Device ID instruction is a multi-purpose command. To release the device from the Power-down mode, the instruction is issued by driving the CE# pin low, shifting the instruction code “ABh” and driving CE# high.

Releasing the device from Power-down mode will take the time duration of t_{RES1} before normal operation is restored and other instructions are accepted. The CE# pin must remain high during the t_{RES1} time duration. If the Release Deep Power-down/RDID instruction is issued while an Erase, Program or Write cycle is in progress (WIP=1) the instruction is ignored and will not have any effects on the current cycle.

Figure 8.38 Release Deep Power Down Mode Sequence In SPI Mode

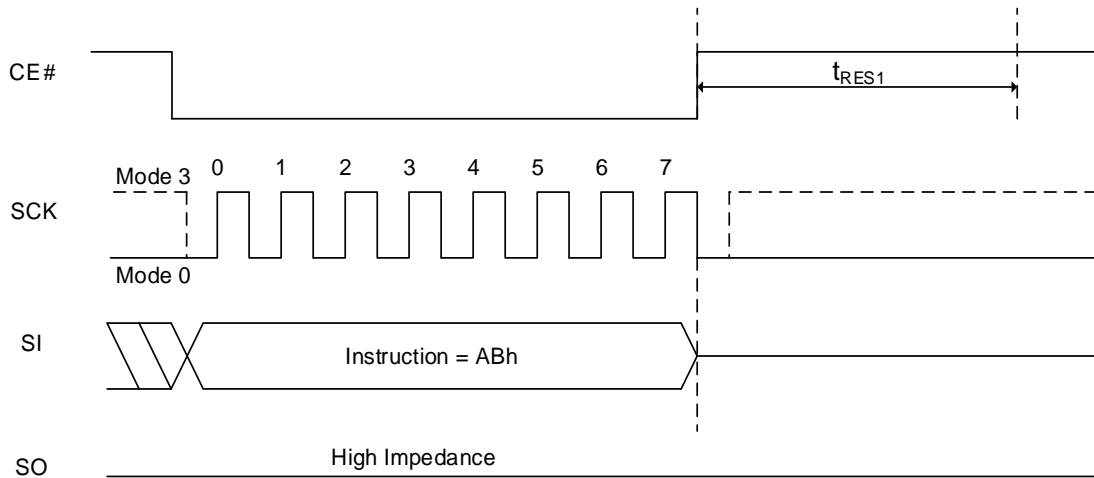
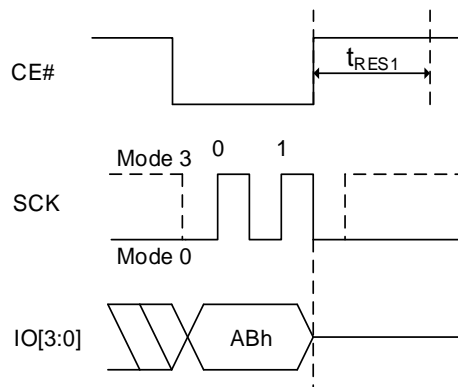


Figure 8.39 Release Deep Power Down Mode Sequence In QPI Mode



8.24 SET WRAPPED BURST READ (STWBR, C0h)

The device is capable of wrapped burst read operation in both SPI and QPI mode. Wrapped burst read and the size of burst length are set by using C0h instruction like below:

C0h command is followed by 1 byte data, and wrapped burst and burst length are set like below table:

Data	Wrap Around	Burst Length
10h	Yes	8-byte
11h	Yes	16-byte
12h	Yes	32-byte
13h	Yes	64-byte
0Xh	No	X

By default, address increases by one up through the entire array (Linear Burst). By setting the burst length, the data being accessed can be limited to the length of burst boundary within a 256 byte page, with random initial address. The first output will be the data at the initial address which is specified in the instruction. Following data will come out from the next address within the burst boundary. Once the address reaches the end of boundary, it will automatically move to the first address of the boundary. CE# high will terminate read operation.

For example, if burst length of 8 and initial address being applied is 0h, following byte output will be from address 00h and continue to 01h,...,07h, 00h, 01h... until CE# terminates the operation. If burst length of 8 and initial address being applied is FEh(254d), following byte output will be from address FEh and continue to FFh, F8h, F9h, FAh, FBh, FCh, FDh, and repeat from FEh until CE# terminates the operation.

To exit the wrapped burst mode, it is required to issue another “C0h” command with data = 1Xh. Otherwise, wrapped burst read mode will be maintained until either power down or reset operation.

To change burst length, it is required to issue another “C0h” command with 1 byte data.

Figure 8.40 Set Wrapped Burst Read Sequence In SPI Mode

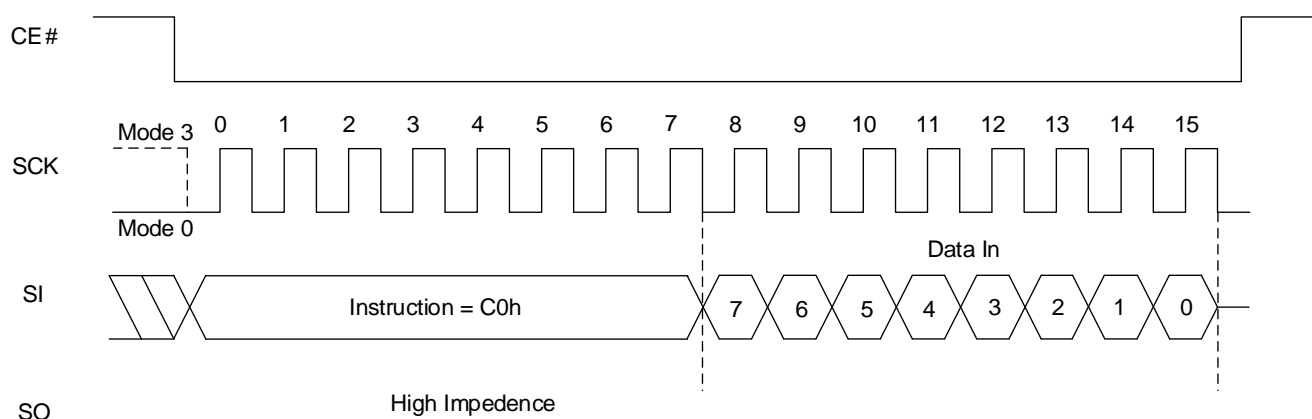
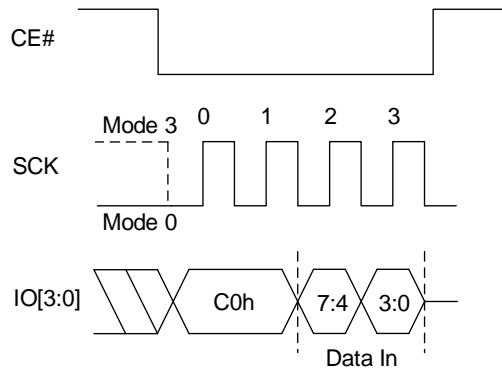


Figure 8.41 Set Wrapped Burst Read Sequence In QPI Mode



8.25 READ PRODUCT IDENTIFICATION (RDID, ABh)

The Release from Power-down/Read Device ID instruction is a multi-purpose instruction. It can support both SPI and QPI modes. The Read Product Identification (RDID) instruction is for reading out the old style of 8-bit Electronic Signature, whose values are shown as table of Product Identification.

The RDID instruction code is followed by three dummy bytes, each bit being latched-in on SI during the rising SCK edge. Then the Device ID is shifted out on SO with the MSB first, each bit been shifted out during the falling edge of SCK. The RDID instruction is ended by driving CE# high. The Device ID (ID7-ID0) outputs repeatedly if additional clock cycles are continuously sent to SCK while CE# is at low.

Table 8.5 Product Identification

Manufacturer ID		(MF7-MF0)	
ISSI Serial Flash		9Dh	
Instruction	ABh	90h	9Fh
Part Number	Device ID (ID7-ID0)	Memory Type + Capacity (ID15-ID0)	
IS25LP040E	12h	4013h	
IS25LP020E	11h	4012h	
IS25LP010E	10h	4011h	
IS25LP512E	05h	4010h	
IS25LP025E	02h	4009h	
IS25WP040E	12h	7013h	
IS25WP020E	11h	7012h	
IS25WP010E	10h	7011h	
IS25WP512E	05h	7010h	
IS25WP025E	02h	7009h	

Figure 8.42 RDID (Read Product Identification) Sequence In SPI Mode

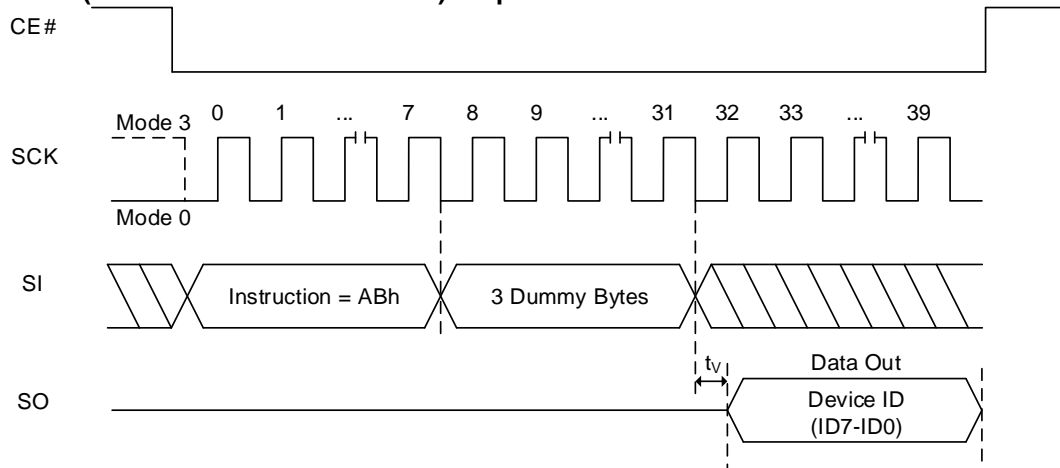
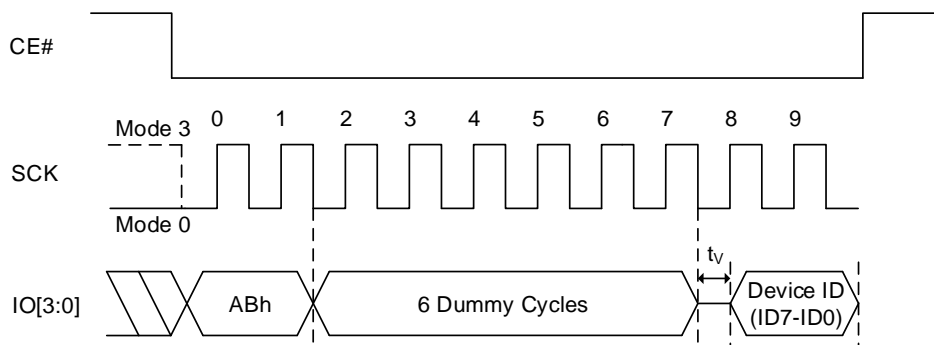


Figure 8.43 RDID (Read Product Identification) Sequence In QPI Mode



8.26 READ PRODUCT IDENTIFICATION BY JEDEC ID OPERATION (RDJDID, 9Fh; RDJDIDQ, AFh)

The JEDEC ID READ instruction allows the user to read the manufacturer and product ID of devices. Refer to Table 8.5 Product Identification for Manufacturer ID and Device ID. After the JEDEC ID READ command (9Fh in SPI mode, AFh in QPI mode) is input, the Manufacturer ID is shifted out MSB first followed by the 2-byte electronic ID (ID15-ID0) that indicates Memory Type and Capacity, one bit at a time. Each bit is shifted out during the falling edge of SCK. If CE# stays low after the last bit of the 2-byte electronic ID, the Manufacturer ID and 2-byte electronic ID will loop until CE# is pulled high.

Figure 8.44 RDJDID (Read JEDEC ID In SPI Mode) Sequence

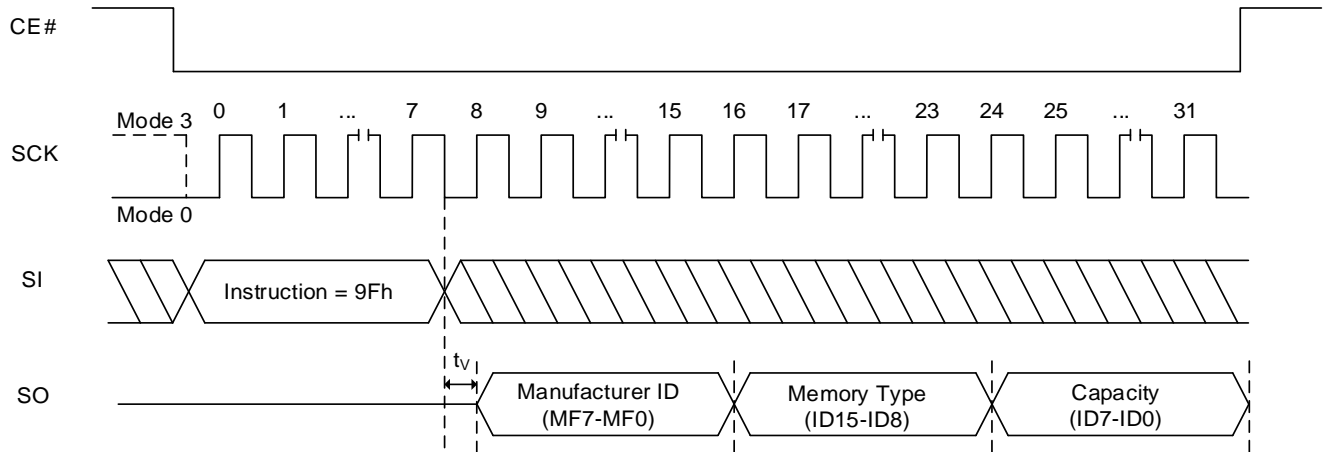
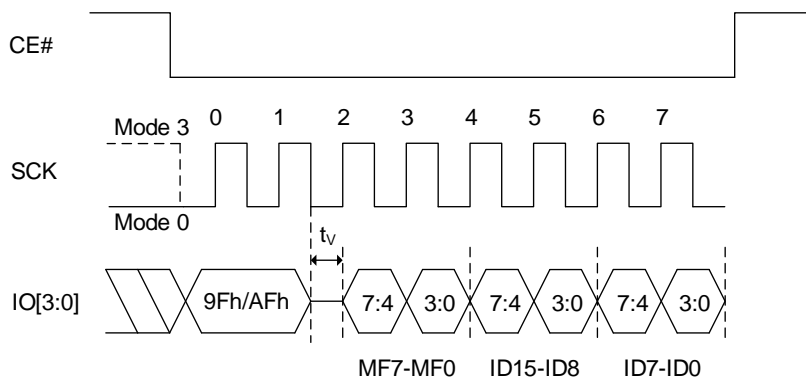


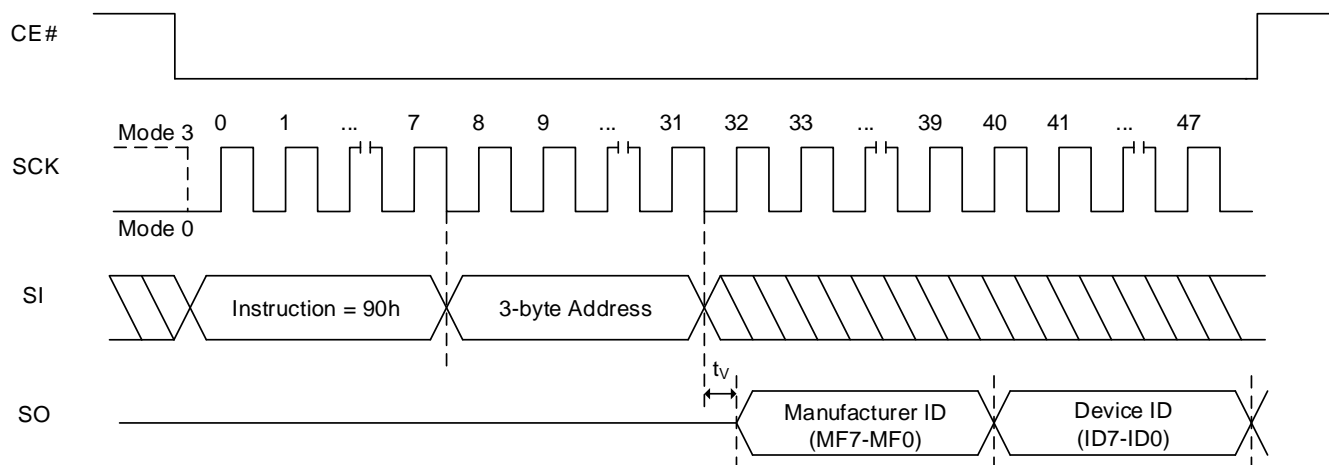
Figure 8.45 RDJDID and RDJDIDQ DJJDIDQ (Read JEDEC ID In QPI Mode) Sequence



8.27 READ DEVICE MANUFACTURER AND DEVICE ID OPERATION (RDMDID, 90h)

The Read Device Manufacturer and Device ID (RDMDID) instruction allows the user to read the Manufacturer and product ID of devices. Refer to Table 8.5 Product Identification for Manufacturer ID and Device ID. The RDMDID instruction code is followed by two dummy bytes and one byte address (A7~A0), each bit being latched-in on SI during the rising edge of SCK. If one byte address is initially set as A0 = 0, then the Manufacturer ID is shifted out on SO with the MSB first followed by the Device ID (ID7-ID0). Each bit is shifted out during the falling edge of SCK. If one byte address is initially set as A0 = 1, then Device ID will be read first followed by the Manufacturer ID. The Manufacturer and Device ID can be read continuously alternating between the two until CE# is driven high.

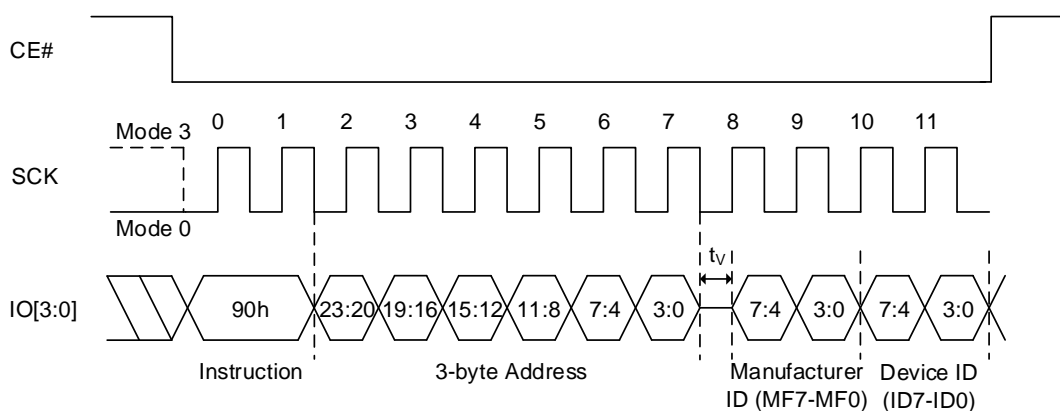
Figure 8.46 RDMDID (Read Product Identification) Sequence In SPI Mode



Notes:

1. ADDRESS A0 = 0, will output the 1-byte Manufacturer ID (MF7-MF0) → 1-byte Device ID (ID7-ID0)
 ADDRESS A0 = 1, will output the 1-byte Device ID (ID7-ID0) → 1-byte Manufacturer ID (MF7-MF0)
2. The Manufacturer and Device ID can be read continuously and will alternate from one to the other until CE# pin is pulled high.

Figure 8.47 RDMDID (Read Product Identification) Sequence In QPI Mode



Notes:

1. ADDRESS A0 = 0, will output the 1-byte Manufacturer ID (MF7-MF0) → 1-byte Device ID (ID7-ID0)
 ADDRESS A0 = 1, will output the 1-byte Device ID (ID7-ID0) → 1-byte Manufacturer ID (MF7-MF0)
2. The Manufacturer and Device ID can be read continuously and will alternate from one to the other until CE# pin is pulled high.

8.31 READ UNIQUE ID NUMBER (RDUID, 4Bh)

The Read Unique ID Number (RDUID) instruction accesses a factory-set read-only 16-byte number that is unique to the device. The ID number can be used in conjunction with user software methods to help prevent copying or cloning of a system. The RDUID instruction is instated by driving the CE# pin low and shifting the instruction code (4Bh) followed by 3 address bytes and dummy cycles (configurable, default is 8 clocks). After which, the 16-byte ID is shifted out on the falling edge of SCK as shown below. As a result, the sequence of RDUID instruction is same as FAST READ. RDUID QPI sequence is also same as FAST READ QPI except for the instruction code. Refer to the FAST READ QPI operation.

Note: 16 bytes of data will repeat as long as CE# is low and SCK is toggling.

Figure 8.48 RDUID Sequence In SPI Mode

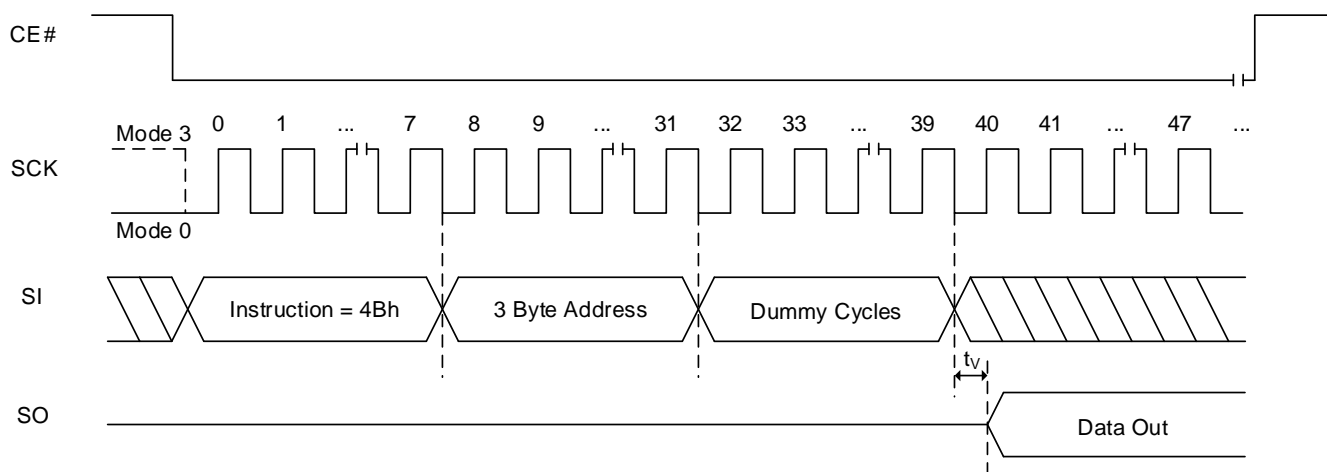


Table 8.6 Unique ID Addressing

A[23:10]	A[9:4]	A[3:0]
XX	00000	0h Byte address
XX	00000	1h Byte address
XX	00000	2h Byte address
XX	00000	⋮
XX	00000	Fh Byte address

Note: XX means “don’t care”.

8.32 READ SFDP OPERATION (RDSFDP, 5Ah)

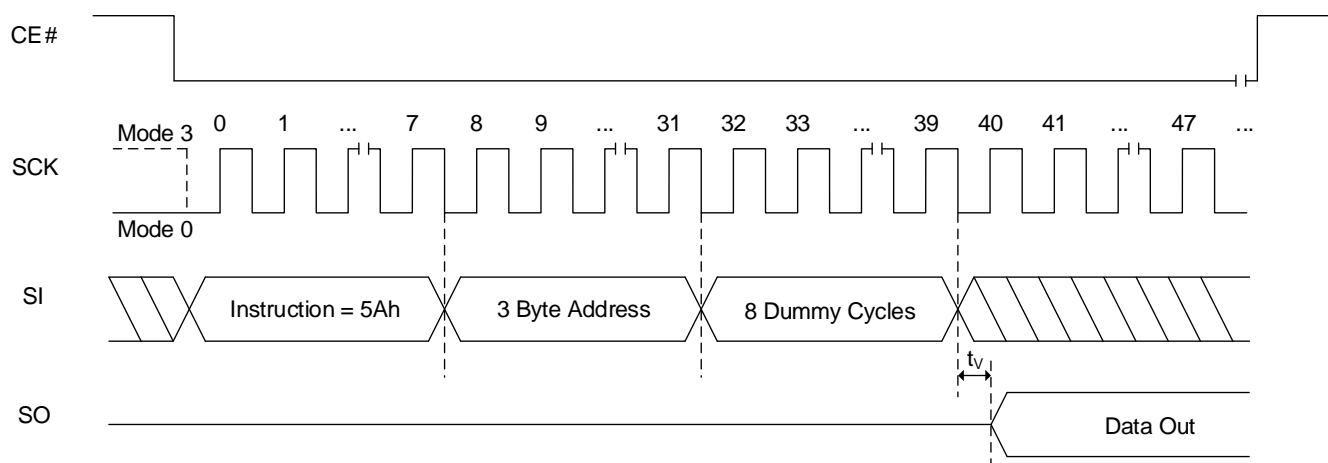
The Serial Flash Discoverable Parameters (SFDP) standard provides a consistent method of describing the functions and features of serial Flash devices in a standard set of internal parameter tables. These parameters can be interrogated by host system software to enable adjustments needed to accommodate divergent features from multiple vendors. For more details please refer to the JEDEC Standard JESD216 (Serial Flash Discoverable Parameters).

The sequence of issuing RDSFDP instruction in SPI mode is:

CE# goes low → Send RDSFDP instruction (5Ah) → Send 3 address bytes on SI pin → 8 dummy cycles on SI pin → Read SFDP code on SO → End RDSFDP operation by driving CE# high at any time during data out. Refer to ISSI's Application note for SFDP table. The data at the addresses that are not specified in SFDP table are undefined.

RDSFDP Sequence in QPI mode, has 8 dummy cycles before SFDP code, too.

Figure 8.49 RDSFDP (Read SFDP) Sequence In SPI Mode



8.33 NO OPERATION (NOP, 00h)

The No Operation command solely cancels a Reset Enable command and has no impact on any other commands. It is available in both SPI and QPI modes. To execute a NOP, the host drives CE# low, sends the NOP command cycle (00H), then drives CE# high.

8.34 SOFTWARE RESET (RESET-ENABLE (RSTEN, 66h) AND RESET (RST, 99h))

The Reset operation is used as a system (software) reset that puts the device in normal operating mode. This operation consists of two commands: Reset-Enable (RSTEN) and Reset (RST). The Reset operation requires the Reset-Enable command followed by the Reset command. Any command other than the Reset command after the Reset-Enable command will disable the Reset-Enable.

Execute the CE# pin low → sends the Reset-Enable command (66h), and drives CE# high. Next, the host drives CE# low again, sends the Reset command (99h), and drives CE# high.

The Software Reset during an active Program or Erase operation aborts the operation, which can result in corrupting or losing the data of the targeted address range. Depending on the prior operation, the reset timing may vary. Recovery from a Write operation requires more latency time than recovery from other operations.

Note: The non-volatile Status Register and Function Register remain unaffected by Software RESET.

Figure 8.50 Software Reset Enable and Software Reset Sequence In SPI Mode (RSTEN, 66h + RST, 99h)

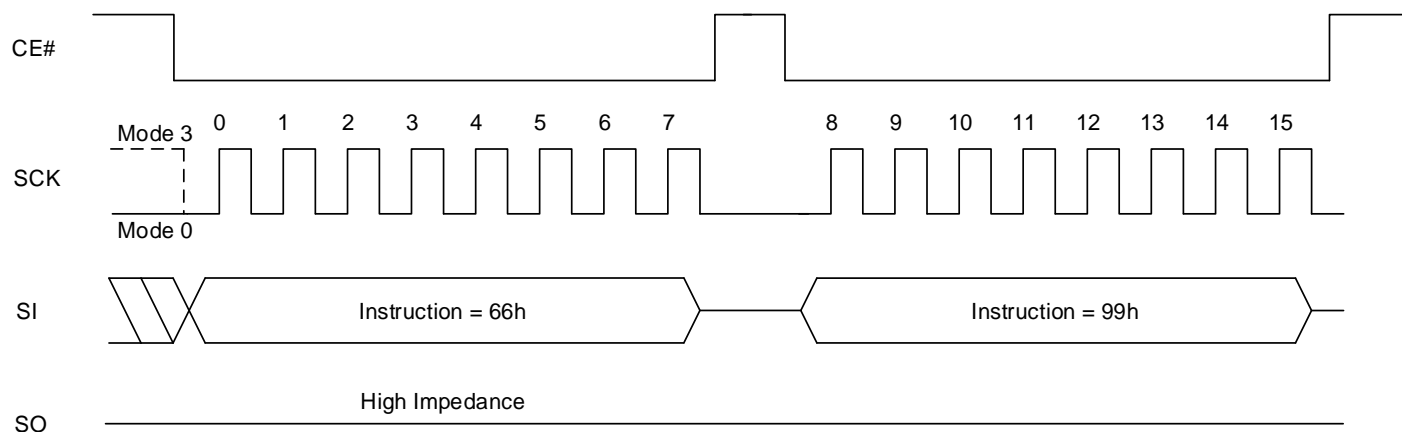
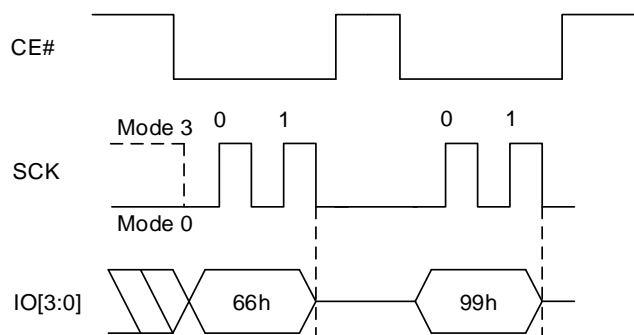


Figure 8.51 Software Reset Enable and Software Reset Sequence In QPI Mode (RSTEN, 66h + RST, 99h)



8.35 SECURITY INFORMATION ROW

The security Information Row is comprised of an additional 4 x 256 bytes of programmable information. The security bits can be reprogrammed by the user. Any program security instruction issued while an erase, program or write cycle is in progress is rejected without having any effect on the cycle that is in progress.

Table 8.7 Information Row Valid Address Range

Address Assignment	A[23:16]	A[15:8]	A[7:0]
IRL0 (Information Row Lock0)	00h	00h	Byte address
IRL1	00h	10h	Byte address
IRL2	00h	20h	Byte address
IRL3	00h	30h	Byte address

Bit 7~4 of the Function Register is used to permanently lock the programmable memory array.

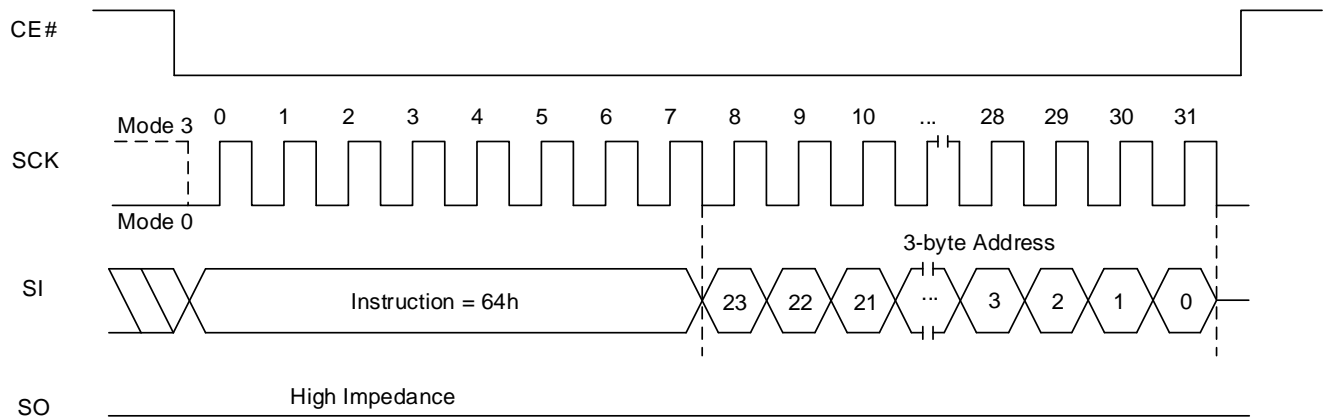
When Function Register bit IRLx = "0", the 256 bytes of the programmable memory array can be programmed. When Function Register bit IRLx = "1", the 256 bytes of the programmable memory array function as read only.

8.36 INFORMATION ROW ERASE OPERATION (IRER, 64h)

Information Row Erase (IRER) instruction erases the data in the Information Row x (x: 0~3) array. Prior to the operation, the Write Enable Latch (WEL) must be set via a Write Enable (WREN) instruction. The WEL bit is automatically reset after the completion of the operation.

The sequence of IRER operation: Pull CE# low to select the device → Send IRER instruction code → Send three address bytes → Pull CE# high. CE# should remain low during the entire instruction sequence. Once CE# is pulled high, Erase operation will begin immediately. The internal control logic automatically handles the erase voltage and timing.

Figure 8.52 IRER (Information Row Erase) Sequence



8.37 INFORMATION ROW PROGRAM OPERATION (IRP, 62h)

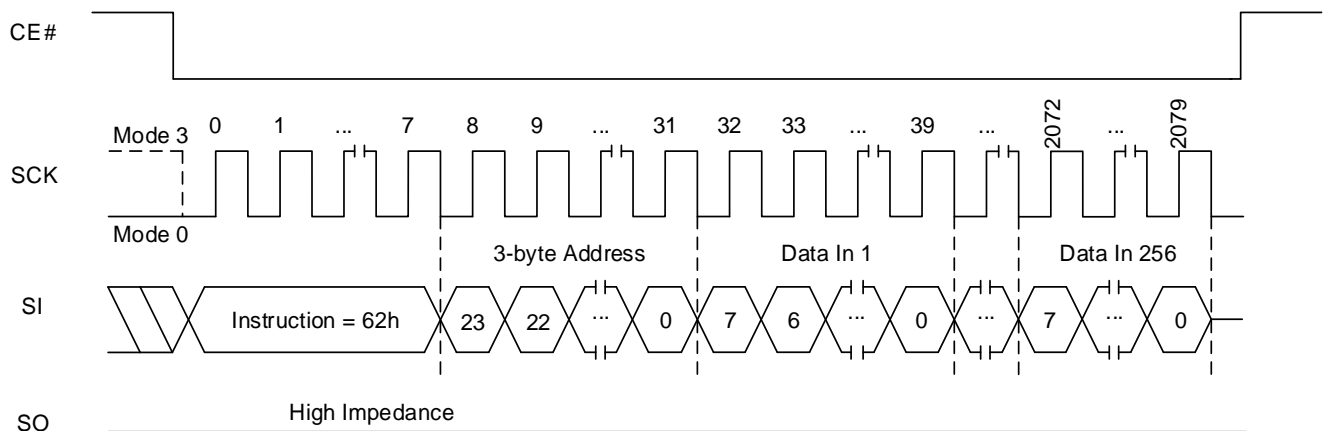
The Information Row Program (IRP) instruction allows up to 256 bytes data to be programmed into the memory in a single operation. Before the execution of IRP instruction, the Write Enable Latch (WEL) must be enabled through a Write Enable (WREN) instruction.

The IRP instruction code, three address bytes and program data (1 to 256 bytes) should be sequentially input. Three address bytes has to be input as specified in the Table 8.7 Information Row Valid Address Range. Program operation will start once the CE# goes high, otherwise the IRP instruction will not be executed. The internal control logic automatically handles the programming voltages and timing. The progress or completion of the program operation can be determined by reading the WIP bit in Status Register via a RDSR instruction. If the WIP bit is “1”, the program operation is still in progress. If WIP bit is “0”, the program operation has completed.

If more than 256 bytes data are sent to a device, the address counter rolls over within the same page. The previously latched data are discarded and the last 256 bytes data are kept to be programmed into the page. The starting byte can be anywhere within the page. When the end of the page is reached, the address will wrap around to the beginning of the same page. If the data to be programmed are less than a full page, the data of all other bytes on the same page will remain unchanged.

Note: A program operation can alter “1”s into “0”s, but an erase operation is required to change “0”s back to “1”s. A byte cannot be reprogrammed without first erasing the corresponding Information Row array which is one of IR0-3.

Figure 8.53 IRP (Information Row Program) Sequence



8.38 INFORMATION ROW READ OPERATION (IRRD, 68h)

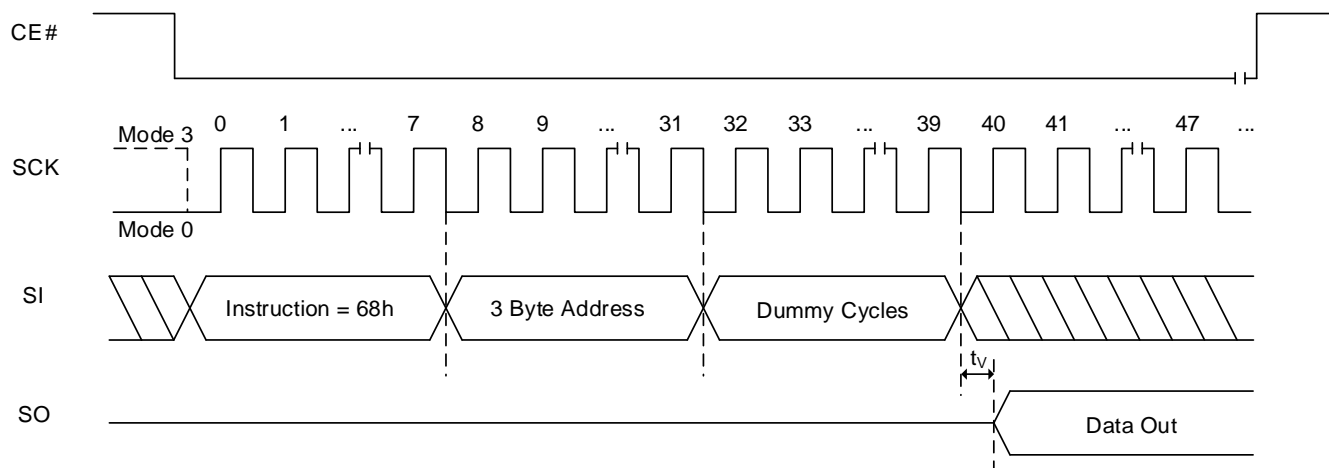
The IRRD instruction is used to read memory data at up to a 104MHz clock.

The IRRD instruction code is followed by three address bytes (A23 - A0), transmitted via the SI line, and each bit latched-in during the rising edge of SCK. Then the first data byte addressed is shifted out on the SO line after 8 dummy cycles in SPI mode (6 dummy cycles in QPI mode), with each bit shifted out at a maximum frequency f_{CT} , during the falling edge of SCK.

The address is automatically incremented by one after each byte of data is shifted out. Once the address reaches the last address of each 256 byte Information Row, the next address will not be valid and the data of the address will be garbage data. It is recommended to repeat four times IRRD operation that reads 256 byte with a valid starting address of each Information Row in order to read all data in the 4 x 256 byte Information Row array. The IRRD instruction is terminated by driving CE# high (VIH).

If an IRRD instruction is issued while an Erase, Program or Write cycle is in process (WIP=1) the instruction is ignored and will not have any effects on the current cycle.

Figure 8.54 IRRD (Information Row Read) Sequence



8.39 SECTOR LOCK/UNLOCK FUNCTIONS

SECTOR UNLOCK OPERATION (SECUNLOCK, 26h)

The Sector Unlock command allows the user to select a specific sector to allow program and erase operations. This instruction is effective when the blocks are designated as write-protected through the BP0, BP1, BP2, and BP3 bits in the Status Register. Only one sector can be enabled at any time. To enable a different sector, a previously enabled sector must be disabled by executing a Sector Lock command. The instruction code is followed by a 24-bit address specifying the target sector, but A0 through A11 are not decoded. The remaining sectors within the same block remain as read-only.

Figure 8.55 Sector Unlock Sequence In SPI Mode

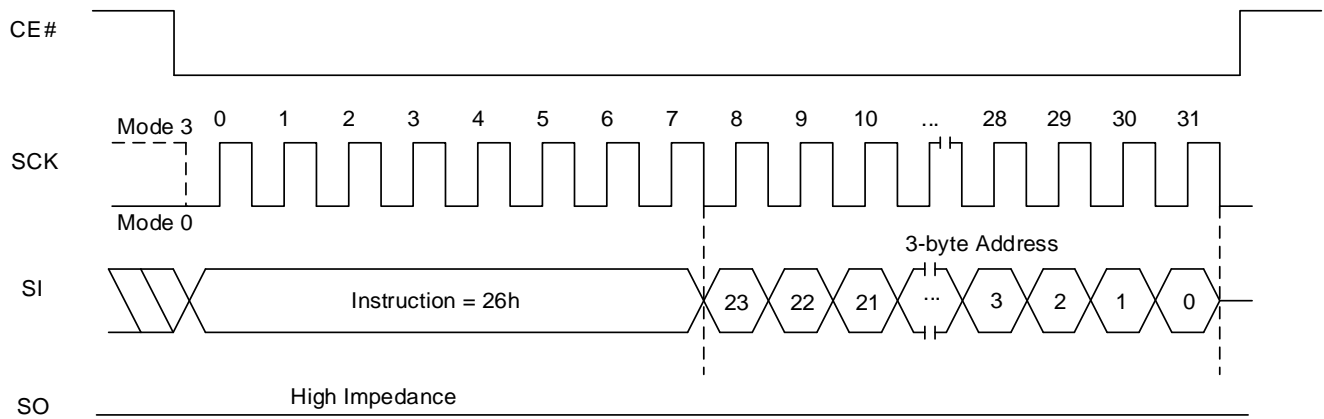
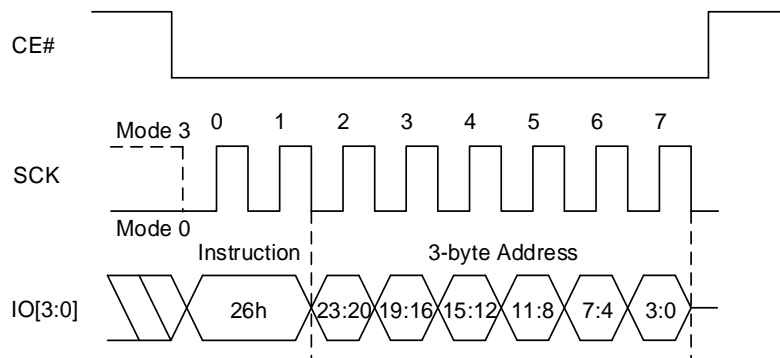


Figure 8.56 Sector Unlock QPI Sequence In QPI Mode



SECTOR LOCK OPERATION (SECLock, 24h)

The Sector Lock command relocks a sector that was previously unlocked by the Sector Unlock command. The instruction code does not require an address to be specified, as only one sector can be enabled at a time. The remaining sectors within the same block remain in read-only mode.

Figure 8.57 Sector Lock Sequence In SPI Mode

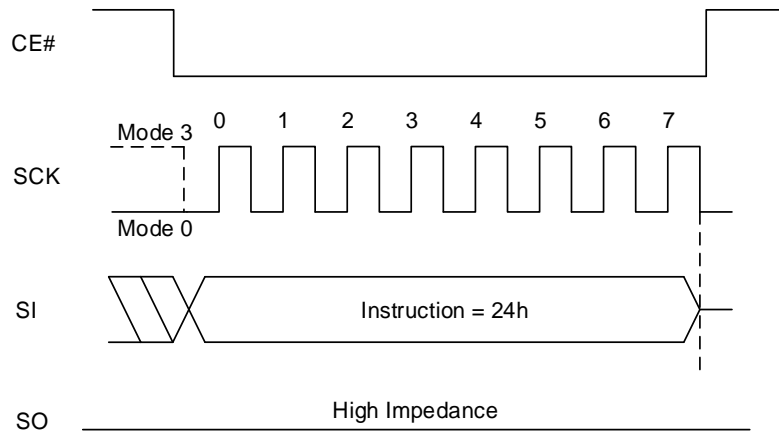
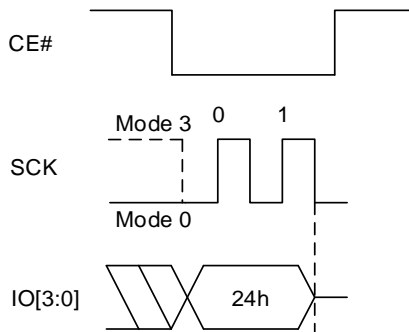


Figure 8.58 Sector Lock QPI Sequence In QPI Mode



8.40 IN BAND RESET OPERATION

The device offers an additional feature of In-Band RESET function, which uses existing SPI signals to initiate a hardware reset, which is different from existing software reset/hardware reset (dedicated RESET# pin);

- Existing software reset commands often depend on the Flash being in a particular mode before they are effective. This makes software based reset sequences depend on slave device and mode.
- Dedicated RESET# pin requires additional pin over traditional 8-pins of SPI Flash device. Also it requires 1 more signal for reset operation.

In Band-RESET operation requires 2-signal pins; CE# and IO0.

- CE# is driven active low to select the SPI slave (note1)
- Clock (SCK) remains stable in either a high or low state(note 2)
- SI (DQ0) is driven low by the bus master, simultaneously with CE# going active low.....(note 3)
- CE# is driven inactive ... (note 4)
- Repeat the above 4 steps, each time alternating the state of SI (IO0).
- After the fourth CE# pulse, the slave triggers its internal reset.....(note 5)

Note 1 This powers up the SPI slave

Note 2 This prevents any confusion with a command, as no command bits are transferred (clocked)

Note 3 No SPI bus slave drives SI (IO0) during CE# low before a transition of clock. Slave streaming output active is not allowed until after the first edge of clock.

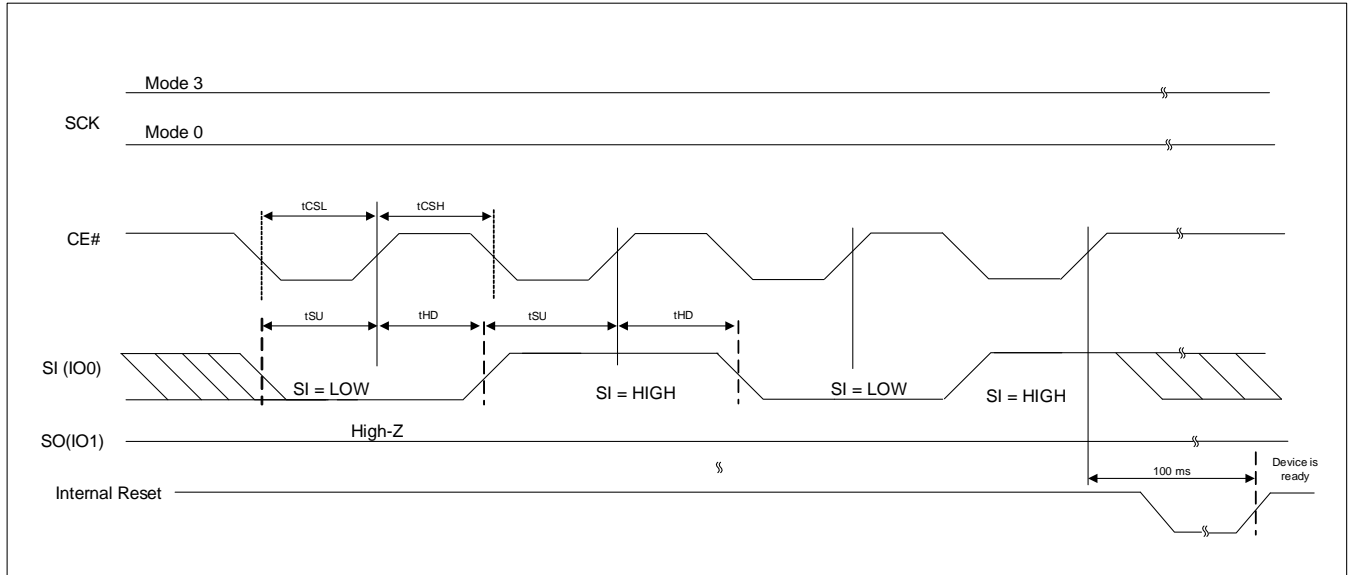
Note 4 The slave captures the state of SI on the rising edge of CE#

Note 5 SI (IO0) is low on the first CE#, high on the second, low on the third, high on the fourth ... (This provides a 5th, unlike random noise)

NOTE:

This reset sequence is not intended to be used at normal power on, but to be used only when the device is not responding to the system. This reset sequence will be operational from any state that the device may be in. During the reset process, the device will ignore any chip select (command). Once the sequence is completed the device will respond to normal operation e.g: provide a SFDP response.

Figure 8.59 Timing for In-Band RESET Operation



Parameter	Symbol	Min	Max	Units
CE# Low Pulse	tCSL	500	--	ns
CE# High Pulse	tCSH	500	--	ns
Setup Time	tSU	5	--	ns
Hold Time	tHD	5	--	ns

9. ELECTRICAL CHARACTERISTICS

9.1 ABSOLUTE MAXIMUM RATINGS ⁽¹⁾

Storage Temperature		-65°C to +150°C
Surface Mount Lead Soldering Temperature	Standard Package	240°C 3 Seconds
	Lead-free Package	260°C 3 Seconds
Input Voltage with Respect to Ground on All Pins		-0.5V to V _{CC} + 0.5V
All Output Voltage with Respect to Ground		-0.5V to V _{CC} + 0.5V
V _{CC}	IS25LP	-0.5V to +6.0V
	IS25WP	-0.5V to +2.5V

Notes:

1. Applied conditions greater than those listed in “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. ANSI/ESDA/JEDEC JS-001

9.2 OPERATING RANGE

Ambient Operating Temperature	Extended Grade E	-40°C to 105°C
	Automotive Grade A3	-40°C to 125°C
V _{CC} Power Supply	IS25LP	2.3V (V _{MIN}) – 3.6V (V _{MAX}); 3.0V (Typ)
	IS25WP	1.70V (V _{MIN}) –1.95V (V _{MAX}); 1.8V (Typ)

9.3 DC CHARACTERISTICS

(Under operating range)

Symbol	Parameter		Condition	Min	Typ ⁽²⁾	Max	Units	
I _{CC1}	V _{CC} Active Read current ⁽³⁾		NORD at 50MHz			6	8	mA
			FRD Single at 104MHz			7	9	
			FRD Dual at 104MHz			8	10	
			FRD Quad at 104MHz			10	12	
I _{CC2}	V _{CC} Program Current		CE# = V _{CC}	85°C	15	20		
				105°C		20		
				125°C		20		
I _{CC3}	V _{CC} WRSR Current		CE# = V _{CC}	85°C	15	20		
				105°C		20		
				125°C		20		
I _{CC4}	V _{CC} Erase Current (SER/BER4K/BER64K)		CE# = V _{CC}	85°C	15	20		
				105°C		20		
				125°C		20		
I _{CC5}	V _{CC} Erase Current (CE)		CE# = V _{CC}	85°C	15	20		
				105°C		20		
				125°C		20		
I _{SB1}	V _{CC} Standby Current CMOS		CE# = V _{CC} , V _{IN} = GND or V _{CC}	85°C	17	35 ⁽⁴⁾		
				105°C		40 ⁽⁴⁾		
				125°C		45		
I _{SB2}	Deep power down current	IS25LP	CE# = V _{CC} , V _{IN} = GND or V _{CC}	85°C	6	15 ⁽⁴⁾		
				105°C		18 ⁽⁴⁾		
				125°C		20		
		IS25WP	CE# = V _{CC} , V _{IN} = GND or V _{CC}	85°C	3	15 ⁽⁴⁾		
				105°C		18 ⁽⁴⁾		
				125°C		20		
I _{LI}	Input Leakage Current		V _{IN} = 0V to V _{CC}			1	V	
I _{LO}	Output Leakage Current		V _{IN} = 0V to V _{CC}			1		
V _{IL} ⁽¹⁾	Input Low Voltage				-0.5	0.3V _{CC}		
V _{IH} ⁽¹⁾	Input High Voltage				0.7V _{CC}	V _{CC} + 0.3		
V _{OL}	Output Low Voltage		V _{MIN} < V _{CC} < V _{MAX}	I _{OL} = 100 μA		0.2		
V _{OH}	Output High Voltage			I _{OH} = -100 μA	V _{CC} - 0.2			

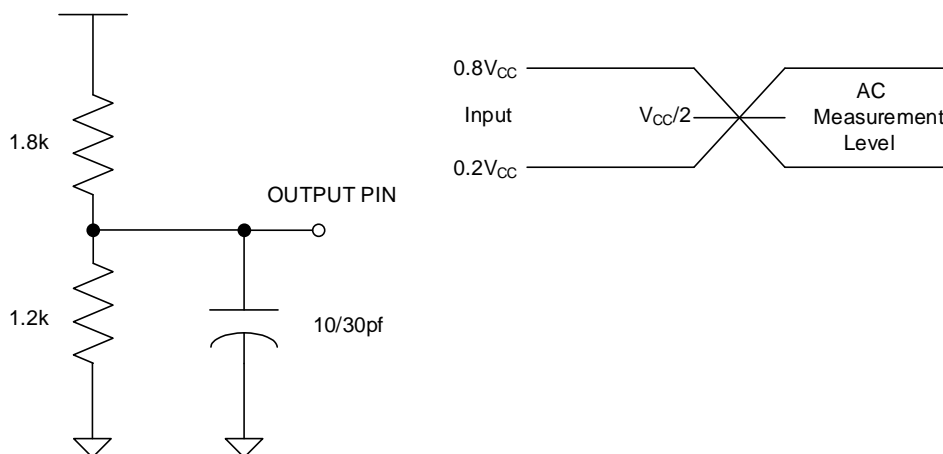
Notes:

1. Maximum DC voltage on input or I/O pins is $V_{CC} + 0.5V$. During voltage transitions, input or I/O pins may overshoot V_{CC} by + 2.0V for a period of time not to exceed 20ns. Minimum DC voltage on input or I/O pins is -0.5V. During voltage transitions, input or I/O pins may undershoot GND by -2.0V for a period of time not to exceed 20ns.
2. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at $V_{CC} = V_{CC} (Typ)$, $T_A=25^{\circ}C$.
3. Outputs are unconnected during reading data so that output switching current is not included.
4. These parameters are characterized and are not 100% tested.

9.4 AC MEASUREMENT CONDITIONS

Symbol	Parameter	Min	Max	Units
CL	Load Capacitance		30	pF
TR,TF	Input Rise and Fall Times		5	ns
VIN	Input Pulse Voltages	0.2V _{CC} to 0.8V _{CC}		V
VREFI	Input Timing Reference Voltages	0.3V _{CC} to 0.7V _{CC}		V
VREFO	Output Timing Reference Voltages	0.5V _{CC}		V

Figure 9.1 Output test load & AC measurement I/O Waveform



9.5 PIN CAPACITANCE

($T_A = 25^{\circ}C$, $V_{CC}=3V$ for IS25LP, $V_{CC}=1.8V$ for IS25WP, 1MHz)

Symbol	Parameter	Test Condition	IS25LP		IS25WP		Units
			Min	Max	Min	Max	
C _{IN}	Input Capacitance (CE#, SCK)	V _{IN} = 0V	-	6	-	6	pF
C _{IN/OUT}	Input/Output Capacitance (other pins)	V _{IN/OUT} = 0V	-	8	-	10	pF

Note:

1. These parameters are characterized and are not 100% tested.



9.6 AC CHARACTERISTICS

(Under operating range, refer to section 9.4 for AC measurement conditions)

Symbol	Parameter	Min	Typ ⁽²⁾	Max	Units	
f _{CT}	Clock Frequency for fast read mode	0		104	MHz	
f _C	Clock Frequency for read mode	0		50	MHz	
t _{RI}	Input Rise Time			8	ns	
t _{FI}	Input Fall Time			8	ns	
t _{CKH}	SCK High Time	4			ns	
t _{CKL}	SCK Low Time	4			ns	
t _{CEH}	CE# High Time	7			ns	
t _{CS}	CE# Setup Time	5			ns	
t _{CH}	CE# Hold Time	5			ns	
t _{CHSL}	CE# Not Active Hold Time	5			ns	
t _{SHCH}	CE# Not Active Setup Time	5			ns	
t _{DS}	Data In Setup Time	2			ns	
t _{DH}	Data in Hold Time	2			ns	
t _V	Output Valid			8	ns	
t _{OH}	Output Hold Time	2			ns	
t _{DIS} ⁽¹⁾	Output Disable Time			8	ns	
t _{WHSL} ⁽³⁾	Write Protect Setup Time	20			ns	
t _{SHWL} ⁽³⁾	Write Protect Hold Time	100			ns	
t _{HLCH}	HOLD Active Setup Time relative to SCK	5			ns	
t _{CHHH}	HOLD Active Hold Time relative to SCK	5			ns	
t _{HHCH}	HOLD Not Active Setup Time relative to SCK	5			ns	
t _{CHHL}	HOLD Not Active Hold Time relative to SCK	5			ns	
t _{LZ} ⁽¹⁾	HOLD to Output Low Z			12	ns	
t _{HZ} ⁽¹⁾	HOLD to Output High Z			12	ns	
t _{EC}	Sector Erase Time (4Kbyte)		70	300	ms	
	Block Erase Time (32Kbyte)		130	500	ms	
	Block Erase time (64Kbyte) ⁽⁴⁾		200	1000	ms	
	Chip Erase Time ⁽⁵⁾	256Kb		130	500	s
		512Kb		0.25	1.0	
		1Mb		0.4	1.5	
2Mb			0.75	2.0		
	4Mb		1.5	3.0		
t _{PP}	Page Program Time		0.45	1.2	ms	
t _{res1} ⁽¹⁾	Release deep power down	IS25LP		3	μs	
		IS25WP		5		
t _{DP} ⁽¹⁾	Deep power down			3	μs	
t _W	Write Status Register time		2	10	ms	
t _{SUS} ⁽¹⁾	Suspend to read ready			100	μs	
t _{RS} ⁽¹⁾	Resume to next suspend		80	-	μs	
t _{SRST} ⁽¹⁾	Software Reset cover time			100	μs	

Notes:

1. These parameters are characterized and not 100% tested.
2. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at V_{CC} = V_{CC} (Typ), TA=25°C.
3. Only applicable as a constraint for a WRITE STATUS REGISTER command when SRWD is set at 1
4. 64Kbyte Block Erase time is not applicable to 256Kb (IS25LP/WP025E) and 512Kb (IS25LP/WP512E).

9.7 SERIAL INPUT/OUTPUT TIMING

Figure 9.2 SERIAL INPUT TIMING (STR Mode)

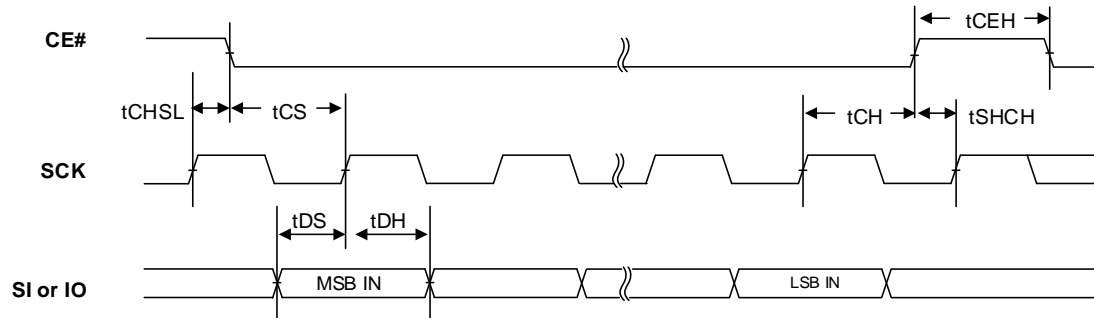


Figure 9.3 SERIAL INPUT TIMING (DTR Mode)

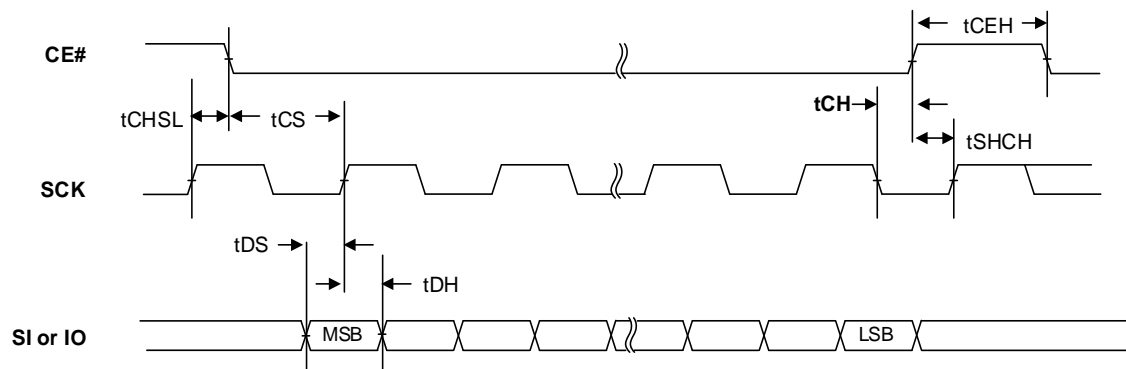


Figure 9.4 OUTPUT TIMING (STR Mode)

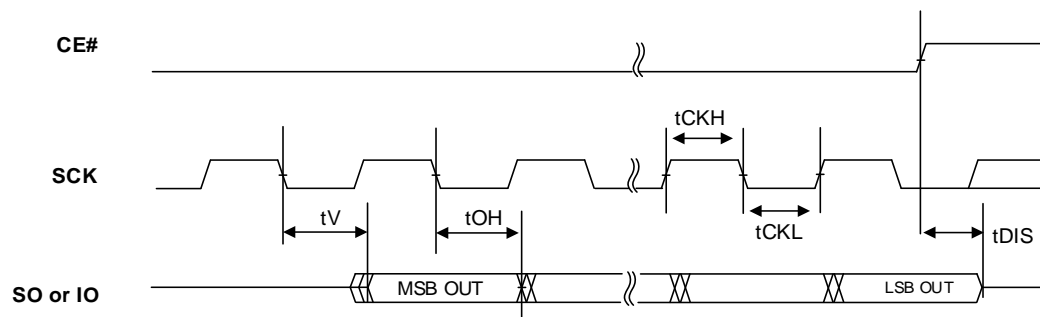


Figure 9.5 OUTPUT TIMING (DTR Mode)

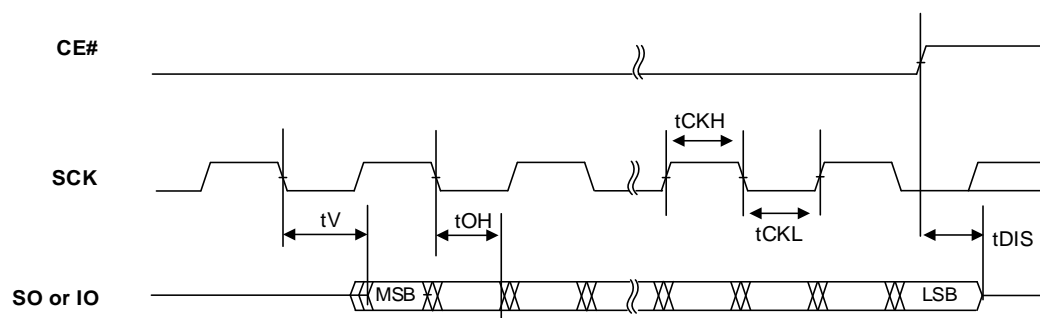


Figure 9.6 HOLD TIMING

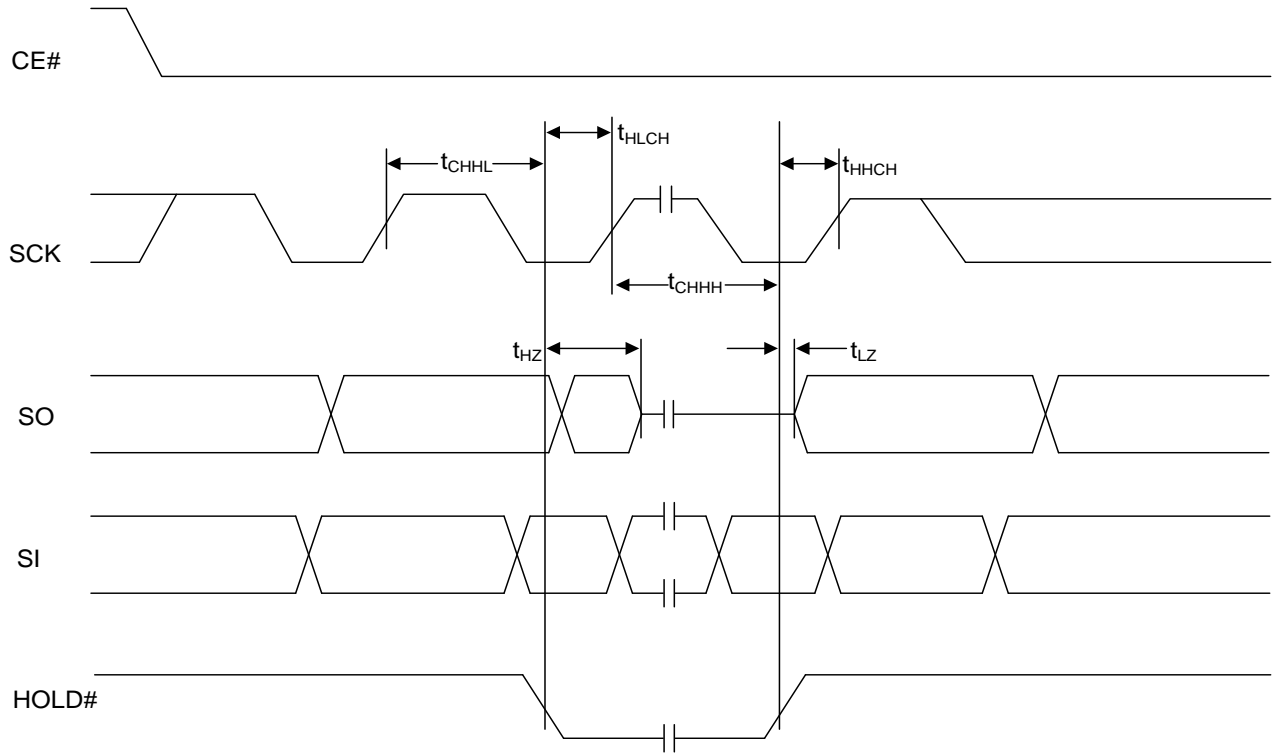
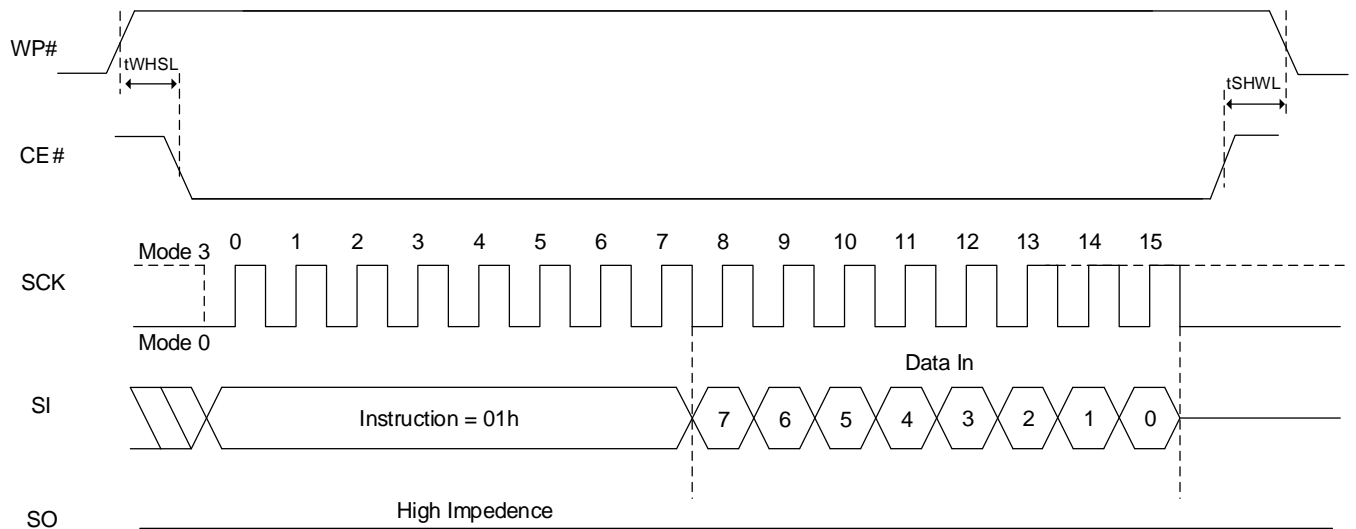


Figure 9.7 WRITE PROTECT SETUP AND HOLD TIMMING DURING WRITE STATUS REGISTER (SRWD=1)

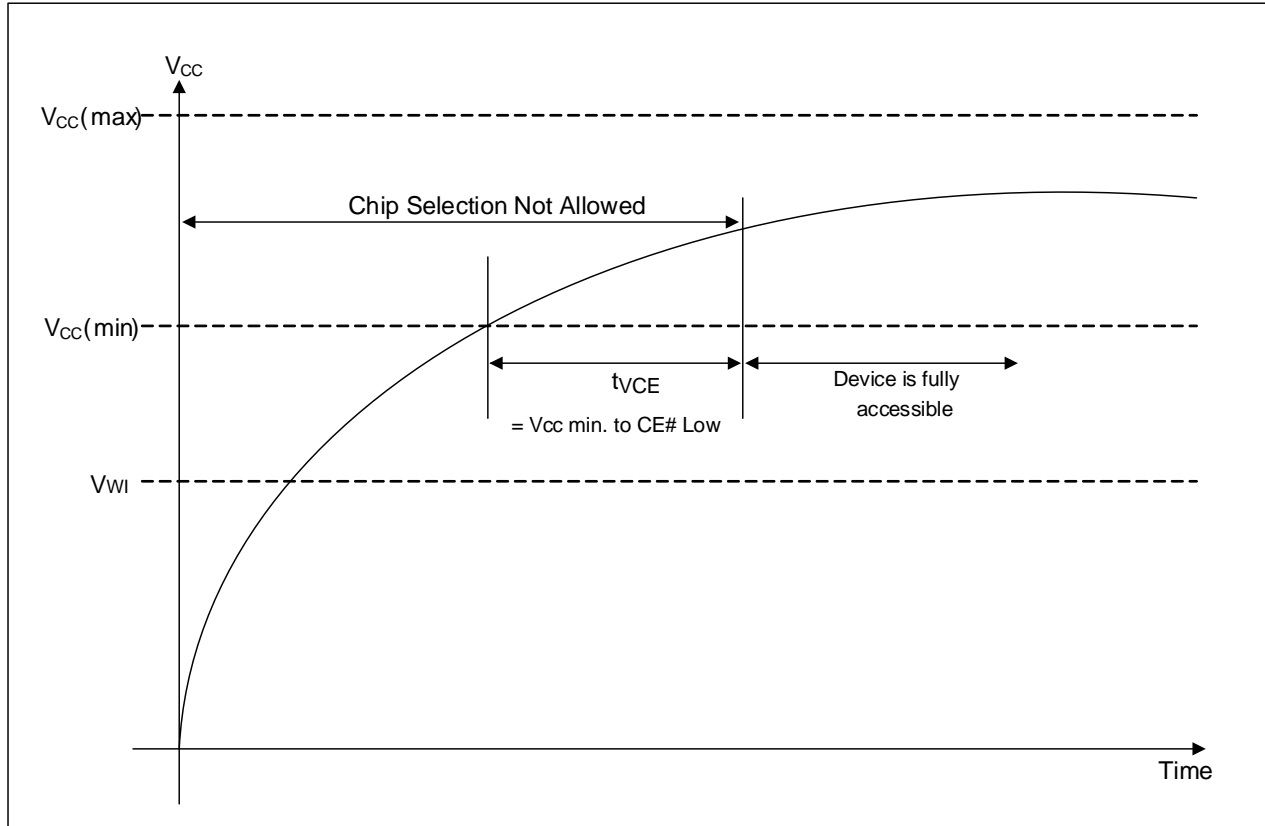


Note: WP# must be kept high until the embedded operation finish.

9.8 POWER-UP AND POWER-DOWN

At Power-up and Power-down, the device must be NOT SELECTED until V_{CC} reaches at the right level. (Adding a simple pull-up resistor on CE# is recommended.)

Figure 9.8 POWER UP TIMING



Symbol	Parameter	Min.	Max	Unit
t _{VCE} ⁽¹⁾	V _{CC} (min) to CE# Low	300		us
V _{WI} ⁽¹⁾	Write Inhibit Voltage	IS25LP	2.1	V
		IS25WP	1.4	

Note: These parameters are characterized and not 100% tested.



9.9 PROGRAM/ERASE PERFORMANCE ⁽¹⁾

Parameter	Typ	Max	Unit	
Sector Erase Time (4KB)	70	300	ms	
Block Erase Time (32KB)	130	500	ms	
Block Erase Time (64KB) ⁽²⁾	200	1000	ms	
Chip Erase Time	256Kb	130	500	ms
	512Kb	0.25	1.0	s
	1Mb	0.4	1.5	
	2Mb	0.75	2.0	
	4Mb	1.5	3.0	
Page Programming Time	0.45	1.2	ms	
Byte Program	8	40	µs	

Note:

1. These parameters are characterized and not 100% tested.
2. 64Kbyte Block Erase time is not applicable to 256Kb (IS25LP/WP025E) and 512Kb (IS25LP/WP512E).

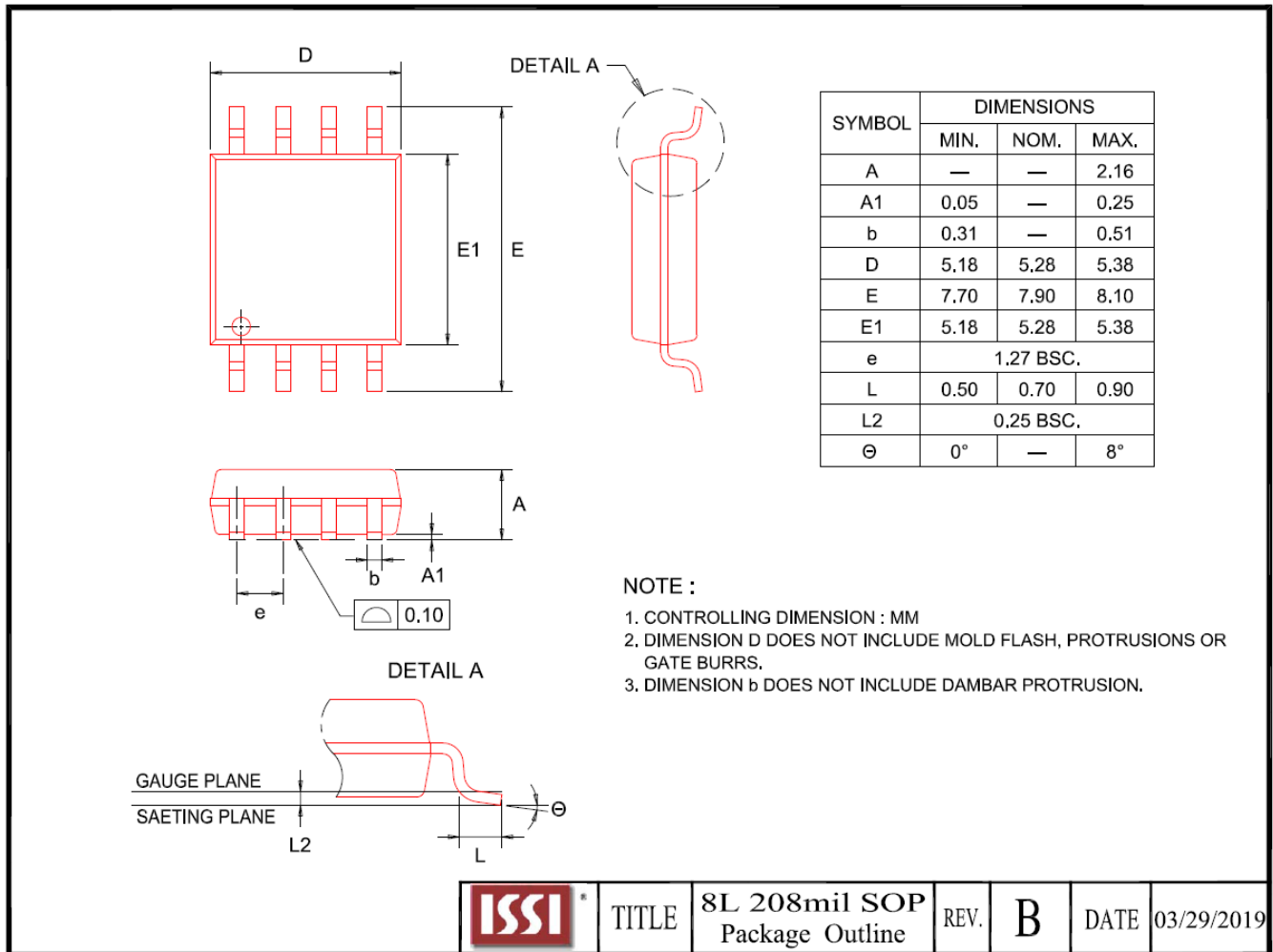
9.10 RELIABILITY CHARACTERISTICS

Parameter	Min	Max	Unit	Test Method
Endurance	100,000	-	Cycles	JEDEC Standard A117
Data Retention	20	-	Years	JEDEC Standard A117
Latch-Up	-100	+100	mA	JEDEC Standard 78

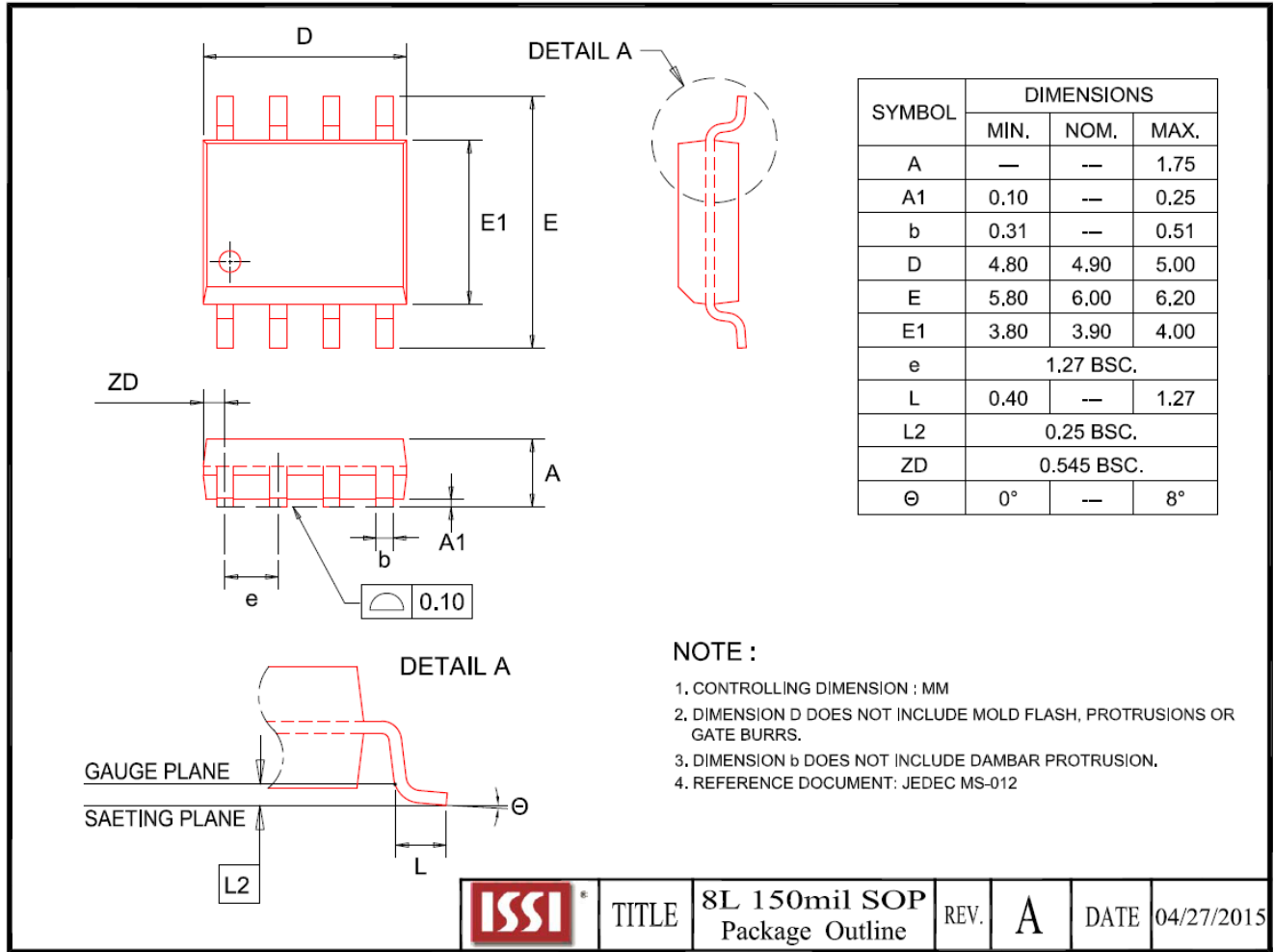
Note: These parameters are characterized and not 100% tested.

10. PACKAGE TYPE INFORMATION

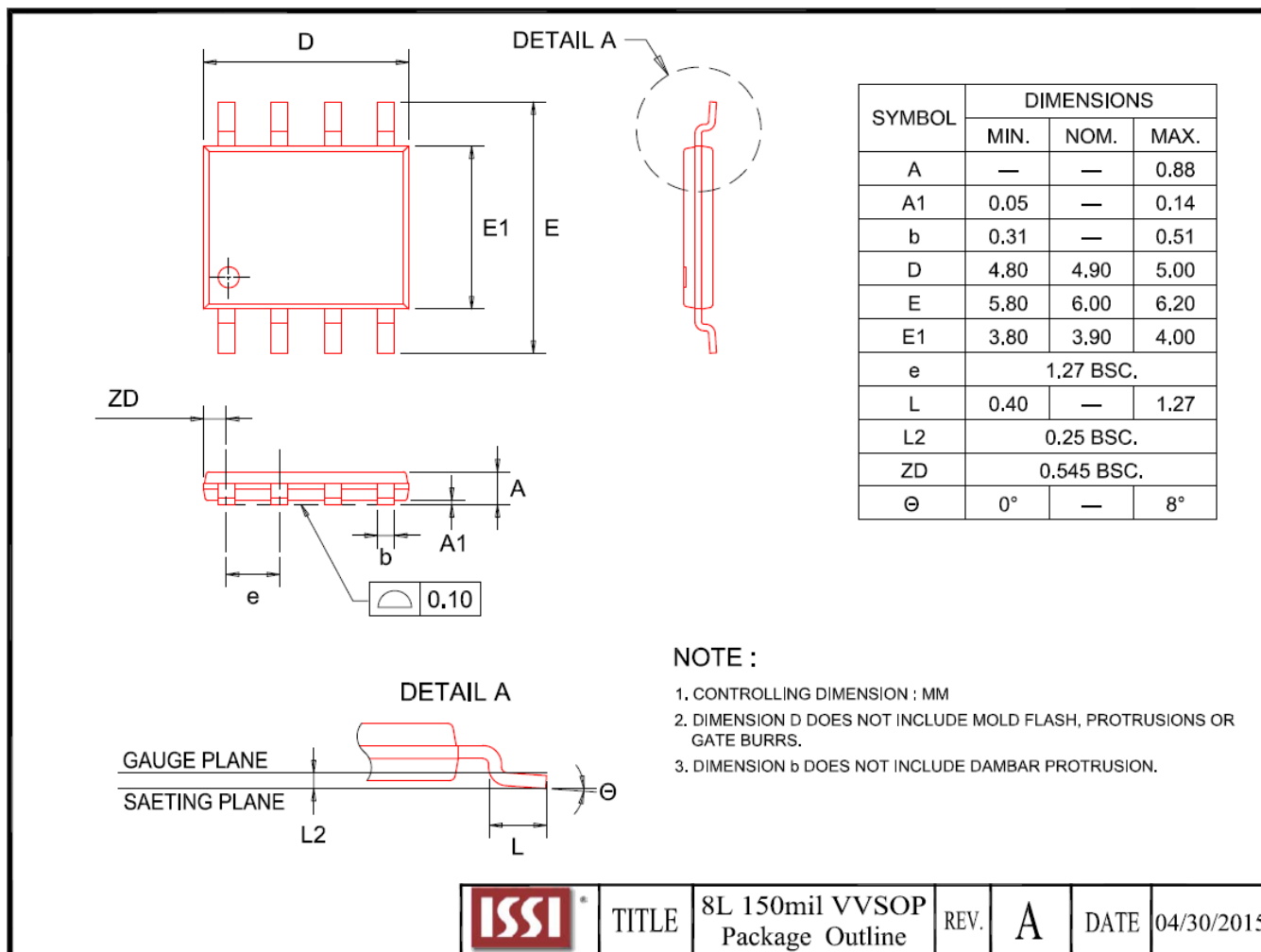
10.1 8-PIN JEDEC 208MIL BROAD SMALL OUTLINE INTEGRATED CIRCUIT (SOIC) PACKAGE (B)



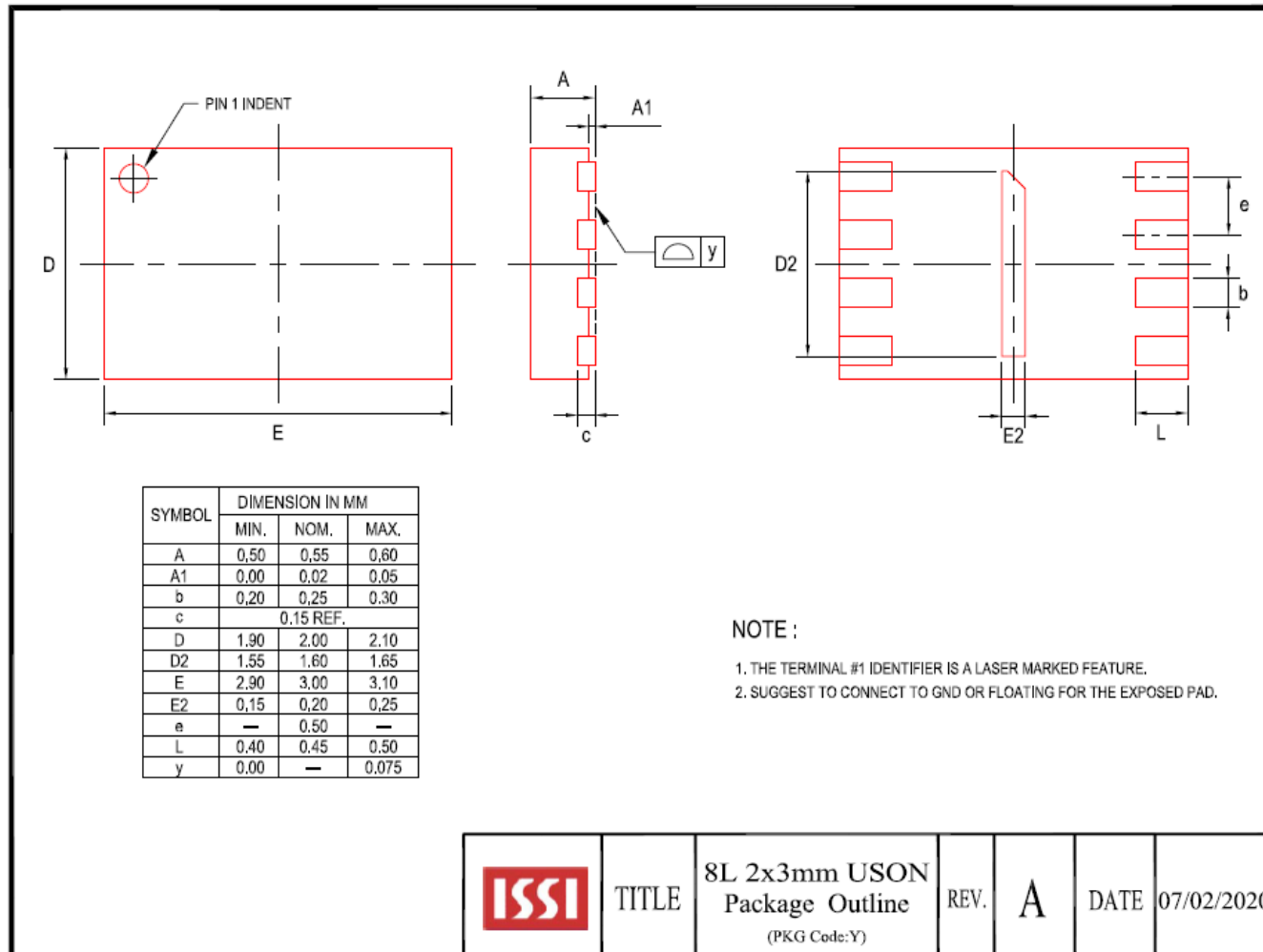
10.2 8-PIN JEDEC 150MIL BROAD SMALL OUTLINE INTEGRATED CIRCUIT (SOIC) PACKAGE (N)



10.3 8-PIN 150MIL VVSOP PACKAGE (V)

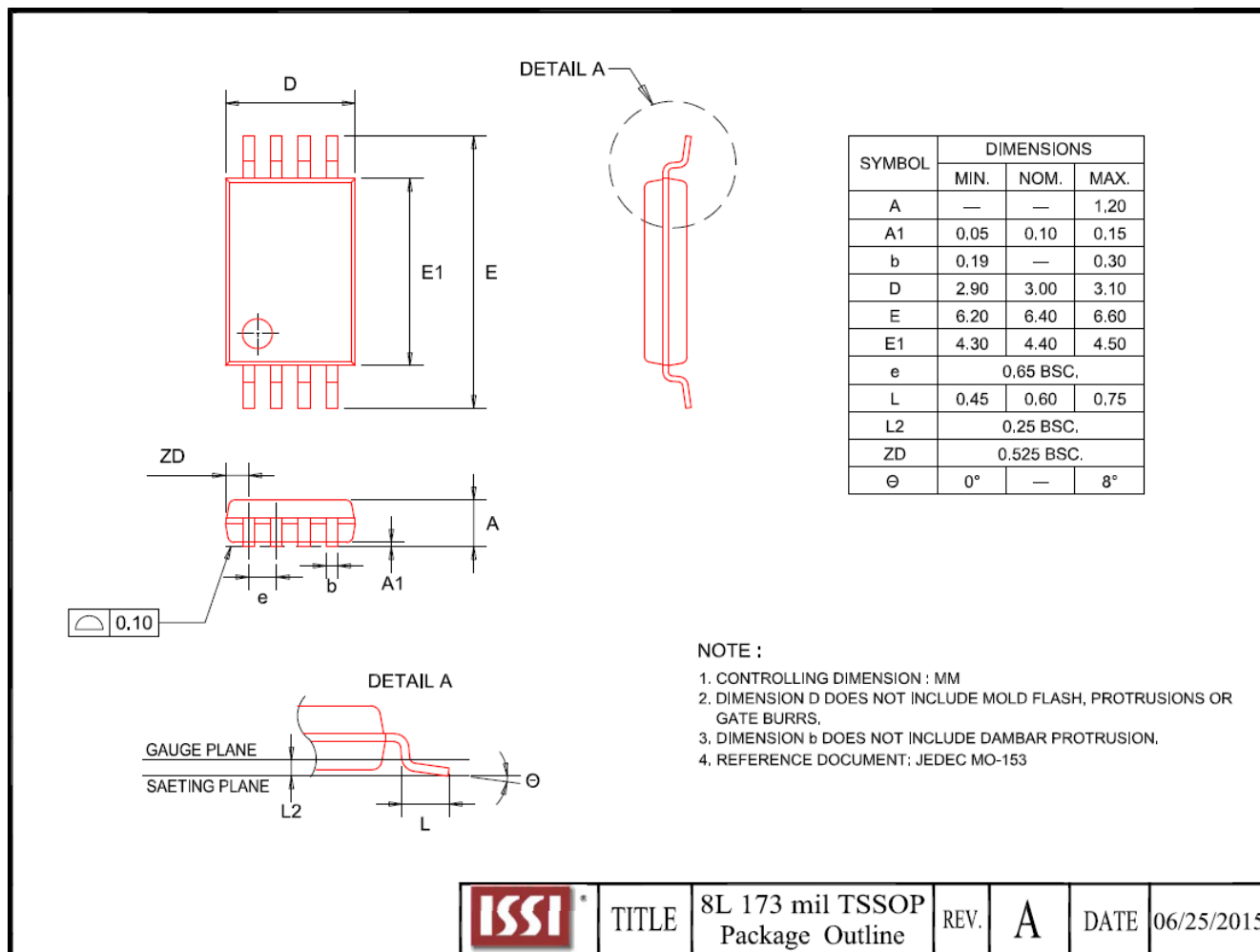


10.4 8-CONTACT ULTRA-THIN SMALL OUTLINE NO-LEAD (USON) PACKAGE 2X3MM (Y)

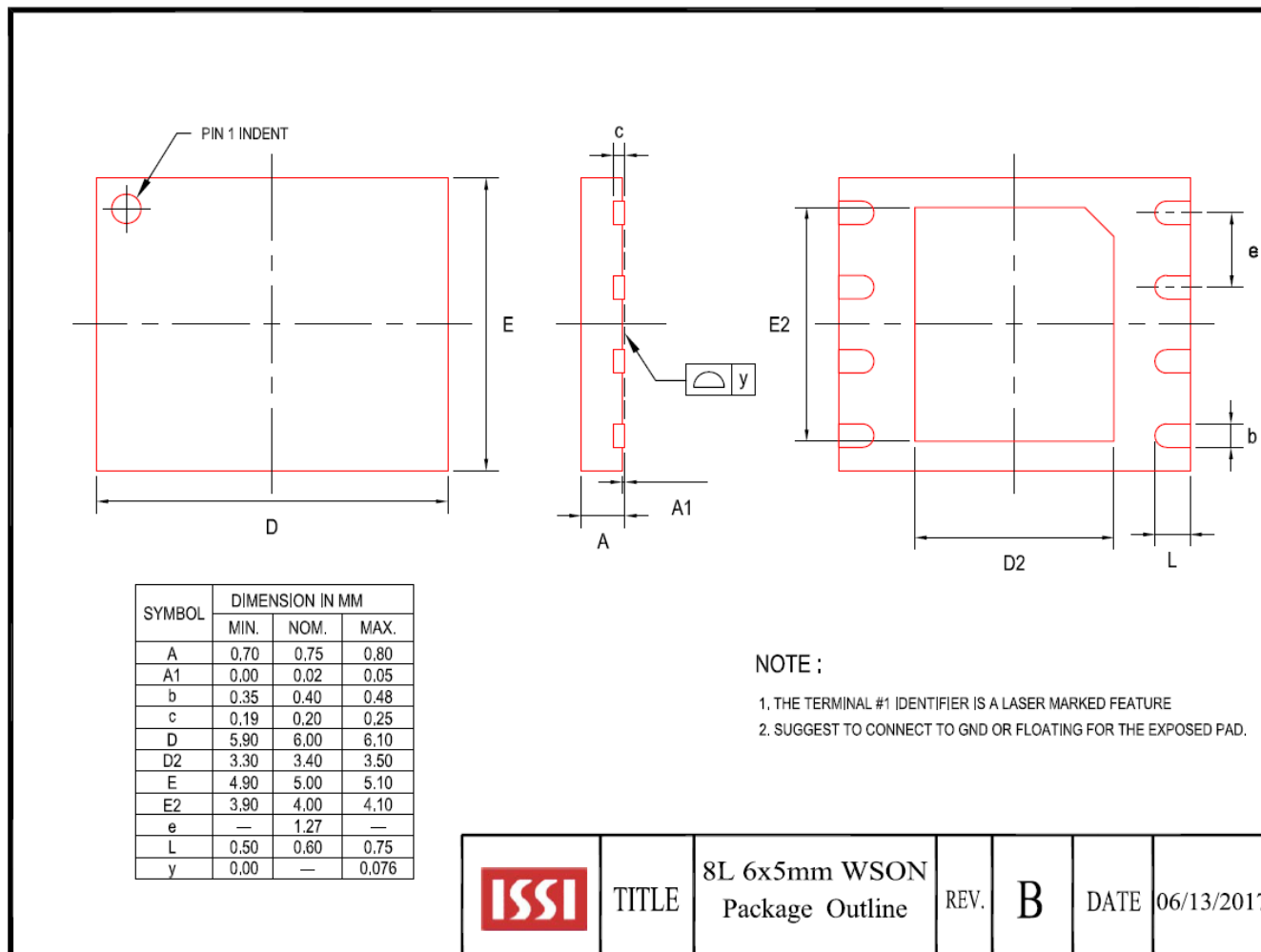


Note: Please [click here](#) to refer to Application Note (AN25D011, Thin USON/WSON/XSON package handling precautions) for assembly guidelines.

10.5 8-PIN TSSOP PACKAGE (D)



10.6 8-CONTACT ULTRA-THIN SMALL OUTLINE NO-LEAD (WSON) PACKAGE 6X5MM (K)

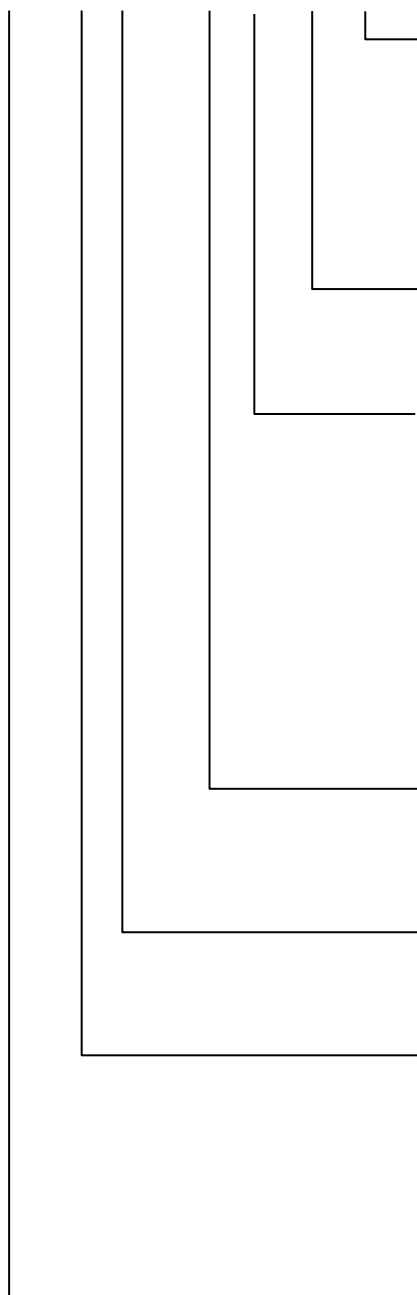


Note: Please [click here](#) to refer to Application Note (AN25D011, Thin USON/WSON/XSON package handling precautions) for assembly guidelines.



11. ORDERING INFORMATION - Valid Part Numbers

IS25LP 040 E - J B L E



TEMPERATURE RANGE

E = Extended (-40°C to +105°C)

A3 = Automotive Grade (-40°C to +125°C)

PACKAGING CONTENT

L = RoHS compliant

PACKAGE Type

B = 8-pin SOIC 208mil

N = 8-pin SOIC 150mil

D = 8-pin TSSOP (Call Factory)

V = 8-pin VVSOP 150mil (Call Factory)

Y = 8-contact USON 2x3mm

K = 8-contact WSON 6x5mm (Call Factory)

W = KGD (Call Factory)

Option

J = Standard

B = Optional BP Table (Call Factory)

C = Optional 1Mb with 32KB Erase only (D8h/52h)

Die Revision

E = Revision E

Density

040 = 4 Mbit

020 = 2 Mbit

010 = 1 Mbit

512 = 512Kbit

025 = 256Kbit

BASE PART NUMBER

IS = Integrated Silicon Solution Inc.

25LP = FLASH, 2.30V ~ 3.60V, QPI

25WP = FLASH, 1.70V ~ 1.95V, QPI